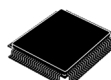




**THE DATASHEET OF  
SPC5604PGF1MLQ6**



## MPC5604P



144 LQFP  
20 mm x 20 mm



100 LQFP  
14 mm x 14 mm

## Qorivva MPC5604P Microcontroller Data Sheet

- Up to 64 MHz, single issue, 32-bit CPU core complex (e200z0h)
  - Compliant with Power Architecture embedded category
  - Variable Length Encoding (VLE)
- Memory organization
  - Up to 512 KB on-chip code flash memory with ECC and erase/program controller
  - Optional 64 (4 × 16) KB on-chip data flash memory with ECC for EEPROM emulation
  - Up to 40 KB on-chip SRAM with ECC
- Fail safe protection
  - Programmable watchdog timer
  - Non-maskable interrupt
  - Fault collection unit
- Nexus L2+ interface
- Interrupts
  - 16-channel eDMA controller
  - 16 priority level controller
- General purpose I/Os individually programmable as input, output or special function
- 2 general purpose eTimer units
  - 6 timers each with up/down count capabilities
  - 16-bit resolution, cascadable counters
  - Quadrature decode with rotation direction flag
  - Double buffer input capture and output compare
- Communications interfaces
  - 2 LINFlex channels (LIN 2.1)
  - 4 DSPI channels with automatic chip select generation
  - 1 FlexCAN interface (2.0B Active) with 32 message objects
- 1 safety port based on FlexCAN with 32 message objects and up to 7.5 Mbit/s capability; usable as second CAN when not used as safety port
- 1 FlexRay™ module (V2.1) with selectable dual or single channel support, 32 message objects and up to 10 Mbit/s
- Two 10-bit analog-to-digital converters (ADC)
  - 2 × 15 input channels, 4 channels shared between the two ADCs
  - Conversion time < 1 μs including sampling time at full precision
  - Programmable Cross Triggering Unit (CTU)
  - 4 analog watchdogs with interrupt capability
- On-chip CAN/UART bootstrap loader with Boot Assist Module (BAM)
- 1 FlexPWM unit
  - 8 complementary or independent outputs with ADC synchronization signals
  - Polarity control, reload unit
  - Integrated configurable dead time unit and inverter fault input pins
  - 16-bit resolution, up to 2 × f<sub>CPU</sub>
  - Lockable configuration
- Clock generation
  - 4–40 MHz main oscillator
  - 16 MHz internal RC oscillator
  - Software controlled FMPLL capable of speeds as fast as 64 MHz
- Voltage supply
  - 3.3 V or 5 V supply for I/Os and ADC
  - On-chip single supply voltage regulator with external ballast transistor
- Operating temperature ranges: –40 to 125 °C or –40 to 105 °C

Freescale reserves the right to change the detail specifications as may be required to permit improvements in the design of its products.

# Table of Contents

|        |   |    |            |  |    |
|--------|---|----|------------|--|----|
| 1      | Introduction                                    | 3  | 2.2.3      | Pin muxing   | 24 |
| 1.1    | Document overview                               | 3  | 3          | Electrical characteristics                                       | 38 |
| 1.2    | Description                                     | 3  | 3.1        | Introduction   | 38 |
| 1.3    | Device comparison                               | 3  | 3.2        | Parameter classification   | 38 |
| 1.4    | Block diagram                                   | 4  | 3.3        | Absolute maximum ratings   | 39 |
| 1.5    | Feature details                                 | 7  | 3.4        | Recommended operating conditions                                 | 42 |
| 1.5.1  | High performance e200z0 core processor          | 7  | 3.5        | Thermal characteristics  | 46 |
| 1.5.2  | Crossbar switch (XBAR)                          | 8  | 3.5.1      | Package thermal characteristics                                  | 46 |
| 1.5.3  | Enhanced direct memory access (eDMA)            | 8  | 3.5.2      | General notes for specifications at maximum junction temperature | 47 |
| 1.5.4  | Flash memory                                    | 8  | 3.6        | Electromagnetic interference (EMI) characteristics               | 48 |
| 1.5.5  | Static random access memory (SRAM)              | 9  | 3.7        | Electrostatic discharge (ESD) characteristics                    | 48 |
| 1.5.6  | Interrupt controller (INTC)                     | 9  | 3.8        | Power management electrical characteristics                      | 49 |
| 1.5.7  | System status and configuration module (SSCM)   | 10 | 3.8.1      | Voltage regulator electrical characteristics                     | 49 |
| 1.5.8  | System clocks and clock generation              | 10 | 3.8.2      | Voltage monitor electrical characteristics                       | 52 |
| 1.5.9  | Frequency-modulated phase-locked loop (FMPLL)   | 10 | 3.9        | Power up/down sequencing   | 53 |
| 1.5.10 | Main oscillator                                 | 11 | 3.10       | DC electrical characteristics                                    | 55 |
| 1.5.11 | Internal RC oscillator                          | 11 | 3.10.1     | NVUSRO register  | 55 |
| 1.5.12 | Periodic interrupt timer (PIT)                  | 11 | 3.10.2     | DC electrical characteristics (5 V)                              | 55 |
| 1.5.13 | System timer module (STM)                       | 11 | 3.10.3     | DC electrical characteristics (3.3 V)                            | 57 |
| 1.5.14 | Software watchdog timer (SWT)                   | 11 | 3.10.4     | Input DC electrical characteristics definition                   | 58 |
| 1.5.15 | Fault collection unit (FCU)                     | 12 | 3.10.5     | I/O pad current specification                                    | 59 |
| 1.5.16 | System integration unit – Lite (SIUL)           | 12 | 3.11       | Main oscillator electrical characteristics                       | 64 |
| 1.5.17 | Boot and censorship                             | 12 | 3.12       | FMPLL electrical characteristics                                 | 65 |
| 1.5.18 | Error correction status module (ECSM)           | 13 | 3.13       | 16 MHz RC oscillator electrical characteristics                  | 67 |
| 1.5.19 | Peripheral bridge (PBRIDGE)                     | 13 | 3.14       | Analog-to-digital converter (ADC) electrical characteristics     | 67 |
| 1.5.20 | Controller area network (FlexCAN)               | 13 | 3.14.1     | Input impedance and ADC accuracy                                 | 68 |
| 1.5.21 | Safety port (FlexCAN)                           | 14 | 3.14.2     | ADC conversion characteristics                                   | 72 |
| 1.5.22 | FlexRay   | 14 | 3.15       | Flash memory electrical characteristics                          | 74 |
| 1.5.23 | Serial communication interface module (LINFlex) | 15 | 3.16       | AC specifications  | 75 |
| 1.5.24 | Deserial serial peripheral interface (DSPI)     | 15 | 3.16.1     | Pad AC specifications  | 75 |
| 1.5.25 | Pulse width modulator (FlexPWM)                 | 16 | 3.17       | AC timing characteristics  | 76 |
| 1.5.26 | eTimer  | 16 | 3.17.1     | RESET pin characteristics  | 76 |
| 1.5.27 | Analog-to-digital converter (ADC) module        | 17 | 3.17.2     | IEEE 1149.1 interface timing                                     | 78 |
| 1.5.28 | Cross triggering unit (CTU)                     | 18 | 3.17.3     | Nexus timing   | 81 |
| 1.5.29 | Nexus development interface (NDI)               | 18 | 3.17.4     | External interrupt timing (IRQ pin)                              | 83 |
| 1.5.30 | Cyclic redundancy check (CRC)                   | 19 | 3.17.5     | DSPI timing  | 84 |
| 1.5.31 | IEEE 1149.1 JTAG controller                     | 19 | 4          | Package characteristics  | 90 |
| 1.5.32 | On-chip voltage regulator (VREG)                | 19 | 4.1        | Package mechanical data  | 90 |
| 2      | Package pinouts and signal descriptions         | 20 | 4.1.1      | 144 LQFP mechanical outline drawing                              | 90 |
| 2.1    | Package pinouts                                 | 20 | 4.1.2      | 100 LQFP mechanical outline drawing                              | 92 |
| 2.2    | Pin description                                 | 21 | 5          | Ordering information   | 96 |
| 2.2.1  | Power supply and reference voltage pins         | 21 | Appendix A | Abbreviations  | 97 |
| 2.2.2  | System pins                                     | 23 | 6          | Document revision history  | 98 |

# 1 Introduction

## 1.1 Document overview

This document provides electrical specifications, pin assignments, and package diagrams for the MPC5603P/4P series of microcontroller units (MCUs). It also describes the device features and highlights important electrical and physical characteristics. For functional characteristics, refer to the device reference manual.

## 1.2 Description

This 32-bit system-on-chip (SoC) automotive microcontroller family is the latest achievement in integrated automotive application controllers. It belongs to an expanding range of automotive-focused products designed to address chassis applications—specifically, electrical hydraulic power steering (EHPS) and electric power steering (EPS)—as well as airbag applications.

This family is one of a series of next-generation integrated automotive microcontrollers based on the Power Architecture technology.

The advanced and cost-efficient host processor core of this automotive controller family complies with the Power Architecture embedded category. It operates at speeds of up to 64 MHz and offers high performance processing optimized for low power consumption. It capitalizes on the available development infrastructure of current Power Architecture devices and is supported with software drivers, operating systems and configuration code to assist with users implementations.

## 1.3 Device comparison

Table 1 provides a summary of different members of the MPC5604P family and their features to enable a comparison among the family members and an understanding of the range of functionality offered within this family.

**Table 1. MPC5604P device comparison**

| Feature  | MPC5603P                        | MPC5604P |
|--|---------------------------------|----------|
| Code flash memory (with ECC)                         | 384 KB                          | 512 KB   |
| Data flash memory / EE option (with ECC)             | 64 KB (optional feature)        |          |
| SRAM (with ECC)                                      | 36 KB                           | 40 KB    |
| Processor core                                       | 32-bit e200z0h                  |          |
| Instruction set                                      | VLE (variable length encoding)  |          |
| CPU performance                                      | 0–64 MHz                        |          |
| FMPLL (frequency-modulated phase-locked loop) module | 2                               |          |
| INTC (interrupt controller) channels                 | 147                             |          |
| PIT (periodic interrupt timer)                       | 1 (includes four 32-bit timers) |          |
| eDMA (enhanced direct memory access) channels        | 16                              |          |
| FlexRay <sup>1</sup>                                 | Optional feature                |          |
| FlexCAN (controller area network)                    | 2 <sup>2,3</sup>                |          |
| Safety port  | Yes (via second FlexCAN module) |          |
| FCU (fault collection unit)                          | Yes                             |          |
| CTU (cross triggering unit)                          | Yes                             |          |

**Table 1. MPC5604P device comparison (continued)**

| Feature                                     |                              | MPC5603P  | MPC5604P |
|---|------------------------------|---|----------|
| eTimer                                      |                              | 2 (16-bit, 6 channels)                              |          |
| FlexPWM (pulse-width modulation) channels   |                              | 8 (capturing on X-channels)                         |          |
| ADC (analog-to-digital converter)           |                              | 2 (10-bit, 15-channel <sup>4</sup> )                |          |
| LINFlex                                     |                              | 2   |          |
| DSPI (deserial serial peripheral interface) |                              | 4   |          |
| CRC (cyclic redundancy check) unit          |                              | Yes   |          |
| JTAG controller                             |                              | Yes   |          |
| Nexus port controller (NPC)                 |                              | Yes (Level 2+)                                      |          |
| Supply                                      | Digital power supply         | 3.3 V or 5 V single supply with external transistor |          |
|   | Analog power supply          | 3.3 V or 5 V  |          |
|   | Internal RC oscillator       | 16 MHz  |          |
|   | External crystal oscillator  | 4–40 MHz  |          |
| Packages                                    |                              | 100 LQFP<br>144 LQFP                                |          |
| Temperature                                 | Standard ambient temperature | –40 to 125 °C                                       |          |

<sup>1</sup> 32 message buffers, selectable single or dual channel support

<sup>2</sup> Each FlexCAN module has 32 message buffers.

<sup>3</sup> One FlexCAN module can act as a Safety Port with a bit rate as high as 7.5 Mbit/s.

<sup>4</sup> Four channels shared between the two ADCs

## 1.4 Block diagram

Figure 1 shows a top-level block diagram of the MPC5604P MCU.

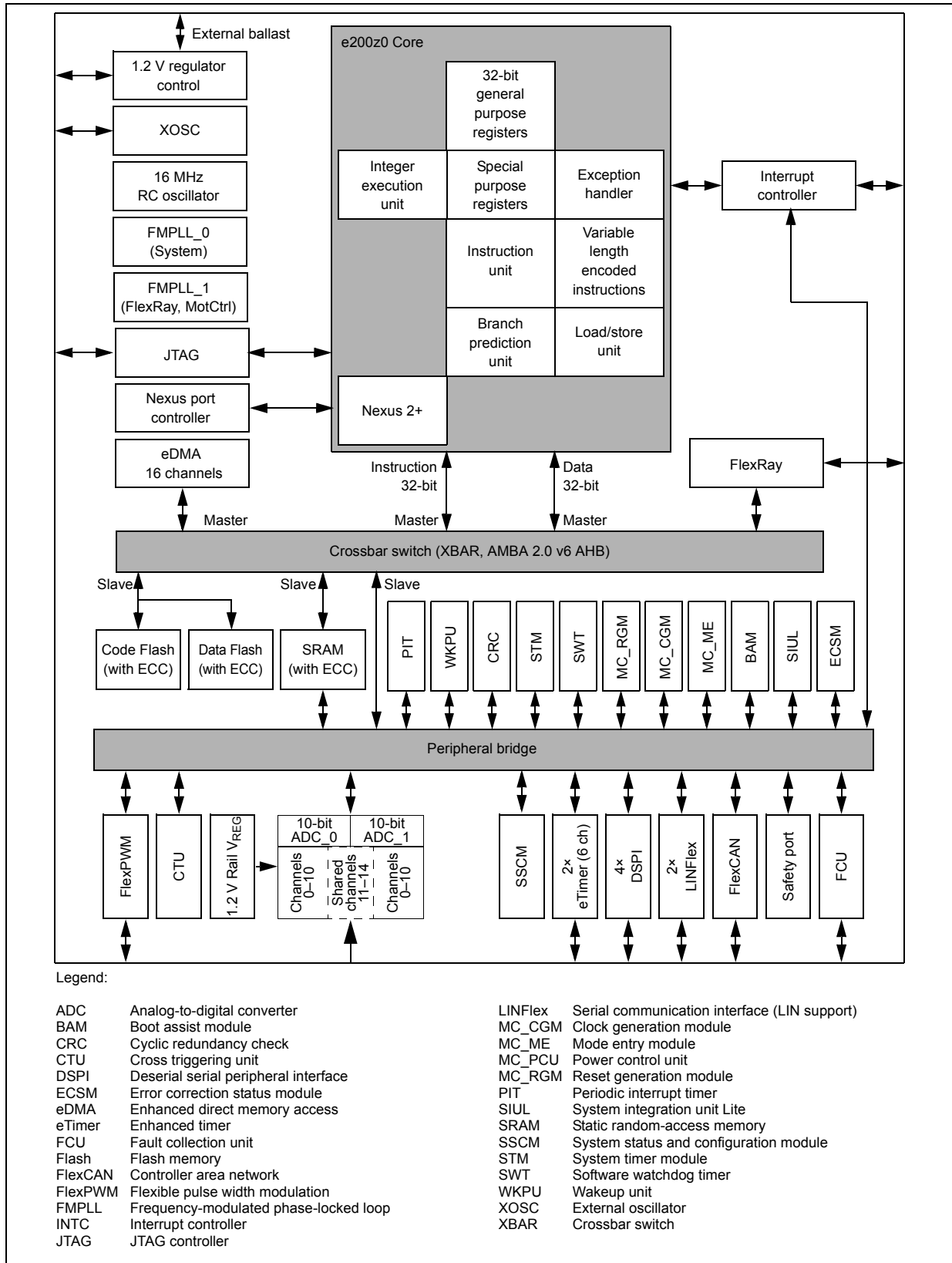


Figure 1. MPC5604P block diagram

**Table 2. MPC5604P series block summary**

| Block   | Function  |
|---|---|
| Analog-to-digital converter (ADC)             | Multi-channel, 10-bit analog-to-digital converter   |
| Boot assist module (BAM)                      | Block of read-only memory containing VLE code which is executed according to the boot mode of the device  |
| Clock generation module (MC_CGM)              | Provides logic and control required for the generation of system and peripheral clocks  |
| Controller area network (FlexCAN)             | Supports the standard CAN communications protocol   |
| Cross triggering unit (CTU)                   | Enables synchronization of ADC conversions with a timer event from the eMIOS or from the PIT  |
| Crossbar switch (XBAR)                        | Supports simultaneous connections between two master ports and three slave ports; supports a 32-bit address bus width and a 32-bit data bus width   |
| Cyclic redundancy check (CRC)                 | CRC checksum generator  |
| Deserial serial peripheral interface (DSPI)   | Provides a synchronous serial interface for communication with external devices   |
| Enhanced direct memory access (eDMA)          | Performs complex data transfers with minimal intervention from a host processor via "n" programmable channels   |
| Enhanced timer (eTimer)                       | Provides enhanced programmable up/down modulo counting  |
| Error correction status module (ECSM)         | Provides a myriad of miscellaneous control functions for the device including program-visible information about configuration and revision levels, a reset status register, wakeup control for exiting sleep modes, and optional features such as information on memory errors reported by error-correcting codes |
| External oscillator (XOSC)                    | Provides an output clock used as input reference for FMPLL_0 or as reference clock for specific modules depending on system needs   |
| Fault collection unit (FCU)                   | Provides functional safety to the device  |
| Flash memory                                  | Provides non-volatile storage for program code, constants and variables   |
| Frequency-modulated phase-locked loop (FMPLL) | Generates high-speed system clocks and supports programmable frequency modulation   |
| Interrupt controller (INTC)                   | Provides priority-based preemptive scheduling of interrupt requests   |
| JTAG controller                               | Provides the means to test chip functionality and connectivity while remaining transparent to system logic when not in test mode  |
| LINFlex controller                            | Manages a high number of LIN (Local Interconnect Network protocol) messages efficiently with minimum load on CPU  |
| Mode entry module (MC_ME)                     | Provides a mechanism for controlling the device operational mode and mode transition sequences in all functional states; also manages the power control unit, reset generation module and clock generation module, and holds the configuration, control and status registers accessible for applications          |
| Periodic interrupt timer (PIT)                | Produces periodic interrupts and triggers   |
| Peripheral bridge (PBRIDGE)                   | Interface between the system bus and on-chip peripherals  |
| Power control unit (MC_PCU)                   | Reduces the overall power consumption by disconnecting parts of the device from the power supply via a power switching device; device components are grouped into sections called "power domains" which are controlled by the PCU   |

**Table 2. MPC5604P series block summary (continued)**

| Block   | Function   |
|---|--|
| Pulse width modulator (FlexPWM)               | Contains four PWM submodules, each of which is capable of controlling a single half-bridge power stage and two fault input channels  |
| Reset generation module (MC_RGM)              | Centralizes reset sources and manages the device reset sequence of the device  |
| Static random-access memory (SRAM)            | Provides storage for program code, constants, and variables  |
| System integration unit lite (SIUL)           | Provides control over all the electrical pad controls and up to 32 ports with 16 bits of bidirectional, general-purpose input and output signals and supports up to 32 external interrupts with trigger event configuration      |
| System status and configuration module (SSCM) | Provides system configuration and status data (such as memory size and status, device mode and security status), device identification data, debug status port enable and selection, and bus and peripheral abort enable/disable |
| System timer module (STM)                     | Provides a set of output compare events to support AUTOSAR <sup>1</sup> and operating system tasks   |
| System watchdog timer (SWT)                   | Provides protection from runaway code  |
| Wakeup unit (WKPU)                            | Supports up to 18 external sources that can generate interrupts or wakeup events, 1 of which can cause non-maskable interrupt requests or wakeup events  |

<sup>1</sup> AUTOSAR: AUTomotive Open System ARchitecture (see <http://www.autosar.org>)

## 1.5 Feature details

### 1.5.1 High performance e200z0 core processor

The e200z0 Power Architecture core provides the following features:

- High performance e200z0 core processor for managing peripherals and interrupts
- Single issue 4-stage pipeline in-order execution 32-bit Power Architecture CPU
- Harvard architecture
- Variable length encoding (VLE), allowing mixed 16-bit and 32-bit instructions
  - Results in smaller code size footprint
  - Minimizes impact on performance
- Branch processing acceleration using lookahead instruction buffer
- Load/store unit
  - 1 cycle load latency
  - Misaligned access support
  - No load-to-use pipeline bubbles
- Thirty-two 32-bit general purpose registers (GPRs)
- Separate instruction bus and load/store bus Harvard architecture
- Hardware vectored interrupt support
- Reservation instructions for implementing read-modify-write constructs
- Long cycle time instructions, except for guarded loads, do not increase interrupt latency
- Extensive system development support through Nexus debug port
- Non-maskable interrupt support

## 1.5.2 Crossbar switch (XBAR)

The XBAR multi-port crossbar switch supports simultaneous connections between four master ports and three slave ports. The crossbar supports a 32-bit address bus width and a 32-bit data bus width.

The crossbar allows for two concurrent transactions to occur from any master port to any slave port; but one of those transfers must be an instruction fetch from internal flash memory. If a slave port is simultaneously requested by more than one master port, arbitration logic will select the higher priority master and grant it ownership of the slave port. All other masters requesting that slave port will be stalled until the higher priority master completes its transactions. Requesting masters will be treated with equal priority and will be granted access to a slave port in round-robin fashion, based upon the ID of the last master to be granted access.

The crossbar provides the following features:

- 4 master ports:
  - e200z0 core complex Instruction port
  - e200z0 core complex Load/Store Data port
  - eDMA
  - FlexRay
- 3 slave ports:
  - Flash memory (code flash and data flash)
  - SRAM
  - Peripheral bridge
- 32-bit internal address, 32-bit internal data paths
- Fixed Priority Arbitration based on Port Master
- Temporary dynamic priority elevation of masters

## 1.5.3 Enhanced direct memory access (eDMA)

The enhanced direct memory access (eDMA) controller is a second-generation module capable of performing complex data movements via 16 programmable channels, with minimal intervention from the host processor. The hardware micro architecture includes a DMA engine which performs source and destination address calculations, and the actual data movement operations, along with an SRAM-based memory containing the transfer control descriptors (TCD) for the channels. This implementation is utilized to minimize the overall block size.

The eDMA module provides the following features:

- 16 channels support independent 8, 16 or 32-bit single value or block transfers
- Supports variable sized queues and circular queues
- Source and destination address registers are independently configured to either post-increment or to remain constant
- Each transfer is initiated by a peripheral, CPU, or eDMA channel request
- Each eDMA channel can optionally send an interrupt request to the CPU on completion of a single value or block transfer
- DMA transfers possible between system memories, DSPIs, ADC, FlexPWM, eTimer and CTU
- Programmable DMA channel multiplexer for assignment of any DMA source to any available DMA channel with as many as 30 request sources
- eDMA abort operation through software

## 1.5.4 Flash memory

The MPC5604P provides as much as 576 KB of programmable, non-volatile, flash memory. The non-volatile memory (NVM) can be used for instruction and/or data storage. The flash memory module interfaces the system bus to a dedicated flash memory

array controller. It supports a 32-bit data bus width at the system bus port, and a 128-bit read data interface to flash memory. The module contains four 128-bit wide prefetch buffers. Prefetch buffer hits allow no-wait responses. Normal flash memory array accesses are registered and are forwarded to the system bus on the following cycle, incurring two wait-states.

The flash memory module provides the following features:

- As much as 576 KB flash memory
  - 8 blocks (32 KB + 2×16 KB + 32 KB + 32 KB + 3×128 KB) code flash
  - 4 blocks (16 KB + 16 KB + 16 KB + 16 KB) data flash
  - Full Read While Write (RWW) capability between code and data flash
- Four 128-bit wide prefetch buffers to provide single cycle in-line accesses (prefetch buffers can be configured to prefetch code or data or both)
- Typical flash memory access time: 0 wait states for buffer hits, 2 wait states for page buffer miss at 64 MHz
- Hardware managed flash memory writes handled by 32-bit RISC Krypton engine
- Hardware and software configurable read and write access protections on a per-master basis
- Configurable access timing allowing use in a wide range of system frequencies
- Multiple-mapping support and mapping-based block access timing (up to 31 additional cycles) allowing use for emulation of other memory types.
- Software programmable block program/erase restriction control
- Erase of selected block(s)
- Read page sizes
  - Code flash memory: 128 bits (4 words)
  - Data flash memory: 32 bits (1 word)
- ECC with single-bit correction, double-bit detection for data integrity
  - Code flash memory: 64-bit ECC
  - Data flash memory: 64-bit ECC
- Embedded hardware program and erase algorithm
- Erase suspend, program suspend and erase-suspended program
- Censorship protection scheme to prevent flash memory content visibility
- Hardware support for EEPROM emulation

### 1.5.5 Static random access memory (SRAM)

The MPC5604P SRAM module provides up to 40 KB of general-purpose memory.

ECC handling is done on a 32-bit boundary and is completely software compatible with MPC55xx family devices with an e200z6 core and 64-bit wide ECC.

The SRAM module provides the following features:

- Supports read/write accesses mapped to the SRAM from any master
- Up to 40 KB general purpose SRAM
- Supports byte (8-bit), half word (16-bit), and word (32-bit) writes for optimal use of memory
- Typical SRAM access time: 0 wait-state for reads and 32-bit writes; 1 wait state for 8- and 16-bit writes if back to back with a read to same memory block

### 1.5.6 Interrupt controller (INTC)

The interrupt controller (INTC) provides priority-based preemptive scheduling of interrupt requests, suitable for statically scheduled hard real-time systems. The INTC handles 147 selectable-priority interrupt sources.

For high priority interrupt requests, the time from the assertion of the interrupt request from the peripheral to when the processor is executing the interrupt service routine (ISR) has been minimized. The INTC provides a unique vector for each interrupt request source for quick determination of which ISR has to be executed. It also provides a wide number of priorities so that lower priority ISRs do not delay the execution of higher priority ISRs. To allow the appropriate priorities for each source of interrupt request, the priority of each interrupt request is software configurable.

When multiple tasks share a resource, coherent accesses to that resource need to be supported. The INTC supports the priority ceiling protocol (PCP) for coherent accesses. By providing a modifiable priority mask, the priority can be raised temporarily so that all tasks which share the same resource can not preempt each other.

The INTC provides the following features:

- Unique 9-bit vector for each separate interrupt source
- 8 software triggerable interrupt sources
- 16 priority levels with fixed hardware arbitration within priority levels for each interrupt source
- Ability to modify the ISR or task priority: modifying the priority can be used to implement the Priority Ceiling Protocol for accessing shared resources.
- 2 external high priority interrupts directly accessing the main core and I/O processor (IOP) critical interrupt mechanism

## 1.5.7 System status and configuration module (SSCM)

The system status and configuration module (SSCM) provides central device functionality.

The SSCM includes these features:

- System configuration and status
  - Memory sizes/status
  - Device mode and security status
  - Determine boot vector
  - Search code flash for bootable sector
  - DMA status
- Debug status port enable and selection
- Bus and peripheral abort enable/disable

## 1.5.8 System clocks and clock generation

The following list summarizes the system clock and clock generation on the MPC5604P:

- Lock detect circuitry continuously monitors lock status
- Loss of clock (LOC) detection for PLL outputs
- Programmable output clock divider ( $\div 1$ ,  $\div 2$ ,  $\div 4$ ,  $\div 8$ )
- FlexPWM module and eTimer module can run on an independent clock source
- On-chip oscillator with automatic level control
- Internal 16 MHz RC oscillator for rapid start-up and safe mode: supports frequency trimming by user application

## 1.5.9 Frequency-modulated phase-locked loop (FMPLL)

The FMPLL allows the user to generate high speed system clocks from a 4–40 MHz input clock. Further, the FMPLL supports programmable frequency modulation of the system clock. The PLL multiplication factor, output clock divider ratio are all software configurable.

The PLL has the following major features:

- Input clock frequency: 4–40 MHz



- Maximum output frequency: 64 MHz
- Voltage controlled oscillator (VCO)—frequency 256–512 MHz
- Reduced frequency divider (RFD) for reduced frequency operation without forcing the PLL to relock
- Frequency-modulated PLL
  - Modulation enabled/disabled through software
  - Triangle wave modulation
- Programmable modulation depth ( $\pm 0.25\%$  to  $\pm 4\%$  deviation from center frequency): programmable modulation frequency dependent on reference frequency
- Self-clocked mode (SCM) operation

### 1.5.10 Main oscillator

The main oscillator provides these features:

- Input frequency range: 4–40 MHz
- Crystal input mode or oscillator input mode
- PLL reference

### 1.5.11 Internal RC oscillator

This device has an RC ladder phase-shift oscillator. The architecture uses constant current charging of a capacitor. The voltage at the capacitor is compared by the stable bandgap reference voltage.

The RC oscillator provides these features:

- Nominal frequency 16 MHz
- $\pm 5\%$  variation over voltage and temperature after process trim
- Clock output of the RC oscillator serves as system clock source in case loss of lock or loss of clock is detected by the PLL
- RC oscillator is used as the default system clock during startup

### 1.5.12 Periodic interrupt timer (PIT)

The PIT module implements these features:

- 4 general purpose interrupt timers
- 32-bit counter resolution
- Clocked by system clock frequency
- Each channel can be used as trigger for a DMA request

### 1.5.13 System timer module (STM)

The STM module implements these features:

- One 32-bit up counter with 8-bit prescaler
- Four 32-bit compare channels
- Independent interrupt source for each channel
- Counter can be stopped in debug mode

### 1.5.14 Software watchdog timer (SWT)

The SWT has the following features:



- 32-bit time-out register to set the time-out period
- Programmable selection of system or oscillator clock for timer operation
- Programmable selection of window mode or regular servicing
- Programmable selection of reset or interrupt on an initial time-out
- Master access protection
- Hard and soft configuration lock bits
- Reset configuration inputs allow timer to be enabled out of reset

### 1.5.15 Fault collection unit (FCU)

The FCU provides an independent fault reporting mechanism even if the CPU is malfunctioning.

The FCU module has the following features:

- FCU status register reporting the device status
- Continuous monitoring of critical fault signals
- User selection of critical signals from different fault sources inside the device
- Critical fault events trigger 2 external pins (user selected signal protocol) that can be used externally to reset the device and/or other circuitry (for example, safety relay or FlexRay transceiver)
- Faults are latched into a register

### 1.5.16 System integration unit – Lite (SIUL)

The MPC5604P SIUL controls MCU pad configuration, external interrupt, general purpose I/O (GPIO), and internal peripheral multiplexing.

The pad configuration block controls the static electrical characteristics of I/O pins. The GPIO block provides uniform and discrete input/output control of the I/O pins of the MCU.

The SIU provides the following features:

- Centralized general purpose input output (GPIO) control of as many as 80 input/output pins and 26 analog input-only pads (package dependent)
- All GPIO pins can be independently configured to support pull-up, pull down, or no pull
- Reading and writing to GPIO supported both as individual pins and 16-bit wide ports
- All peripheral pins (except ADC channels) can be alternatively configured as both general purpose input or output pins
- ADC channels support alternative configuration as general purpose inputs
- Direct readback of the pin value is supported on all pins through the SIUL
- Configurable digital input filter that can be applied to some general purpose input pins for noise elimination: as many as 4 internal functions can be multiplexed onto 1 pin

### 1.5.17 Boot and censorship

Different booting modes are available in the MPC5604P: booting from internal flash memory and booting via a serial link.

The default booting scheme uses the internal flash memory (an internal pull-down is used to select this mode). Optionally, the user can boot via FlexCAN or LINFlex (using the boot assist module software).

A censorship scheme is provided to protect the content of the flash memory and offer increased security for the entire device.

A password mechanism is designed to grant the legitimate user access to the non-volatile memory.

### 1.5.17.1 Boot assist module (BAM)

The BAM is a block of read-only one-time programmed memory and is identical for all MPC560xP devices that are based on the e200z0h core. The BAM program is executed every time the device is powered on if the alternate boot mode has been selected by the user.

The BAM provides the following features:

- Serial bootloading via FlexCAN or LINFlex
- Ability to accept a password via the used serial communication channel to grant the legitimate user access to the non-volatile memory

### 1.5.18 Error correction status module (ECSM)

The ECSM provides a myriad of miscellaneous control functions regarding program-visible information about the platform configuration and revision levels, a reset status register, a software watchdog timer, wakeup control for exiting sleep modes, and information on platform memory errors reported by error-correcting codes and/or generic access error information for certain processor cores.

The Error Correction Status Module supports a number of miscellaneous control functions for the platform. The ECSM includes these features:

- Registers for capturing information on platform memory errors if error-correcting codes (ECC) are implemented
- For test purposes, optional registers to specify the generation of double-bit memory errors are enabled on the MPC5604P.

The sources of the ECC errors are:

- Flash memory
- SRAM

### 1.5.19 Peripheral bridge (PBRIDGE)

The PBRIDGE implements the following features:

- Duplicated periphery
- Master access privilege level per peripheral (per master: read access enable; write access enable)
- Write buffering for peripherals
- Checker applied on PBRIDGE output toward periphery
- Byte endianness swap capability

### 1.5.20 Controller area network (FlexCAN)

The MPC5604P MCU contains one controller area network (FlexCAN) module. This module is a communication controller implementing the CAN protocol according to Bosch Specification version 2.0B. The CAN protocol was designed to be used primarily as a vehicle serial data bus, meeting the specific requirements of this field: real-time processing, reliable operation in the EMI environment of a vehicle, cost-effectiveness and required bandwidth. The FlexCAN module contains 32 message buffers.

The FlexCAN module provides the following features:

- Full implementation of the CAN protocol specification, version 2.0B
  - Standard data and remote frames
  - Extended data and remote frames
  - Up to 8-bytes data length
  - Programmable bit rate up to 1 Mbit/s



- 32 message buffers of up to 8-bytes data length
- Each message buffer configurable as Rx or Tx, all supporting standard and extended messages
- Programmable loop-back mode supporting self-test operation
- 3 programmable mask registers
- Programmable transmit-first scheme: lowest ID or lowest buffer number
- Time stamp based on 16-bit free-running timer
- Global network time, synchronized by a specific message
- Maskable interrupts
- Independent of the transmission medium (an external transceiver is assumed)
- High immunity to EMI
- Short latency time due to an arbitration scheme for high-priority messages
- Transmit features
  - Supports configuration of multiple mailboxes to form message queues of scalable depth
  - Arbitration scheme according to message ID or message buffer number
  - Internal arbitration to guarantee no inner or outer priority inversion
  - Transmit abort procedure and notification
- Receive features
  - Individual programmable filters for each mailbox
  - 8 mailboxes configurable as a six-entry receive FIFO
  - 8 programmable acceptance filters for receive FIFO
- Programmable clock source
  - System clock
  - Direct oscillator clock to avoid PLL jitter

### 1.5.21 Safety port (FlexCAN)

The MPC5604P MCU has a second CAN controller synthesized to run at high bit rates to be used as a safety port. The CAN module of the safety port provides the following features:

- Identical to the FlexCAN module
- Bit rate as fast as 7.5 Mbit/s at 60 MHz CPU clock using direct connection between CAN modules (no physical transceiver required)
- 32 message buffers of up to 8 bytes data length
- Can be used as a second independent CAN module

### 1.5.22 FlexRay

The FlexRay module provides the following features:

- Full implementation of FlexRay Protocol Specification 2.1
- 32 configurable message buffers can be handled
- Dual channel or single channel mode of operation, each as fast as 10 Mbit/s data rate
- Message buffers configurable as Tx, Rx or RxFIFO
- Message buffer size configurable
- Message filtering for all message buffers based on FrameID, cycle count and message ID
- Programmable acceptance filters for RxFIFO message buffers

## 1.5.23 Serial communication interface module (LINFlex)

The LINFlex (local interconnect network flexible) on the MPC5604P features the following:

- Supports LIN Master mode, LIN Slave mode and UART mode
- LIN state machine compliant to LIN1.3, 2.0, and 2.1 specifications
- Handles LIN frame transmission and reception without CPU intervention
- LIN features
  - Autonomous LIN frame handling
  - Message buffer to store Identifier and as much as 8 data bytes
  - Supports message length as long as 64 bytes
  - Detection and flagging of LIN errors (sync field, delimiter, ID parity, bit framing, checksum, and time-out)
  - Classic or extended checksum calculation
  - Configurable Break duration as long as 36-bit times
  - Programmable baud rate prescalers (13-bit mantissa, 4-bit fractional)
  - Diagnostic features: Loop back; Self Test; LIN bus stuck dominant detection
  - Interrupt-driven operation with 16 interrupt sources
- LIN slave mode features
  - Autonomous LIN header handling
  - Autonomous LIN response handling
- UART mode
  - Full-duplex operation
  - Standard non return-to-zero (NRZ) mark/space format
  - Data buffers with 4-byte receive, 4-byte transmit
  - Configurable word length (8-bit or 9-bit words)
  - Error detection and flagging
  - Parity, Noise and Framing errors
  - Interrupt-driven operation with four interrupt sources
  - Separate transmitter and receiver CPU interrupt sources
  - 16-bit programmable baud-rate modulus counter and 16-bit fractional
  - 2 receiver wake-up methods

## 1.5.24 Deserial serial peripheral interface (DSPI)

The deserial serial peripheral interface (DSPI) module provides a synchronous serial interface for communication between the MPC5604P MCU and external devices.

The DSPI modules provide these features:

- Full duplex, synchronous transfers
- Master or slave operation
- Programmable master bit rates
- Programmable clock polarity and phase
- End-of-transmission interrupt flag
- Programmable transfer baud rate
- Programmable data frames from 4 to 16 bits
- Up to 20 chip select lines available
  - 8 on DSPI\_0
  - 4 each on DSPI\_1, DSPI\_2 and DSPI\_3



- 8 clock and transfer attributes registers
- Chip select strobe available as alternate function on one of the chip select pins for deglitching
- FIFOs for buffering as many as 5 transfers on the transmit and receive side
- Queuing operation possible through use of the eDMA
- General purpose I/O functionality on pins when not used for SPI

### 1.5.25 Pulse width modulator (FlexPWM)

The pulse width modulator module (PWM) contains four PWM submodules, each capable of controlling a single half-bridge power stage. There are also four fault channels.

This PWM is capable of controlling most motor types: AC induction motors (ACIM), permanent magnet AC motors (PMAC), both brushless (BLDC) and brush DC motors (BDC), switched (SRM) and variable reluctance motors (VRM), and stepper motors.

The FlexPWM block implements the following features:

- 16-bit resolution for center, edge-aligned, and asymmetrical PWMs
- Maximum operating clock frequency of 120 MHz
- PWM outputs can operate as complementary pairs or independent channels
- Can accept signed numbers for PWM generation
- Independent control of both edges of each PWM output
- Synchronization to external hardware or other PWM supported
- Double buffered PWM registers
  - Integral reload rates from 1 to 16
  - Half cycle reload capability
- Multiple ADC trigger events can be generated per PWM cycle via hardware
- Write protection for critical registers
- Fault inputs can be assigned to control multiple PWM outputs
- Programmable filters for fault inputs
- Independently programmable PWM output polarity
- Independent top and bottom deadtime insertion
- Each complementary pair can operate with its own PWM frequency and deadtime values
- Individual software-control for each PWM output
- All outputs can be programmed to change simultaneously via a “Force Out” event
- PWMX pin can optionally output a third PWM signal from each submodule
- Channels not used for PWM generation can be used for buffered output compare functions
- Channels not used for PWM generation can be used for input capture functions
- Enhanced dual-edge capture functionality
- eDMA support with automatic reload
- 2 fault inputs
- Capture capability for PWMA, PWMB, and PWMX channels not supported

### 1.5.26 eTimer

The MPC5604P includes two eTimer modules. Each module provides six 16-bit general purpose up/down timer/counter units with the following features:

- Maximum operating clock frequency of 120 MHz
- Individual channel capability



- Input capture trigger
- Output compare
- Double buffer (to capture rising edge and falling edge)
- Separate prescaler for each counter
- Selectable clock source
- 0–100% pulse measurement
- Rotation direction flag (Quad decoder mode)
- Maximum count rate
  - External event counting: max. count rate = peripheral clock/2
  - Internal clock counting: max. count rate = peripheral clock
- Counters are:
  - Cascadable
  - Preloadable
- Programmable count modulo
- Quadrature decode capabilities
- Counters can share available input pins
- Count once or repeatedly
- Pins available as GPIO when timer functionality not in use

## 1.5.27 Analog-to-digital converter (ADC) module

The ADC module provides the following features:

Analog part:

- 2 on-chip AD converters
  - 10-bit AD resolution
  - 1 sample and hold unit per ADC
  - Conversion time, including sampling time, less than 1  $\mu$ s (at full precision)
  - Typical sampling time is 150 ns min. (at full precision)
  - Differential non-linearity error (DNL)  $\pm 1$  LSB
  - Integral non-linearity error (INL)  $\pm 1.5$  LSB
  - TUE  $< 3$  LSB
  - Single-ended input signal up to 5.0 V
  - The ADC and its reference can be supplied with a voltage independent from  $V_{DDIO}$
  - The ADC supply can be equal or higher than  $V_{DDIO}$
  - The ADC supply and the ADC reference are not independent from each other (they are internally bonded to the same pad)
  - Sample times of 2 (default), 8, 64, or 128 ADC clock cycles

Digital part:

- $2 \times 13$  input channels including 4 channels shared between the 2 converters
- 4 analog watchdogs comparing ADC results against predefined levels (low, high, range) before results are stored in the appropriate ADC result location,
- 2 modes of operation: Normal mode or CTU control mode
- Normal mode features
  - Register-based interface with the CPU: control register, status register, 1 result register per channel



- ADC state machine managing 3 request flows: regular command, hardware injected command, software injected command
- Selectable priority between software and hardware injected commands
- 4 analog watchdogs comparing ADC results against predefined levels (low, high, range)
- DMA compatible interface
- CTU control mode features
  - Triggered mode only
  - 4 independent result queues (2 × 16 entries, 2 × 4 entries)
  - Result alignment circuitry (left justified; right justified)
  - 32-bit read mode allows to have channel ID on one of the 16-bit part
  - DMA compatible interfaces

## 1.5.28 Cross triggering unit (CTU)

The cross triggering unit allows automatic generation of ADC conversion requests on user selected conditions without CPU load during the PWM period and with minimized CPU load for dynamic configuration.

It implements the following features:

- Double buffered trigger generation unit with as many as eight independent triggers generated from external triggers
- Trigger generation unit configurable in sequential mode or in triggered mode
- Each Trigger can be appropriately delayed to compensate the delay of external low pass filter
- Double buffered global trigger unit allowing eTimer synchronization and/or ADC command generation
- Double buffered ADC command list pointers to minimize ADC-trigger unit update
- Double buffered ADC conversion command list with as many as 24 ADC commands
- Each trigger has the capability to generate consecutive commands
- ADC conversion command allows to control ADC channel from each ADC, single or synchronous sampling, independent result queue selection

## 1.5.29 Nexus development interface (NDI)

The NDI (Nexus Development Interface) block provides real-time development support capabilities for the MPC5604P Power Architecture based MCU in compliance with the IEEE-ISTO 5001-2003 standard. This development support is supplied for MCUs without requiring external address and data pins for internal visibility. The NDI block is an integration of several individual Nexus blocks that are selected to provide the development support interface for this device. The NDI block interfaces to the host processor and internal busses to provide development support as per the IEEE-ISTO 5001-2003 Class 2+ standard. The development support provided includes access to the MCU's internal memory map and access to the processor's internal registers during run time.

The Nexus Interface provides the following features:

- Configured via the IEEE 1149.1
- All Nexus port pins operate at  $V_{DDIO}$  (no dedicated power supply)
- Nexus 2+ features supported
  - Static debug
  - Watchpoint messaging
  - Ownership trace messaging
  - Program trace messaging
  - Real time read/write of any internally memory mapped resources through JTAG pins
  - Overrun control, which selects whether to stall before Nexus overruns or keep executing and allow overwrite of information



- Watchpoint triggering, watchpoint triggers program tracing
- Auxiliary Output Port
  - 4 MDO (Message Data Out) pins
  - MCKO (Message Clock Out) pin
  - 2  $\overline{\text{MSEO}}$  (Message Start/End Out) pins
  - $\overline{\text{EVTO}}$  (Event Out) pin
- Auxiliary Input Port
  - $\overline{\text{EVTI}}$  (Event In) pin

### 1.5.30 Cyclic redundancy check (CRC)

The CRC computing unit is dedicated to the computation of CRC off-loading the CPU. The CRC module features:

- Support for CRC-16-CCITT (x25 protocol):
  - $x^{16} + x^{12} + x^5 + 1$
- Support for CRC-32 (Ethernet protocol):
  - $x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$
- Zero wait states for each write/read operations to the CRC\_CFG and CRC\_INP registers at the maximum frequency

### 1.5.31 IEEE 1149.1 JTAG controller

The JTAG controller (JTAGC) block provides the means to test chip functionality and connectivity while remaining transparent to system logic when not in test mode. All data input to and output from the JTAGC block is communicated in serial format. The JTAGC block is compliant with the IEEE standard.

The JTAG controller provides the following features:

- IEEE Test Access Port (TAP) interface with 4 pins (TDI, TMS, TCK, TDO)
- Selectable modes of operation include JTAGC/debug or normal system operation.
- A 5-bit instruction register that supports the following IEEE 1149.1-2001 defined instructions:
  - BYPASS, IDCODE, EXTEST, SAMPLE, SAMPLE/PRELOAD
- A 5-bit instruction register that supports the additional following public instructions:
  - ACCESS\_AUX\_TAP\_NPC, ACCESS\_AUX\_TAP\_ONCE
- 3 test data registers: a bypass register, a boundary scan register, and a device identification register.
- A TAP controller state machine that controls the operation of the data registers, instruction register and associated circuitry.

### 1.5.32 On-chip voltage regulator (VREG)

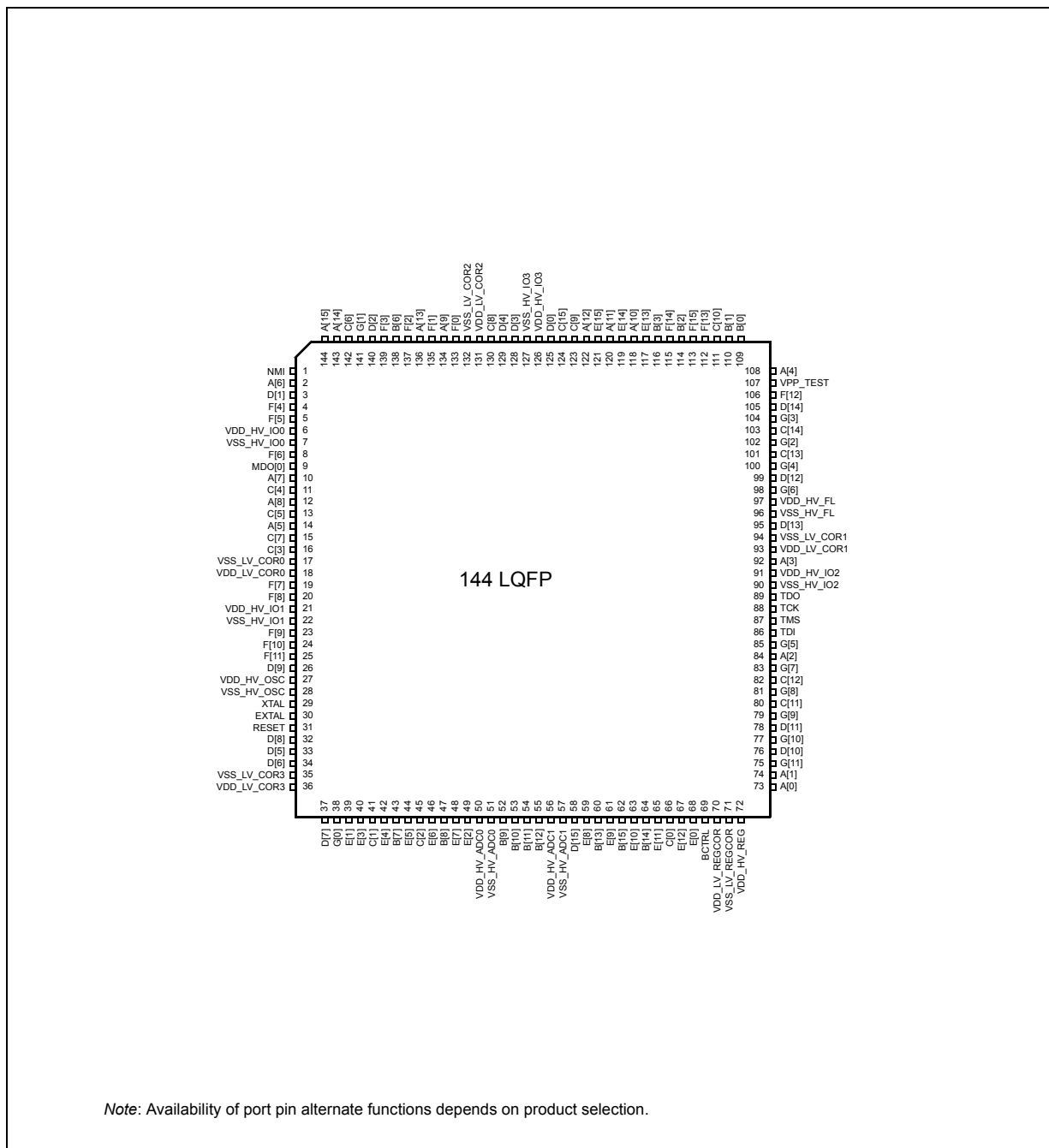
The on-chip voltage regulator module provides the following features:

- Uses external NPN (negative-positive-negative) transistor
- Regulates external 3.3 V /5.0 V down to 1.2 V for the core logic
- Low voltage detection on the internal 1.2 V and I/O voltage 3.3 V

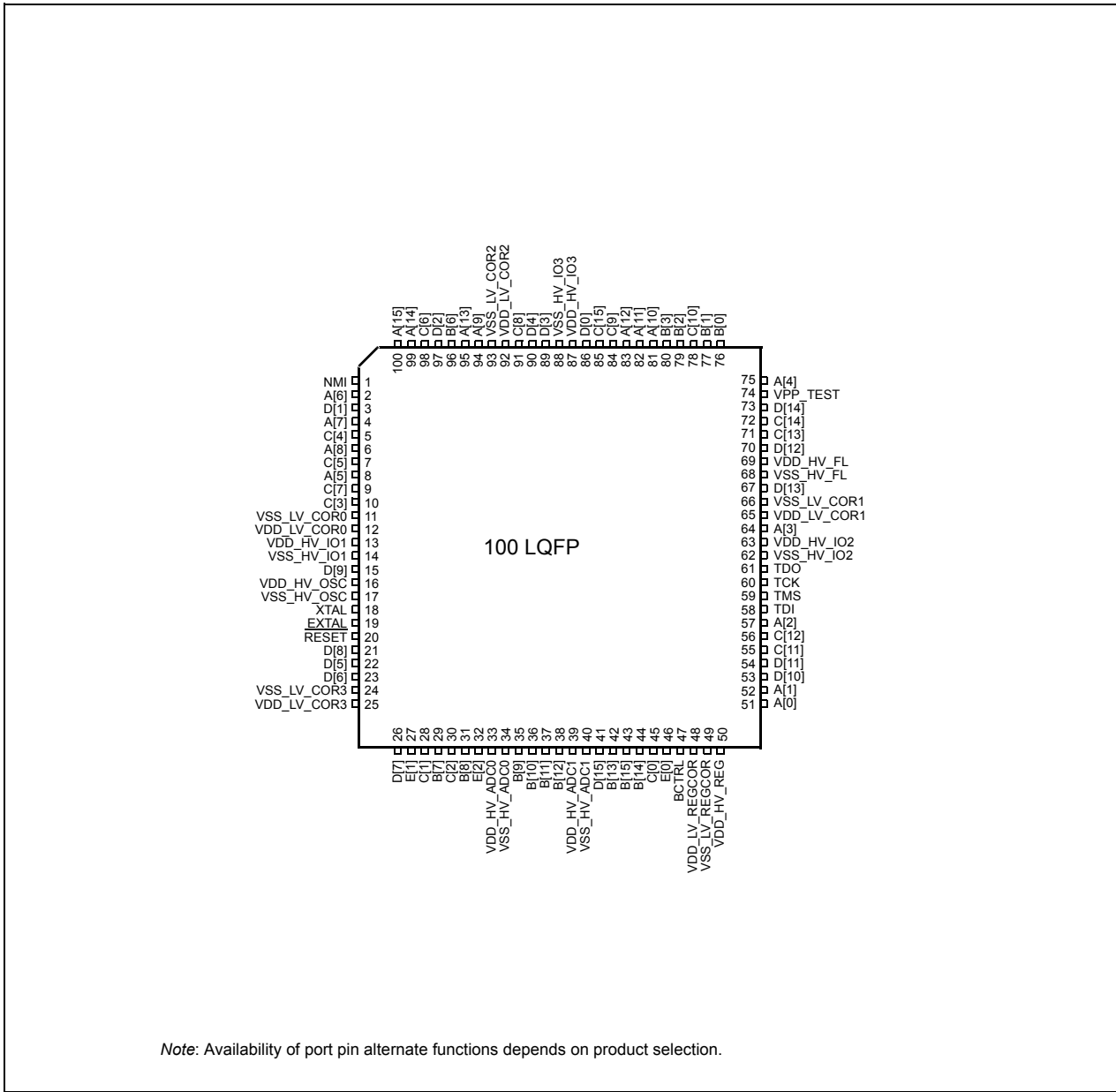
## 2 Package pinouts and signal descriptions

### 2.1 Package pinouts

The LQFP pinouts are shown in the following figures.



**Figure 2. 144-pin LQFP pinout (top view)**



**Figure 3. 100-pin LQFP pinout (top view)**

## 2.2 Pin description

The following sections provide signal descriptions and related information about the functionality and configuration of the MPC5604P devices.

### 2.2.1 Power supply and reference voltage pins

Table 3 lists the power supply and reference voltage for the MPC5604P devices.

**Table 3. Supply pins**

| Supply  |  | Pin     |         |
|---|--|---------|---------|
| Symbol  | Description  | 100-pin | 144-pin |
| VREG control and power supply pins. Pins available on 100-pin and 144-pin package.  |  |         |         |
| BCTRL   | Voltage regulator external NPN ballast base control pin  | 47      | 69      |
| $V_{DD\_HV\_REG}$ (3.3 V or 5.0 V)  | Voltage regulator supply voltage   | 50      | 72      |
| $V_{DD\_LV\_REGCOR}$  | 1.2 V decoupling pins for core logic and regulator feedback. Decoupling capacitor must be connected between this pins and $V_{SS\_LV\_REGCOR}$ . | 48      | 70      |
| $V_{SS\_LV\_REGCOR}$  | 1.2 V decoupling pins for core logic and regulator feedback. Decoupling capacitor must be connected between this pins and $V_{DD\_LV\_REGCOR}$ . | 49      | 71      |
| ADC_0/ADC_1 reference and supply voltage. Pins available on 100-pin and 144-pin package.  |  |         |         |
| $V_{DD\_HV\_ADC0}^1$  | ADC_0 supply and high reference voltage  | 33      | 50      |
| $V_{SS\_HV\_ADC0}$  | ADC_0 ground and low reference voltage   | 34      | 51      |
| $V_{DD\_HV\_ADC1}$  | ADC_1 supply and high reference voltage  | 39      | 56      |
| $V_{SS\_HV\_ADC1}$  | ADC_1 ground and low reference voltage   | 40      | 57      |
| Power supply pins (3.3 V or 5.0 V). All pins available on 144-pin package. Five pairs ( $V_{DD}$ ; $V_{SS}$ ) available on 100-pin package. |  |         |         |
| $V_{DD\_HV\_IO0}^2$   | Input/Output supply voltage  | —       | 6       |
| $V_{SS\_HV\_IO0}^2$   | Input/Output ground  | —       | 7       |
| $V_{DD\_HV\_IO1}$   | Input/Output supply voltage  | 13      | 21      |
| $V_{SS\_HV\_IO1}$   | Input/Output ground  | 14      | 22      |
| $V_{DD\_HV\_IO2}$   | Input/Output supply voltage  | 63      | 91      |
| $V_{SS\_HV\_IO2}$   | Input/Output ground  | 62      | 90      |
| $V_{DD\_HV\_IO3}$   | Input/Output supply voltage  | 87      | 126     |
| $V_{SS\_HV\_IO3}$   | Input/Output ground  | 88      | 127     |
| $V_{DD\_HV\_FL}$  | Code and data flash supply voltage   | 69      | 97      |
| $V_{SS\_HV\_FL}$  | Code and data flash supply ground  | 68      | 96      |
| $V_{DD\_HV\_OSC}$   | Crystal oscillator amplifier supply voltage  | 16      | 27      |
| $V_{SS\_HV\_OSC}$   | Crystal oscillator amplifier ground  | 17      | 28      |
| Power supply pins (1.2 V). All pins available on 100-pin and 144-pin package.   |  |         |         |
| $V_{DD\_LV\_COR0}$  | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest $V_{SS\_LV\_COR}$ pin.           | 12      | 18      |

**Table 3. Supply pins (continued)**

| Supply                  |   | Pin     |         |
|-------------------------|---|---------|---------|
| Symbol                  | Description   | 100-pin | 144-pin |
| V <sub>SS_LV_COR0</sub> | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin. | 11      | 17      |
| V <sub>DD_LV_COR1</sub> | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>SS_LV_COR</sub> pin. | 65      | 93      |
| V <sub>SS_LV_COR1</sub> | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin. | 66      | 94      |
| V <sub>DD_LV_COR2</sub> | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>SS_LV_COR</sub> pin. | 92      | 131     |
| V <sub>SS_LV_COR2</sub> | 1.2 V Decoupling pins for core logic. Decoupling capacitor must be connected between these pins and the nearest V <sub>DD_LV_COR</sub> pin. | 93      | 132     |
| V <sub>DD_LV_COR3</sub> | 1.2 V Decoupling pins for on-chip PLL modules. Decoupling capacitor must be connected between this pin and V <sub>SS_LV_COR3</sub> .        | 25      | 36      |
| V <sub>SS_LV_COR3</sub> | 1.2 V Decoupling pins for on-chip PLL modules. Decoupling capacitor must be connected between this pin and V <sub>DD_LV_COR3</sub> .        | 24      | 35      |

<sup>1</sup> Analog supply/ground and high/low reference lines are internally physically separate, but are shorted via a double-bonding connection on V<sub>DD\_HV\_ADCx</sub>/V<sub>SS\_HV\_ADCx</sub> pins.

<sup>2</sup> Not available on 100-pin package.

## 2.2.2 System pins

Table 3 and Table 4 contain information on pin functions for the MPC5604P devices. The pins listed in Table 4 are single-function pins. The pins shown in Table 5 are multi-function pins, programmable via their respective Pad Configuration Register (PCR) values.

**Table 4. System pins**

| Symbol  | Description  | Direction   | Pad speed <sup>1</sup> |         | Pin     |         |
|---|--|-------------|------------------------|---------|---------|---------|
|   |  |             | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| Dedicated pins. Available on 100-pin and 144-pin package. |  |             |                        |         |         |         |
| MDO[0]  | Nexus Message Data Output—line 0   | Output only | Fast                   |         | —       | 9       |
| NMI   | Non-Maskable Interrupt   | Input only  | Slow                   | —       | 1       | 1       |
| XTAL  | Analog output of the oscillator amplifier circuit; needs to be grounded if oscillator is used in bypass mode | —           | —                      | —       | 18      | 29      |

**Table 4. System pins (continued)**

| Symbol   | Description   | Direction     | Pad speed <sup>1</sup> |         | Pin     |         |
|--|---|---------------|------------------------|---------|---------|---------|
|  |   |               | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| EXTAL  | <ul style="list-style-type: none"> <li>Analog input of oscillator amplifier circuit, when oscillator not in bypass mode</li> <li>Analog input for clock generator when oscillator in bypass mode</li> </ul> | —             | —                      | —       | 19      | 30      |
| TMS  | JTAG state machine control  | Bidirectional | Slow                   | Fast    | 59      | 87      |
| TCK  | JTAG clock  | Input only    | Slow                   | —       | 60      | 88      |
| TDI  | Test Data In  | Input only    | Slow                   | Medium  | 58      | 86      |
| TDO  | Test Data Out   | Output only   | Slow                   | Fast    | 61      | 89      |
| Reset pin, available on 100-pin and 144-pin package. |   |               |                        |         |         |         |
| $\overline{\text{RESET}}$                            | Bidirectional reset with Schmitt trigger characteristics and noise filter   | Bidirectional | Medium                 | —       | 20      | 31      |
| Test pin, available on 100-pin and 144-pin package.  |   |               |                        |         |         |         |
| VPP_TEST   | Pin for testing purpose only. To be tied to ground in normal operating mode.  | —             | —                      | —       | 74      | 107     |

<sup>1</sup> SCR values refer to the value assigned to the Slew Rate Control bits of the pad configuration register.

### 2.2.3 Pin muxing

Table 5 defines the pin list and muxing for the MPC5604P devices.

Each row of Table 5 shows all the possible ways of configuring each pin, via alternate functions. The default function assigned to each pin after reset is the ALT0 function.

MPC5604P devices provide four main I/O pad types, depending on the associated functions:

- *Slow pads* are the most common, providing a compromise between transition time and low electromagnetic emission.
- *Medium pads* provide fast enough transition for serial communication channels with controlled current to reduce electromagnetic emission.
- *Fast pads* provide maximum speed. They are used for improved NEXUS debugging capability.
- *Symmetric pads* are designed to meet FlexRay requirements.

Medium and Fast pads can use slow configuration to reduce electromagnetic emission, at the cost of reducing AC performance. For more information, see the data sheet’s “Pad AC Specifications” section.

**Table 5. Pin muxing**

| Port pin          | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>           | Functions  | Peripheral <sup>3</sup>  | I/O direction <sup>4</sup>          | Pad speed <sup>5</sup> |         | Pin No. |         |
|-------------------|----------------------------------|---|--|--|-------------------------------------|------------------------|---------|---------|---------|
|                   |                                  |   |  |  |                                     | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| Port A (16-bit)   |                                  |   |  |  |                                     |                        |         |         |         |
| A[0]              | PCR[0]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[0]<br>ETC[0]<br>SCK<br>F[0]<br>EIRQ[0]                | SIUL<br>eTimer_0<br>DSPI_2<br>FCU_0<br>SIUL                    | I/O<br>I/O<br>O<br>O<br>I           | Slow                   | Medium  | 51      | 73      |
| A[1]              | PCR[1]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[1]<br>ETC[1]<br>SOUT<br>F[1]<br>EIRQ[1]               | SIUL<br>eTimer_0<br>DSPI_2<br>FCU_0<br>SIUL                    | I/O<br>I/O<br>O<br>O<br>I           | Slow                   | Medium  | 52      | 74      |
| A[2] <sup>6</sup> | PCR[2]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—<br>— | GPIO[2]<br>ETC[2]<br>—<br>A[3]<br>SIN<br>ABS[0]<br>EIRQ[2] | SIUL<br>eTimer_0<br>—<br>FlexPWM_0<br>DSPI_2<br>MC_RGM<br>SIUL | I/O<br>I/O<br>—<br>O<br>I<br>I<br>I | Slow                   | Medium  | 57      | 84      |
| A[3] <sup>6</sup> | PCR[3]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[3]<br>ETC[3]<br>CS0<br>B[3]<br>ABS[2]<br>EIRQ[3]      | SIUL<br>eTimer_0<br>DSPI_2<br>FlexPWM_0<br>MC_RGM<br>SIUL      | I/O<br>I/O<br>I/O<br>O<br>I<br>I    | Slow                   | Medium  | 64      | 92      |
| A[4] <sup>6</sup> | PCR[4]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[4]<br>ETC[0]<br>CS1<br>ETC[4]<br>FAB<br>EIRQ[4]       | SIUL<br>eTimer_1<br>DSPI_2<br>eTimer_0<br>MC_RGM<br>SIUL       | I/O<br>I/O<br>O<br>I/O<br>I<br>I    | Slow                   | Medium  | 75      | 108     |
| A[5]              | PCR[5]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[5]<br>CS0<br>ETC[5]<br>CS7<br>EIRQ[5]                 | SIUL<br>DSPI_1<br>eTimer_1<br>DSPI_0<br>SIUL                   | I/O<br>I/O<br>I/O<br>O<br>I         | Slow                   | Medium  | 8       | 14      |
| A[6]              | PCR[6]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[6]<br>SCK<br>—<br>—<br>EIRQ[6]                        | SIUL<br>DSPI_1<br>—<br>—<br>SIUL                               | I/O<br>I/O<br>—<br>—<br>I           | Slow                   | Medium  | 2       | 2       |
| A[7]              | PCR[7]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[7]<br>SOUT<br>—<br>—<br>EIRQ[7]                       | SIUL<br>DSPI_1<br>—<br>—<br>SIUL                               | I/O<br>O<br>—<br>—<br>I             | Slow                   | Medium  | 4       | 10      |

**Table 5. Pin muxing (continued)**

| Port pin | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>           | Functions   | Peripheral <sup>3</sup>                                    | I/O direction <sup>4</sup>        | Pad speed <sup>5</sup> |         | Pin No. |         |
|----------|----------------------------------|---|---|--|-----------------------------------|------------------------|---------|---------|---------|
|          |                                  |   |   |  |                                   | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| A[8]     | PCR[8]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[8]<br>—<br>—<br>—<br>SIN<br>EIRQ[8]                  | SIUL<br>—<br>—<br>—<br>DSPI_1<br>SIUL                      | I/O<br>—<br>—<br>—<br>I<br>I      | Slow                   | Medium  | 6       | 12      |
| A[9]     | PCR[9]                           | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[9]<br>CS1<br>—<br>B[3]<br>FAULT[0]                   | SIUL<br>DSPI_2<br>—<br>FlexPWM_0<br>FlexPWM_0              | I/O<br>O<br>—<br>O<br>I           | Slow                   | Medium  | 94      | 134     |
| A[10]    | PCR[10]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[10]<br>CS0<br>B[0]<br>X[2]<br>EIRQ[9]                | SIUL<br>DSPI_2<br>FlexPWM_0<br>FlexPWM_0<br>SIUL           | I/O<br>I/O<br>O<br>I/O<br>I       | Slow                   | Medium  | 81      | 118     |
| A[11]    | PCR[11]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[11]<br>SCK<br>A[0]<br>A[2]<br>EIRQ[10]               | SIUL<br>DSPI_2<br>FlexPWM_0<br>FlexPWM_0<br>SIUL           | I/O<br>I/O<br>O<br>O<br>I         | Slow                   | Medium  | 82      | 120     |
| A[12]    | PCR[12]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[12]<br>SOUT<br>A[2]<br>B[2]<br>EIRQ[11]              | SIUL<br>DSPI_2<br>FlexPWM_0<br>FlexPWM_0<br>SIUL           | I/O<br>O<br>O<br>O<br>I           | Slow                   | Medium  | 83      | 122     |
| A[13]    | PCR[13]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—<br>— | GPIO[13]<br>—<br>B[2]<br>—<br>SIN<br>FAULT[0]<br>EIRQ[12] | SIUL<br>—<br>FlexPWM_0<br>—<br>DSPI_2<br>FlexPWM_0<br>SIUL | I/O<br>—<br>O<br>—<br>I<br>I<br>I | Slow                   | Medium  | 95      | 136     |
| A[14]    | PCR[14]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[14]<br>TXD<br>ETC[4]<br>—<br>EIRQ[13]                | SIUL<br>Safety Port_0<br>eTimer_1<br>—<br>SIUL             | I/O<br>O<br>I/O<br>—<br>I         | Slow                   | Medium  | 99      | 143     |
| A[15]    | PCR[15]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[15]<br>—<br>ETC[5]<br>—<br>RXD<br>EIRQ[14]           | SIUL<br>—<br>eTimer_1<br>—<br>Safety Port_0<br>SIUL        | I/O<br>—<br>I/O<br>—<br>I<br>I    | Slow                   | Medium  | 100     | 144     |

**Table 5. Pin muxing (continued)**

| Port pin        | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>      | Functions  | Peripheral <sup>3</sup>                            | I/O direction <sup>4</sup>     | Pad speed <sup>5</sup> |         | Pin No. |         |
|-----------------|----------------------------------|--|--|--|--------------------------------|------------------------|---------|---------|---------|
|                 |                                  |  |  |  |                                | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| Port B (16-bit) |                                  |  |  |  |                                |                        |         |         |         |
| B[0]            | PCR[16]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[16]<br>TXD<br>ETC[2]<br>DEBUG[0]<br>EIRQ[15]      | SIUL<br>FlexCAN_0<br>eTimer_1<br>SSCM<br>SIUL      | I/O<br>O<br>I/O<br>—<br>I      | Slow                   | Medium  | 76      | 109     |
| B[1]            | PCR[17]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[17]<br>—<br>ETC[3]<br>DEBUG[1]<br>RXD<br>EIRQ[16] | SIUL<br>—<br>eTimer_1<br>SSCM<br>FlexCAN_0<br>SIUL | I/O<br>—<br>I/O<br>—<br>I<br>I | Slow                   | Medium  | 77      | 110     |
| B[2]            | PCR[18]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[18]<br>TXD<br>—<br>DEBUG[2]<br>EIRQ[17]           | SIUL<br>LIN_0<br>—<br>SSCM<br>SIUL                 | I/O<br>O<br>—<br>—<br>I        | Slow                   | Medium  | 79      | 114     |
| B[3]            | PCR[19]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[19]<br>—<br>—<br>DEBUG[3]<br>RXD                  | SIUL<br>—<br>—<br>SSCM<br>LIN_0                    | I/O<br>—<br>—<br>—<br>I        | Slow                   | Medium  | 80      | 116     |
| B[6]            | PCR[22]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[22]<br>CLKOUT<br>CS2<br>—<br>EIRQ[18]             | SIUL<br>MC_CGL<br>DSPI_2<br>—<br>SIUL              | I/O<br>O<br>O<br>—<br>I        | Slow                   | Medium  | 96      | 138     |
| B[7]            | PCR[23]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[23]<br>—<br>—<br>—<br>AN[0]<br>RXD                | SIUL<br>—<br>—<br>—<br>ADC_0<br>LIN_0              | Input only                     | —                      | —       | 29      | 43      |
| B[8]            | PCR[24]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[24]<br>—<br>—<br>—<br>AN[1]<br>ETC[5]             | SIUL<br>—<br>—<br>—<br>ADC_0<br>eTimer_0           | Input only                     | —                      | —       | 31      | 47      |
| B[9]            | PCR[25]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[25]<br>—<br>—<br>—<br>AN[11]                      | SIUL<br>—<br>—<br>—<br>ADC_0 / ADC_1               | Input only                     | —                      | —       | 35      | 52      |

**Table 5. Pin muxing (continued)**

| Port pin        | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>           | Functions  | Peripheral <sup>3</sup>                          | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |         | Pin No. |         |
|-----------------|----------------------------------|---|--|--|----------------------------|------------------------|---------|---------|---------|
|                 |                                  |   |  |  |                            | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| B[10]           | PCR[26]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[26]<br>—<br>—<br>—<br>AN[12]                      | SIUL<br>—<br>—<br>—<br>ADC_0 / ADC_1             | Input only                 | —                      | —       | 36      | 53      |
| B[11]           | PCR[27]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[27]<br>—<br>—<br>—<br>AN[13]                      | SIUL<br>—<br>—<br>—<br>ADC_0 / ADC_1             | Input only                 | —                      | —       | 37      | 54      |
| B[12]           | PCR[28]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[28]<br>—<br>—<br>—<br>AN[14]                      | SIUL<br>—<br>—<br>—<br>ADC_0 / ADC_1             | Input only                 | —                      | —       | 38      | 55      |
| B[13]           | PCR[29]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[29]<br>—<br>—<br>—<br>AN[0]<br>RXD                | SIUL<br>—<br>—<br>—<br>ADC_1<br>LIN_1            | Input only                 | —                      | —       | 42      | 60      |
| B[14]           | PCR[30]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—<br>— | GPIO[30]<br>—<br>—<br>—<br>AN[1]<br>ETC[4]<br>EIRQ[19] | SIUL<br>—<br>—<br>—<br>ADC_1<br>eTimer_0<br>SIUL | Input only                 | —                      | —       | 44      | 64      |
| B[15]           | PCR[31]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>—      | GPIO[31]<br>—<br>—<br>—<br>AN[2]<br>EIRQ[20]           | SIUL<br>—<br>—<br>—<br>ADC_1<br>SIUL             | Input only                 | —                      | —       | 43      | 62      |
| Port C (16-bit) |                                  |   |  |  |                            |                        |         |         |         |
| C[0]            | PCR[32]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[32]<br>—<br>—<br>—<br>AN[3]                       | SIUL<br>—<br>—<br>—<br>ADC_1                     | Input only                 | —                      | —       | 45      | 66      |
| C[1]            | PCR[33]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—           | GPIO[33]<br>—<br>—<br>—<br>AN[2]                       | SIUL<br>—<br>—<br>—<br>ADC_0                     | Input only                 | —                      | —       | 28      | 41      |

**Table 5. Pin muxing (continued)**

| Port pin | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>      | Functions  | Peripheral <sup>3</sup>                          | I/O direction <sup>4</sup>     | Pad speed <sup>5</sup> |         | Pin No. |         |
|----------|----------------------------------|--|--|--|--------------------------------|------------------------|---------|---------|---------|
|          |                                  |  |  |  |                                | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| C[2]     | PCR[34]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[34]<br>—<br>—<br>—<br>AN[3]                         | SIUL<br>—<br>—<br>—<br>ADC_0                     | Input only                     | —                      | —       | 30      | 45      |
| C[3]     | PCR[35]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[35]<br>CS1<br>ETC[4]<br>TXD<br>EIRQ[21]             | SIUL<br>DSPI_0<br>eTimer_1<br>LIN_1<br>SIUL      | I/O<br>O<br>I/O<br>O<br>I      | Slow                   | Medium  | 10      | 16      |
| C[4]     | PCR[36]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[36]<br>CS0<br>X[1]<br>DEBUG[4]<br>EIRQ[22]          | SIUL<br>DSPI_0<br>FlexPWM_0<br>SSCM<br>SIUL      | I/O<br>I/O<br>I/O<br>—<br>I    | Slow                   | Medium  | 5       | 11      |
| C[5]     | PCR[37]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[37]<br>SCK<br>—<br>DEBUG[5]<br>FAULT[3]<br>EIRQ[23] | SIUL<br>DSPI_0<br>—<br>SSCM<br>FlexPWM_0<br>SIUL | I/O<br>I/O<br>—<br>—<br>I<br>I | Slow                   | Medium  | 7       | 13      |
| C[6]     | PCR[38]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[38]<br>SOUT<br>B[1]<br>DEBUG[6]<br>EIRQ[24]         | SIUL<br>DSPI_0<br>FlexPWM_0<br>SSCM<br>SIUL      | I/O<br>I/O<br>O<br>—<br>I      | Slow                   | Medium  | 98      | 142     |
| C[7]     | PCR[39]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[39]<br>—<br>A[1]<br>DEBUG[7]<br>SIN                 | SIUL<br>—<br>FlexPWM_0<br>SSCM<br>DSPI_0         | I/O<br>—<br>O<br>—<br>I        | Slow                   | Medium  | 9       | 15      |
| C[8]     | PCR[40]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[40]<br>CS1<br>—<br>CS6<br>FAULT[2]                  | SIUL<br>DSPI_1<br>—<br>DSPI_0<br>FlexPWM_0       | I/O<br>O<br>—<br>O<br>I        | Slow                   | Medium  | 91      | 130     |
| C[9]     | PCR[41]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[41]<br>CS3<br>—<br>X[3]<br>FAULT[2]                 | SIUL<br>DSPI_2<br>—<br>FlexPWM_0<br>FlexPWM_0    | I/O<br>O<br>—<br>I/O<br>I      | Slow                   | Medium  | 84      | 123     |
| C[10]    | PCR[42]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[42]<br>CS2<br>—<br>A[3]<br>FAULT[1]                 | SIUL<br>DSPI_2<br>—<br>FlexPWM_0<br>FlexPWM_0    | I/O<br>O<br>—<br>O<br>I        | Slow                   | Medium  | 78      | 111     |

**Table 5. Pin muxing (continued)**

| Port pin        | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>      | Functions  | Peripheral <sup>3</sup>  | I/O direction <sup>4</sup>     | Pad speed <sup>5</sup> |           | Pin No. |         |
|-----------------|----------------------------------|--|--|--|--------------------------------|------------------------|-----------|---------|---------|
|                 |                                  |  |  |  |                                | SRC = 0                | SRC = 1   | 100-pin | 144-pin |
| C[11]           | PCR[43]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[43]<br>ETC[4]<br>CS2<br>CS0                             | SIUL<br>eTimer_0<br>DSPI_2<br>DSPI_3                             | I/O<br>I/O<br>O<br>I/O         | Slow                   | Medium    | 55      | 80      |
| C[12]           | PCR[44]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[44]<br>ETC[5]<br>CS3<br>CS1                             | SIUL<br>eTimer_0<br>DSPI_2<br>DSPI_3                             | I/O<br>I/O<br>O<br>O           | Slow                   | Medium    | 56      | 82      |
| C[13]           | PCR[45]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[45]<br>ETC[1]<br>—<br>—<br>EXT_IN<br>EXT_SYNC           | SIUL<br>eTimer_1<br>—<br>—<br>CTU_0<br>FlexPWM_0                 | I/O<br>I/O<br>—<br>—<br>I<br>I | Slow                   | Medium    | 71      | 101     |
| C[14]           | PCR[46]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[46]<br>ETC[2]<br>EXT_TGR<br>—                           | SIUL<br>eTimer_1<br>CTU_0<br>—                                   | I/O<br>I/O<br>O<br>—           | Slow                   | Medium    | 72      | 103     |
| C[15]           | PCR[47]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[47]<br>CA_TR_EN<br>ETC[0]<br>A[1]<br>EXT_IN<br>EXT_SYNC | SIUL<br>FlexRay_0<br>eTimer_1<br>FlexPWM_0<br>CTU_0<br>FlexPWM_0 | I/O<br>O<br>I/O<br>O<br>I<br>I | Slow                   | Symmetric | 85      | 124     |
| Port D (16-bit) |                                  |  |  |  |                                |                        |           |         |         |
| D[0]            | PCR[48]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[48]<br>CA_TX<br>ETC[1]<br>B[1]                          | SIUL<br>FlexRay_0<br>eTimer_1<br>FlexPWM_0                       | I/O<br>O<br>I/O<br>O           | Slow                   | Symmetric | 86      | 125     |
| D[1]            | PCR[49]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[49]<br>—<br>ETC[2]<br>EXT_TRG<br>CA_RX                  | SIUL<br>—<br>eTimer_1<br>CTU_0<br>FlexRay_0                      | I/O<br>—<br>I/O<br>O<br>I      | Slow                   | Medium    | 3       | 3       |
| D[2]            | PCR[50]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[50]<br>—<br>ETC[3]<br>X[3]<br>CB_RX                     | SIUL<br>—<br>eTimer_1<br>FlexPWM_0<br>FlexRay_0                  | I/O<br>—<br>I/O<br>I/O<br>I    | Slow                   | Medium    | 97      | 140     |
| D[3]            | PCR[51]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[51]<br>CB_TX<br>ETC[4]<br>A[3]                          | SIUL<br>FlexRay_0<br>eTimer_1<br>FlexPWM_0                       | I/O<br>O<br>I/O<br>O           | Slow                   | Symmetric | 89      | 128     |

**Table 5. Pin muxing (continued)**

| Port pin | Pad configuration register (PCR) | Alternate function <sup>1,2</sup> | Functions                               | Peripheral <sup>3</sup>                     | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |           | Pin No. |         |
|----------|----------------------------------|-----------------------------------|---|---|----------------------------|------------------------|-----------|---------|---------|
|          |                                  |                                   |   |   |                            | SRC = 0                | SRC = 1   | 100-pin | 144-pin |
| D[4]     | PCR[52]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[52]<br>CB_TR_EN<br>ETC[5]<br>B[3]  | SIUL<br>FlexRay_0<br>eTimer_1<br>FlexPWM_0  | I/O<br>O<br>I/O<br>O       | Slow                   | Symmetric | 90      | 129     |
| D[5]     | PCR[53]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[53]<br>CS3<br>F[0]<br>SOUT         | SIUL<br>DSPI_0<br>FCU_0<br>DSPI_3           | I/O<br>O<br>O<br>O         | Slow                   | Medium    | 22      | 33      |
| D[6]     | PCR[54]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[54]<br>CS2<br>SCK<br>—<br>FAULT[1] | SIUL<br>DSPI_0<br>DSPI_3<br>—<br>FlexPWM_0  | I/O<br>O<br>I/O<br>—<br>I  | Slow                   | Medium    | 23      | 34      |
| D[7]     | PCR[55]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[55]<br>CS3<br>F[1]<br>CS4<br>SIN   | SIUL<br>DSPI_1<br>FCU_0<br>DSPI_0<br>DSPI_3 | I/O<br>O<br>O<br>O<br>I    | Slow                   | Medium    | 26      | 37      |
| D[8]     | PCR[56]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[56]<br>CS2<br>—<br>CS5<br>FAULT[3] | SIUL<br>DSPI_1<br>—<br>DSPI_0<br>FlexPWM_0  | I/O<br>O<br>—<br>O<br>I    | Slow                   | Medium    | 21      | 32      |
| D[9]     | PCR[57]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[57]<br>X[0]<br>TXD<br>—            | SIUL<br>FlexPWM_0<br>LIN_1<br>—             | I/O<br>I/O<br>O<br>—       | Slow                   | Medium    | 15      | 26      |
| D[10]    | PCR[58]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[58]<br>A[0]<br>CS0<br>—            | SIUL<br>FlexPWM_0<br>DSPI_3<br>—            | I/O<br>O<br>I/O<br>—       | Slow                   | Medium    | 53      | 76      |
| D[11]    | PCR[59]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[59]<br>B[0]<br>CS1<br>SCK          | SIUL<br>FlexPWM_0<br>DSPI_3<br>DSPI_3       | I/O<br>O<br>O<br>I/O       | Slow                   | Medium    | 54      | 78      |
| D[12]    | PCR[60]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[60]<br>X[1]<br>—<br>—<br>RXD       | SIUL<br>FlexPWM_0<br>—<br>—<br>LIN_1        | I/O<br>I/O<br>—<br>—<br>I  | Slow                   | Medium    | 70      | 99      |
| D[13]    | PCR[61]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[61]<br>A[1]<br>CS2<br>SOUT         | SIUL<br>FlexPWM_0<br>DSPI_3<br>DSPI_3       | I/O<br>O<br>O<br>O         | Slow                   | Medium    | 67      | 95      |

**Table 5. Pin muxing (continued)**

| Port pin       | Pad configuration register (PCR) | Alternate function <sup>1,2</sup> | Functions                           | Peripheral <sup>3</sup>                    | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |         | Pin No. |         |
|----------------|----------------------------------|-----------------------------------|-------------------------------------|--|----------------------------|------------------------|---------|---------|---------|
|                |                                  |                                   |                                     |  |                            | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| D[14]          | PCR[62]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[62]<br>B[1]<br>CS3<br>—<br>SIN | SIUL<br>FlexPWM_0<br>DSPI_3<br>—<br>DSPI_3 | I/O<br>O<br>O<br>—<br>I    | Slow                   | Medium  | 73      | 105     |
| D[15]          | PCR[63]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[63]<br>—<br>—<br>—<br>AN[4]    | SIUL<br>—<br>—<br>—<br>ADC_1               | Input only                 | —                      | —       | 41      | 58      |
| Port E(16-bit) |                                  |                                   |                                     |  |                            |                        |         |         |         |
| E[0]           | PCR[64]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[64]<br>—<br>—<br>—<br>AN[5]    | SIUL<br>—<br>—<br>—<br>ADC_1               | Input only                 | —                      | —       | 46      | 68      |
| E[1]           | PCR[65]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[65]<br>—<br>—<br>—<br>AN[4]    | SIUL<br>—<br>—<br>—<br>ADC_0               | Input only                 | —                      | —       | 27      | 39      |
| E[2]           | PCR[66]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[66]<br>—<br>—<br>—<br>AN[5]    | SIUL<br>—<br>—<br>—<br>ADC_0               | Input only                 | —                      | —       | 32      | 49      |
| E[3]           | PCR[67]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[67]<br>—<br>—<br>—<br>AN[6]    | SIUL<br>—<br>—<br>—<br>ADC_0               | Input only                 | —                      | —       | —       | 40      |
| E[4]           | PCR[68]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[68]<br>—<br>—<br>—<br>AN[7]    | SIUL<br>—<br>—<br>—<br>ADC_0               | Input only                 | —                      | —       | —       | 42      |
| E[5]           | PCR[69]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[69]<br>—<br>—<br>—<br>AN[8]    | SIUL<br>—<br>—<br>—<br>ADC_0               | Input only                 | —                      | —       | —       | 44      |

**Table 5. Pin muxing (continued)**

| Port pin | Pad configuration register (PCR) | Alternate function <sup>1,2</sup> | Functions                              | Peripheral <sup>3</sup>          | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |         | Pin No. |         |
|----------|----------------------------------|-----------------------------------|--|----------------------------------|----------------------------|------------------------|---------|---------|---------|
|          |                                  |                                   |  |                                  |                            | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| E[6]     | PCR[70]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[70]<br>—<br>—<br>—<br>AN[9]       | SIUL<br>—<br>—<br>—<br>ADC_0     | Input only                 | —                      | —       | —       | 46      |
| E[7]     | PCR[71]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[71]<br>—<br>—<br>—<br>AN[10]      | SIUL<br>—<br>—<br>—<br>ADC_0     | Input only                 | —                      | —       | —       | 48      |
| E[8]     | PCR[72]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[72]<br>—<br>—<br>—<br>AN[6]       | SIUL<br>—<br>—<br>—<br>ADC_1     | Input only                 | —                      | —       | —       | 59      |
| E[9]     | PCR[73]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[73]<br>—<br>—<br>—<br>AN[7]       | SIUL<br>—<br>—<br>—<br>ADC_1     | Input only                 | —                      | —       | —       | 61      |
| E[10]    | PCR[74]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[74]<br>—<br>—<br>—<br>AN[8]       | SIUL<br>—<br>—<br>—<br>ADC_1     | Input only                 | —                      | —       | —       | 63      |
| E[11]    | PCR[75]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[75]<br>—<br>—<br>—<br>AN[9]       | SIUL<br>—<br>—<br>—<br>ADC_1     | Input only                 | —                      | —       | —       | 65      |
| E[12]    | PCR[76]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[76]<br>—<br>—<br>—<br>AN[10]      | SIUL<br>—<br>—<br>—<br>ADC_1     | Input only                 | —                      | —       | —       | 67      |
| E[13]    | PCR[77]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[77]<br>SCK<br>—<br>—<br>EIRQ[25]  | SIUL<br>DSPI_3<br>—<br>—<br>SIUL | I/O<br>I/O<br>—<br>—<br>I  | Slow                   | Medium  | —       | 117     |
| E[14]    | PCR[78]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[78]<br>SOUT<br>—<br>—<br>EIRQ[26] | SIUL<br>DSPI_3<br>—<br>—<br>SIUL | I/O<br>O<br>—<br>—<br>I    | Slow                   | Medium  | —       | 119     |

**Table 5. Pin muxing (continued)**

| Port pin        | Pad configuration register (PCR) | Alternate function <sup>1,2</sup>      | Functions                                  | Peripheral <sup>3</sup>                  | I/O direction <sup>4</sup>   | Pad speed <sup>5</sup> |         | Pin No. |         |
|-----------------|----------------------------------|--|--|--|------------------------------|------------------------|---------|---------|---------|
|                 |                                  |  |  |  |                              | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| E[15]           | PCR[79]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—<br>— | GPIO[79]<br>—<br>—<br>—<br>SIN<br>EIRQ[27] | SIUL<br>—<br>—<br>—<br>DSPI_3<br>SIUL    | I/O<br>—<br>—<br>—<br>I<br>I | Slow                   | Medium  | —       | 121     |
| Port F (16-bit) |                                  |  |  |  |                              |                        |         |         |         |
| F[0]            | PCR[80]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[80]<br>DBG0<br>CS3<br>—<br>EIRQ[28]   | SIUL<br>FlexRay_0<br>DSPI_3<br>—<br>SIUL | I/O<br>O<br>O<br>—<br>I      | Slow                   | Medium  | —       | 133     |
| F[1]            | PCR[81]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>—      | GPIO[81]<br>DBG1<br>CS2<br>—<br>EIRQ[29]   | SIUL<br>FlexRay_0<br>DSPI_3<br>—<br>SIUL | I/O<br>O<br>O<br>—<br>I      | Slow                   | Medium  | —       | 135     |
| F[2]            | PCR[82]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[82]<br>DBG2<br>CS1<br>—               | SIUL<br>FlexRay_0<br>DSPI_3<br>—         | I/O<br>O<br>O<br>—           | Slow                   | Medium  | —       | 137     |
| F[3]            | PCR[83]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[83]<br>DBG3<br>CS0<br>—               | SIUL<br>FlexRay_0<br>DSPI_3<br>—         | I/O<br>O<br>I/O<br>—         | Slow                   | Medium  | —       | 139     |
| F[4]            | PCR[84]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[84]<br>MDO[3]<br>—<br>—               | SIUL<br>NEXUS_0<br>—<br>—                | I/O<br>O<br>—<br>—           | Slow                   | Fast    | —       | 4       |
| F[5]            | PCR[85]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[85]<br>MDO[2]<br>—<br>—               | SIUL<br>NEXUS_0<br>—<br>—                | I/O<br>O<br>—<br>—           | Slow                   | Fast    | —       | 5       |
| F[6]            | PCR[86]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[86]<br>MDO[1]<br>—<br>—               | SIUL<br>NEXUS_0<br>—<br>—                | I/O<br>O<br>—<br>—           | Slow                   | Fast    | —       | 8       |
| F[7]            | PCR[87]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[87]<br>MCKO<br>—<br>—                 | SIUL<br>NEXUS_0<br>—<br>—                | I/O<br>O<br>—<br>—           | Slow                   | Fast    | —       | 19      |
| F[8]            | PCR[88]                          | ALT0<br>ALT1<br>ALT2<br>ALT3           | GPIO[88]<br>MSEO1<br>—<br>—                | SIUL<br>NEXUS_0<br>—<br>—                | I/O<br>O<br>—<br>—           | Slow                   | Fast    | —       | 20      |

**Table 5. Pin muxing (continued)**

| Port pin        | Pad configuration register (PCR) | Alternate function <sup>1,2</sup> | Functions                              | Peripheral <sup>3</sup>         | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |         | Pin No. |         |
|-----------------|----------------------------------|-----------------------------------|--|---------------------------------|----------------------------|------------------------|---------|---------|---------|
|                 |                                  |                                   |  |                                 |                            | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| F[9]            | PCR[89]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[89]<br>MSEO0<br>—<br>—            | SIUL<br>NEXUS_0<br>—<br>—       | I/O<br>O<br>—<br>—         | Slow                   | Fast    | —       | 23      |
| F[10]           | PCR[90]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[90]<br>EVTO<br>—<br>—             | SIUL<br>NEXUS_0<br>—<br>—       | I/O<br>O<br>—<br>—         | Slow                   | Fast    | —       | 24      |
| F[11]           | PCR[91]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[91]<br>—<br>—<br>—<br>EVTI        | SIUL<br>—<br>—<br>—<br>NEXUS_0  | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 25      |
| F[12]           | PCR[92]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[92]<br>ETC[3]<br>—<br>—           | SIUL<br>eTimer_1<br>—<br>—      | I/O<br>I/O<br>—<br>—       | Slow                   | Medium  | —       | 106     |
| F[13]           | PCR[93]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[92]<br>ETC[4]<br>—<br>—           | SIUL<br>eTimer_1<br>—<br>—      | I/O<br>I/O<br>—<br>—       | Slow                   | Medium  | —       | 112     |
| F[14]           | PCR[94]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[94]<br>TXD<br>—<br>—              | SIUL<br>LIN_1<br>—<br>—         | I/O<br>O<br>—<br>—         | Slow                   | Medium  | —       | 115     |
| F[15]           | PCR[95]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[95]<br>—<br>—<br>—<br>RXD         | SIUL<br>—<br>—<br>—<br>LIN_1    | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 113     |
| Port G (12-bit) |                                  |                                   |  |                                 |                            |                        |         |         |         |
| G[0]            | PCR[96]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[96]<br>F[0]<br>—<br>—<br>EIRQ[30] | SIUL<br>FCU_0<br>—<br>—<br>SIUL | I/O<br>O<br>—<br>—<br>I    | Slow                   | Medium  | —       | 38      |
| G[1]            | PCR[97]                          | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[97]<br>F[1]<br>—<br>—<br>EIRQ[31] | SIUL<br>FCU_0<br>—<br>—<br>SIUL | I/O<br>O<br>—<br>—<br>I    | Slow                   | Medium  | —       | 141     |
| G[2]            | PCR[98]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[98]<br>X[2]<br>—<br>—             | SIUL<br>FlexPWM_0<br>—<br>—     | I/O<br>I/O<br>—<br>—       | Slow                   | Medium  | —       | 102     |

**Table 5. Pin muxing (continued)**

| Port pin | Pad configuration register (PCR) | Alternate function <sup>1,2</sup> | Functions                            | Peripheral <sup>3</sup>          | I/O direction <sup>4</sup> | Pad speed <sup>5</sup> |         | Pin No. |         |
|----------|----------------------------------|-----------------------------------|--------------------------------------|----------------------------------|----------------------------|------------------------|---------|---------|---------|
|          |                                  |                                   |                                      |                                  |                            | SRC = 0                | SRC = 1 | 100-pin | 144-pin |
| G[3]     | PCR[99]                          | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[99]<br>A[2]<br>—<br>—           | SIUL<br>FlexPWM_0<br>—<br>—      | I/O<br>O<br>—<br>—         | Slow                   | Medium  | —       | 104     |
| G[4]     | PCR[100]                         | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[100]<br>B[2]<br>—<br>—          | SIUL<br>FlexPWM_0<br>—<br>—      | I/O<br>O<br>—<br>—         | Slow                   | Medium  | —       | 100     |
| G[5]     | PCR[101]                         | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[101]<br>X[3]<br>—<br>—          | SIUL<br>FlexPWM_0<br>—<br>—      | I/O<br>I/O<br>—<br>—       | Slow                   | Medium  | —       | 85      |
| G[6]     | PCR[102]                         | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[102]<br>A[3]<br>—<br>—          | SIUL<br>FlexPWM_0<br>—<br>—      | I/O<br>O<br>—<br>—         | Slow                   | Medium  | —       | 98      |
| G[7]     | PCR[103]                         | ALT0<br>ALT1<br>ALT2<br>ALT3      | GPIO[103]<br>B[3]<br>—<br>—          | SIUL<br>FlexPWM_0<br>—<br>—      | I/O<br>O<br>—<br>—         | Slow                   | Medium  | —       | 83      |
| G[8]     | PCR[104]                         | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[104]<br>—<br>—<br>—<br>FAULT[0] | SIUL<br>—<br>—<br>—<br>FlexPWM_0 | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 81      |
| G[9]     | PCR[105]                         | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[105]<br>—<br>—<br>—<br>FAULT[1] | SIUL<br>—<br>—<br>—<br>FlexPWM_0 | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 79      |
| G[10]    | PCR[106]                         | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[106]<br>—<br>—<br>—<br>FAULT[2] | SIUL<br>—<br>—<br>—<br>FlexPWM_0 | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 77      |
| G[11]    | PCR[107]                         | ALT0<br>ALT1<br>ALT2<br>ALT3<br>— | GPIO[107]<br>—<br>—<br>—<br>FAULT[3] | SIUL<br>—<br>—<br>—<br>FlexPWM_0 | I/O<br>—<br>—<br>—<br>I    | Slow                   | Medium  | —       | 75      |

<sup>1</sup> ALT0 is the primary (default) function for each port after reset.

- 2 Alternate functions are chosen by setting the values of the PCR[PA] bitfields inside the SIU module. PCR[PA] = 00 → ALT0; PCR[PA] = 01 → ALT1; PCR[PA] = 10 → ALT2; PCR[PA] = 11 → ALT3. This is intended to select the output functions; to use one of the input-only functions, the PCR[IBE] bit must be written to '1', regardless of the values selected in the PCR[PA] bitfields. For this reason, the value corresponding to an input only function is reported as "—".
- 3 Module included on the MCU.
- 4 Multiple inputs are routed to all respective modules internally. The input of some modules must be configured by setting the values of the PSMI[PADESELx] bitfields inside the SIUL module.
- 5 Programmable via the SRC (Slew Rate Control) bits in the respective Pad Configuration Register.
- 6 Weak pull down during reset.

## 3 Electrical characteristics

### 3.1 Introduction

This section contains device electrical characteristics as well as temperature and power considerations.

This microcontroller contains input protection against damage due to high static voltages. However, it is advisable to take precautions to avoid application of any voltage higher than the specified maximum rated voltages.

To enhance reliability, unused inputs can be driven to an appropriate logic voltage level ( $V_{DD}$  or  $V_{SS}$ ). This can be done by the internal pull-up or pull-down resistors, which are provided by the device for most general purpose pins.

The following tables provide the device characteristics and its demands on the system.

In the tables where the device logic provides signals with their respective timing characteristics, the symbol “CC” for Controller Characteristics is included in the Symbol column.

In the tables where the external system must provide signals with their respective timing characteristics to the device, the symbol “SR” for System Requirement is included in the Symbol column.

#### CAUTION

All of the following parameter values can vary depending on the application and must be confirmed during silicon characterization or silicon reliability trial.

### 3.2 Parameter classification

The electrical parameters are guaranteed by various methods. To give the customer a better understanding, the classifications listed in [Table 6](#) are used and the parameters are tagged accordingly in the tables where appropriate.

**Table 6. Parameter classifications**

| Classification tag | Tag description  |
|--------------------|--|
| P                  | Those parameters are guaranteed during production testing on each individual device.   |
| C                  | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations.  |
| T                  | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D                  | Those parameters are derived mainly from simulations.  |

#### NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

### 3.3 Absolute maximum ratings

Table 7. Absolute maximum ratings<sup>1</sup>

| Symbol                          |    | Parameter  | Conditions                    | Value |   | Unit |
|---------------------------------|----|--|-------------------------------|-------|---|------|
|                                 |    |  |                               | Min   | Max <sup>2</sup>                        |      |
| $V_{SS}$                        | SR | Device ground  | —                             | 0     | 0                                       | V    |
| $V_{DD\_HV\_IOx}$ <sup>3</sup>  | SR | 3.3 V / 5.0 V input/output supply voltage with respect to ground ( $V_{SS}$ )                          | —                             | -0.3  | 6.0                                     | V    |
| $V_{SS\_HV\_IOx}$               | SR | Input/output ground voltage with respect to ground ( $V_{SS}$ )  | —                             | -0.1  | 0.1                                     | V    |
| $V_{DD\_HV\_FL}$                | SR | 3.3 V / 5.0 V code and data flash supply voltage with respect to ground ( $V_{SS}$ )                   | —                             | -0.3  | 6.0                                     | V    |
|                                 |    |  | Relative to $V_{DD\_HV\_IOx}$ |       |   |      |
| $V_{SS\_HV\_FL}$                | SR | Code and data flash ground with respect to ground ( $V_{SS}$ )   | —                             | -0.1  | 0.1                                     | V    |
| $V_{DD\_HV\_OSC}$               | SR | 3.3 V / 5.0 V crystal oscillator amplifier supply voltage with respect to ground ( $V_{SS}$ )          | —                             | -0.3  | 6.0                                     | V    |
|                                 |    |  | Relative to $V_{DD\_HV\_IOx}$ |       |   |      |
| $V_{SS\_HV\_OSC}$               | SR | 3.3 V / 5.0 V crystal oscillator amplifier reference voltage with respect to ground ( $V_{SS}$ )       | —                             | -0.1  | 0.1                                     | V    |
| $V_{DD\_HV\_REG}$               | SR | 3.3 V / 5.0 V voltage regulator supply voltage with respect to ground ( $V_{SS}$ )                     | —                             | -0.3  | 6.0                                     | V    |
|                                 |    |  | Relative to $V_{DD\_HV\_IOx}$ |       |   |      |
| $V_{DD\_HV\_ADC0}$ <sup>4</sup> | SR | 3.3 V / 5.0 V ADC_0 supply and high reference voltage with respect to ground ( $V_{SS}$ )              | $V_{DD\_HV\_REG} < 2.7V$      | -0.3  | $V_{DD\_HV\_REG} + 0.3$                 | V    |
|                                 |    |  | $V_{DD\_HV\_REG} > 2.7V$      |       | 6.0                                     |      |
| $V_{SS\_HV\_ADC0}$              | SR | ADC_0 ground and low reference voltage with respect to ground ( $V_{SS}$ )                             | —                             | -0.1  | 0.1                                     | V    |
| $V_{DD\_HV\_ADC1}$ <sup>4</sup> | SR | 3.3 V / 5.0 V ADC_0 supply and high reference voltage with respect to ground ( $V_{SS}$ )              | $V_{DD\_HV\_REG} < 2.7V$      | -0.3  | $V_{DD\_HV\_REG} + 0.3$                 | V    |
|                                 |    |  | $V_{DD\_HV\_REG} > 2.7V$      |       | 6.0                                     |      |
| $V_{SS\_HV\_ADC1}$              | SR | ADC_1 ground and low reference voltage with respect to ground ( $V_{SS}$ )                             | —                             | -0.1  | 0.1                                     | V    |
| $TV_{DD}$                       | SR | Slope characteristics on all $V_{DD}$ during power up <sup>5</sup> with respect to ground ( $V_{SS}$ ) | —                             | 3.0   | $500 \times 10^3$<br>(0.5 [V/ $\mu$ s]) | V/s  |
| $V_{IN}$                        | SR | Voltage on any pin with respect to ground ( $V_{SS\_HV\_IOx}$ ) with respect to ground ( $V_{SS}$ )    | —                             | -0.3  | 6.0                                     | V    |
|                                 |    |  | Relative to $V_{DD\_HV\_IOx}$ |       |   |      |

**Table 7. Absolute maximum ratings<sup>1</sup> (continued)**

| Symbol              | Parameter  | Conditions                    | Value                         |                               | Unit |
|---------------------|--|-------------------------------|-------------------------------|-------------------------------|------|
|                     |  |                               | Min                           | Max <sup>2</sup>              |      |
| V <sub>INAN0</sub>  | SR ADC0 and shared ADC0/1 analog input voltage <sup>6</sup>              | V <sub>DD_HV_REG</sub> > 2.7V | V <sub>SS_HV_ADV0</sub> - 0.3 | V <sub>DD_HV_ADV0</sub> + 0.3 | V    |
|                     |  | V <sub>DD_HV_REG</sub> < 2.7V | V <sub>SS_HV_ADV0</sub>       | V <sub>DD_HV_ADV0</sub>       | V    |
| V <sub>INAN1</sub>  | SR ADC1 analog input voltage <sup>7</sup>                                | V <sub>DD_HV_REG</sub> > 2.7V | V <sub>SS_HV_ADV1</sub> - 0.3 | V <sub>DD_HV_ADV1</sub> + 0.3 | V    |
|                     |  | V <sub>DD_HV_REG</sub> < 2.7V | V <sub>SS_HV_ADV1</sub>       | V <sub>DD_HV_ADV1</sub>       | V    |
| I <sub>INJPAD</sub> | SR Injected input current on any pin during overload condition           | —                             | -10                           | 10                            | mA   |
| I <sub>INJSUM</sub> | SR Absolute sum of all injected input currents during overload condition | —                             | -50                           | 50                            | mA   |
| I <sub>VDD_LV</sub> | SR Low voltage static current sink through V <sub>DD_LV</sub>            | —                             | —                             | 155                           | mA   |
| T <sub>STG</sub>    | SR Storage temperature   | —                             | -55                           | 150                           | °C   |
| T <sub>J</sub>      | SR Junction temperature under bias                                       | —                             | -40                           | 150                           | °C   |

<sup>1</sup> Functional operating conditions are given in the DC electrical characteristics. Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the listed maxima may affect device reliability or cause permanent damage to the device.

<sup>2</sup> Absolute maximum voltages are currently maximum burn-in voltages. Absolute maximum specifications for device stress have not yet been determined.

<sup>3</sup> The difference between each couple of voltage supplies must be less than 300 mV, |V<sub>DD\_HV\_IOy</sub> - V<sub>DD\_HV\_IOx</sub>| < 300 mV.

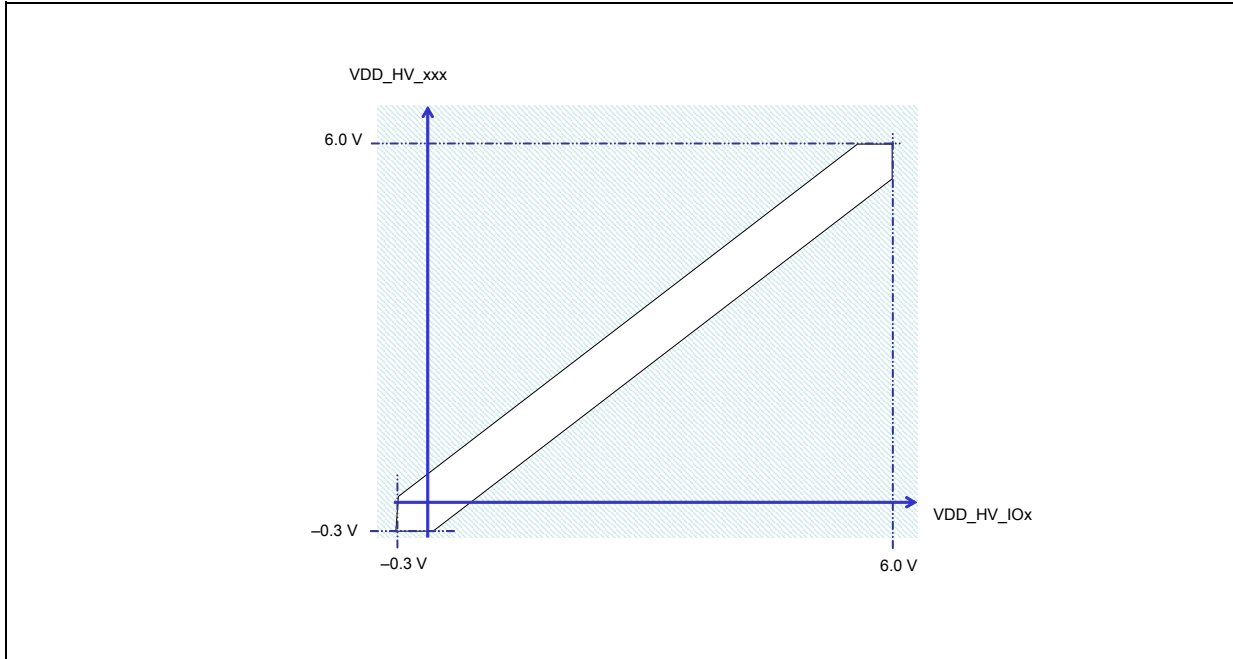
<sup>4</sup> The difference between ADC voltage supplies must be less than 100 mV, |V<sub>DD\_HV\_ADC1</sub> - V<sub>DD\_HV\_ADC0</sub>| < 100 mV.

<sup>5</sup> Guaranteed by device validation

<sup>6</sup> Not allowed to refer this voltage to V<sub>DD\_HV\_ADV1</sub>, V<sub>SS\_HV\_ADV1</sub>

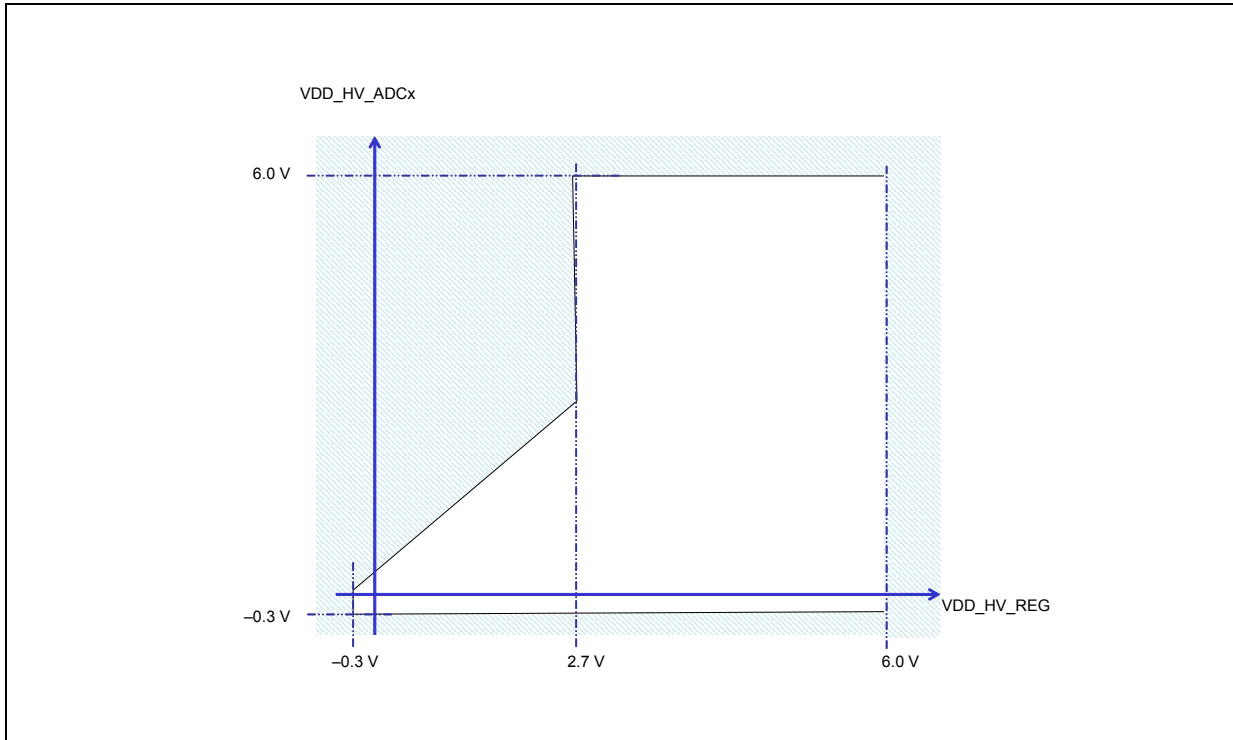
<sup>7</sup> Not allowed to refer this voltage to V<sub>DD\_HV\_ADV0</sub>, V<sub>SS\_HV\_ADV0</sub>

Figure 4 shows the constraints of the different power supplies.



**Figure 4. Power supplies constraints ( $-0.3\text{ V} \leq V_{DD\_HV\_IOx} \leq 6.0\text{ V}$ )**

The MPC5604P supply architecture allows of having ADC supply managed independently from standard  $V_{DD\_HV}$  supply. Figure 5 shows the constraints of the ADC power supply.



**Figure 5. Independent ADC supply ( $-0.3\text{ V} \leq V_{DD\_HV\_REG} \leq 6.0\text{ V}$ )**

### 3.4 Recommended operating conditions

Table 8. Recommended operating conditions (5.0 V)

| Symbol                              |    | Parameter  | Conditions                    | Value                   |                         | Unit |
|-------------------------------------|----|--|-------------------------------|-------------------------|-------------------------|------|
|                                     |    |  |                               | Min                     | Max <sup>1</sup>        |      |
| $V_{SS}$                            | SR | Device ground  | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_IOx}$ <sup>2</sup>      | SR | 5.0 V input/output supply voltage                    | —                             | 4.5                     | 5.5                     | V    |
| $V_{SS\_HV\_IOx}$                   | SR | Input/output ground voltage                          | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_FL}$                    | SR | 5.0 V code and data flash supply voltage             | —                             | 4.5                     | 5.5                     | V    |
|                                     |    |  | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{SS\_HV\_FL}$                    | SR | Code and data flash ground                           | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_OSC}$                   | SR | 5.0 V crystal oscillator amplifier supply voltage    | —                             | 4.5                     | 5.5                     | V    |
|                                     |    |  | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{SS\_HV\_OSC}$                   | SR | 5.0 V crystal oscillator amplifier reference voltage | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_REG}$                   | SR | 5.0 V voltage regulator supply voltage               | —                             | 4.5                     | 5.5                     | V    |
|                                     |    |  | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{DD\_HV\_ADC0}$ <sup>3</sup>     | SR | 5.0 V ADC_0 supply and high reference voltage        | —                             | 4.5                     | 5.5                     | V    |
|                                     |    |  | Relative to $V_{DD\_HV\_REG}$ | $V_{DD\_HV\_REG} - 0.1$ | —                       |      |
| $V_{SS\_HV\_ADC0}$                  | SR | ADC_0 ground and low reference voltage               | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_ADC1}$ <sup>3</sup>     | SR | 5.0 V ADC_1 supply and high reference voltage        | —                             | 4.5                     | 5.5                     | V    |
|                                     |    |  | Relative to $V_{DD\_HV\_REG}$ | $V_{DD\_HV\_REG} - 0.1$ | —                       |      |
| $V_{SS\_HV\_ADC1}$                  | SR | ADC_1 ground and low reference voltage               | —                             | 0                       | 0                       | V    |
| $V_{DD\_LV\_REGCOR}$ <sup>4,5</sup> | CC | Internal supply voltage                              | —                             | —                       | —                       | V    |
| $V_{SS\_LV\_REGCOR}$ <sup>4</sup>   | SR | Internal reference voltage                           | —                             | 0                       | 0                       | V    |
| $V_{DD\_LV\_CORx}$ <sup>4,5</sup>   | CC | Internal supply voltage                              | —                             | —                       | —                       | V    |
| $V_{SS\_LV\_CORx}$ <sup>4</sup>     | SR | Internal reference voltage                           | —                             | 0                       | 0                       | V    |
| $T_A$                               | SR | Ambient temperature under bias                       | —                             | -40                     | 125                     | °C   |

<sup>1</sup> Parametric figures can be out of specification when voltage drops below 4.5 V, however, guaranteeing the full functionality. In particular, ADC electrical characteristics and I/Os DC electrical specification may not be guaranteed.

<sup>2</sup> The difference between each couple of voltage supplies must be less than 100 mV,  $|V_{DD\_HV\_IOy} - V_{DD\_HV\_IOx}| < 100$  mV.

<sup>3</sup> The difference between ADC voltage supplies must be less than 100 mV,  $|V_{DD\_HV\_ADC1} - V_{DD\_HV\_ADC0}| < 100$  mV.

- 4 To be connected to emitter of external NPN. Low voltage supplies are not under user control—they are produced by an on-chip voltage regulator—but for the device to function properly the low voltage grounds ( $V_{SS\_LV\_xxx}$ ) must be shorted to high voltage grounds ( $V_{SS\_HV\_xxx}$ ) and the low voltage supply pins ( $V_{DD\_LV\_xxx}$ ) must be connected to the external ballast emitter.
- 5 The low voltage supplies ( $V_{DD\_LV\_xxx}$ ) are not all independent.  
 $V_{DD\_LV\_COR1}$  and  $V_{DD\_LV\_COR2}$  are shorted internally via double bonding connections with lines that provide the low voltage supply to the data flash module. Similarly,  $V_{SS\_LV\_COR1}$  and  $V_{SS\_LV\_COR2}$  are internally shorted.  
 $V_{DD\_LV\_REGCOR}$  and  $V_{DD\_LV\_REGCORx}$  are physically shorted internally, as are  $V_{SS\_LV\_REGCOR}$  and  $V_{SS\_LV\_CORx}$ .

**Table 9. Recommended operating conditions (3.3 V)**

| Symbol                              | Parameter   | Conditions                    | Value                   |                         | Unit |
|-------------------------------------|---|-------------------------------|-------------------------|-------------------------|------|
|                                     |   |                               | Min                     | Max <sup>1</sup>        |      |
| $V_{SS}$                            | SR Device ground  | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_IOx}$ <sup>2</sup>      | SR 3.3 V input/output supply voltage                    | —                             | 3.0                     | 3.6                     | V    |
| $V_{SS\_HV\_IOx}$                   | SR Input/output ground voltage                          | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_FL}$                    | SR 3.3 V code and data flash supply voltage             | —                             | 3.0                     | 3.6                     | V    |
|                                     |   | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{SS\_HV\_FL}$                    | SR Code and data flash ground                           | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_OSC}$                   | SR 3.3 V crystal oscillator amplifier supply voltage    | —                             | 3.0                     | 3.6                     | V    |
|                                     |   | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{SS\_HV\_OSC}$                   | SR 3.3 V crystal oscillator amplifier reference voltage | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_REG}$                   | SR 3.3 V voltage regulator supply voltage               | —                             | 3.0                     | 3.6                     | V    |
|                                     |   | Relative to $V_{DD\_HV\_IOx}$ | $V_{DD\_HV\_IOx} - 0.1$ | $V_{DD\_HV\_IOx} + 0.1$ |      |
| $V_{DD\_HV\_ADC0}$ <sup>3</sup>     | SR 3.3 V ADC_0 supply and high reference voltage        | —                             | 3.0                     | 5.5                     | V    |
|                                     |   | Relative to $V_{DD\_HV\_REG}$ | $V_{DD\_HV\_REG} - 0.1$ | 5.5                     |      |
| $V_{SS\_HV\_ADC0}$                  | SR ADC_0 ground and low reference voltage               | —                             | 0                       | 0                       | V    |
| $V_{DD\_HV\_ADC1}$ <sup>3</sup>     | SR 3.3 V ADC_1 supply and high reference voltage        | —                             | 3.0                     | 5.5                     | V    |
|                                     |   | Relative to $V_{DD\_HV\_REG}$ | $V_{DD\_HV\_REG} - 0.1$ | 5.5                     |      |
| $V_{SS\_HV\_ADC1}$                  | SR ADC_1 ground and low reference voltage               | —                             | 0                       | 0                       | V    |
| $V_{DD\_LV\_REGCOR}$ <sup>4,5</sup> | CC Internal supply voltage                              | —                             | —                       | —                       | V    |

**Table 9. Recommended operating conditions (3.3 V) (continued)**

| Symbol                   | Parameter | Conditions                     | Value |                  | Unit |    |
|--------------------------|-----------|--------------------------------|-------|------------------|------|----|
|                          |           |                                | Min   | Max <sup>1</sup> |      |    |
| $V_{SS\_LV\_REGCOR}^4$   | SR        | Internal reference voltage     | —     | 0                | V    |    |
| $V_{DD\_LV\_CORx}^{4,5}$ | CC        | Internal supply voltage        | —     | —                | V    |    |
| $V_{SS\_LV\_CORx}^4$     | SR        | Internal reference voltage     | —     | 0                | V    |    |
| $T_A$                    | SR        | Ambient temperature under bias | —     | -40              | 125  | °C |

<sup>1</sup> Parametric figures can be out of specification when voltage drops below 4.5 V, however, guaranteeing the full functionality. In particular, ADC electrical characteristics and I/Os DC electrical specification may not be guaranteed.

<sup>2</sup> The difference between each couple of voltage supplies must be less than 100 mV,  $|V_{DD\_HV\_IOy} - V_{DD\_HV\_IOx}| < 100$  mV.

<sup>3</sup> The difference between each couple of voltage supplies must be less than 100 mV,  $|V_{DD\_HV\_ADC1} - V_{DD\_HV\_ADC0}| < 100$  mV. As long as that condition is met, ADC\_0 and ADC\_1 can be operated at 5 V with the rest of the device operating at 3.3 V.

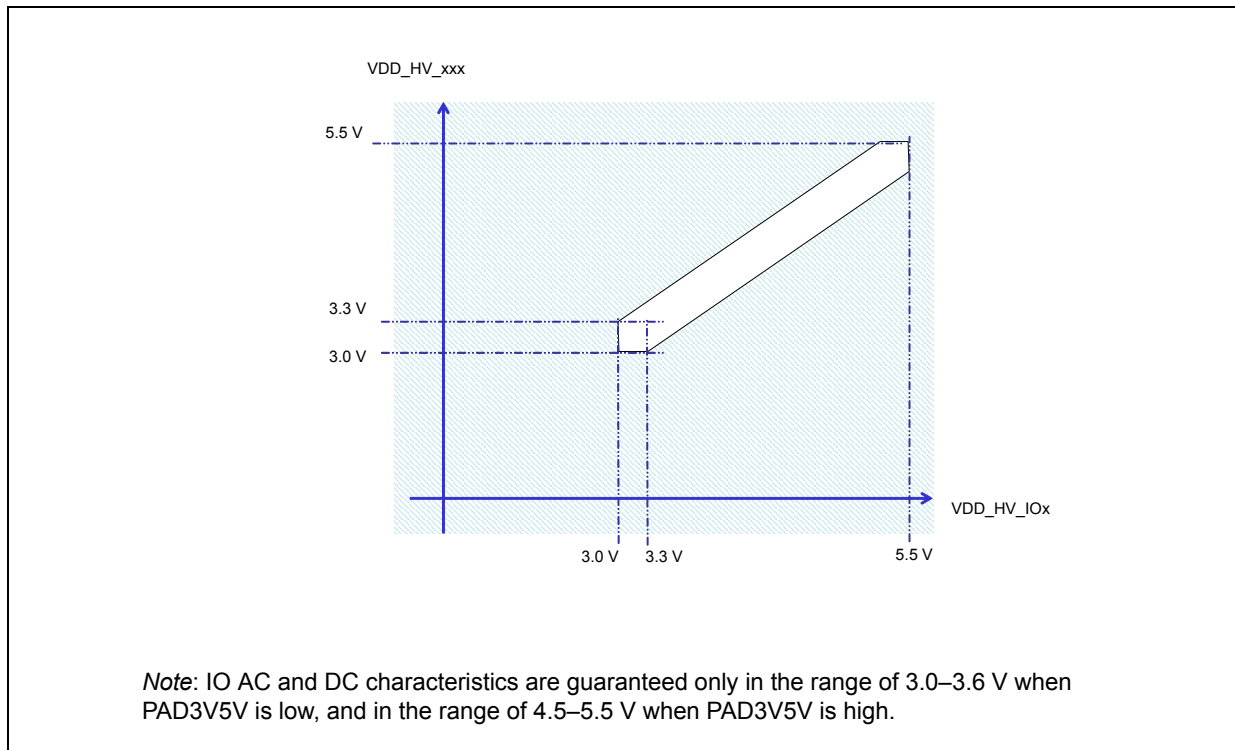
<sup>4</sup> To be connected to emitter of external NPN. Low voltage supplies are not under user control—they are produced by an on-chip voltage regulator—but for the device to function properly the low voltage grounds ( $V_{SS\_LV\_xxx}$ ) must be shorted to high voltage grounds ( $V_{SS\_HV\_xxx}$ ) and the low voltage supply pins ( $V_{DD\_LV\_xxx}$ ) must be connected to the external ballast emitter.

<sup>5</sup> The low voltage supplies ( $V_{DD\_LV\_xxx}$ ) are not all independent.

$V_{DD\_LV\_COR1}$  and  $V_{DD\_LV\_COR2}$  are shorted internally via double bonding connections with lines that provide the low voltage supply to the data flash module. Similarly,  $V_{SS\_LV\_COR1}$  and  $V_{SS\_LV\_COR2}$  are internally shorted.

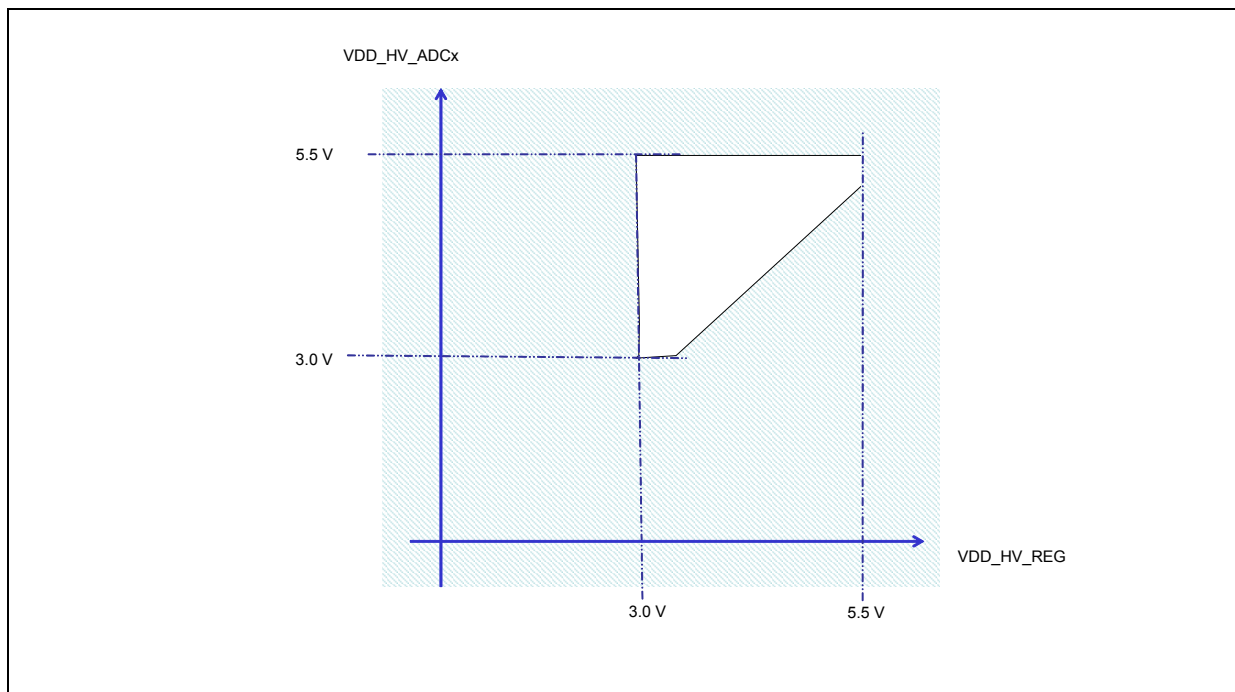
$V_{DD\_LV\_REGCOR}$  and  $V_{DD\_LV\_REGCORx}$  are physically shorted internally, as are  $V_{SS\_LV\_REGCOR}$  and  $V_{SS\_LV\_CORx}$ .

Figure 6 shows the constraints of the different power supplies.



**Figure 6. Power supplies constraints ( $3.0\text{ V} \leq V_{DD\_HV\_IOx} \leq 5.5\text{ V}$ )**

The MPC5604P supply architecture allows the ADC supply to be managed independently from the standard  $V_{DD\_HV}$  supply. Figure 7 shows the constraints of the ADC power supply.



**Figure 7. Independent ADC supply ( $3.0\text{ V} \leq V_{DD\_HV\_REG} \leq 5.5\text{ V}$ )**

## 3.5 Thermal characteristics

### 3.5.1 Package thermal characteristics

**Table 10. Thermal characteristics for 144-pin LQFP**

| Symbol             | Parameter   | Conditions            | Typical value | Unit |
|--------------------|---|-----------------------|---------------|------|
| $R_{\theta JA}$    | Thermal resistance junction-to-ambient, natural convection <sup>1</sup> | Single layer board—1s | 54.2          | °C/W |
|                    |   | Four layer board—2s2p | 44.4          | °C/W |
| $R_{\theta JB}$    | Thermal resistance junction-to-board <sup>2</sup>                       | Four layer board—2s2p | 29.9          | °C/W |
| $R_{\theta JCtop}$ | Thermal resistance junction-to-case (top) <sup>3</sup>                  | Single layer board—1s | 9.3           | °C/W |
| $\Psi_{JB}$        | Junction-to-board, natural convection <sup>4</sup>                      | Operating conditions  | 30.2          | °C/W |
| $\Psi_{JC}$        | Junction-to-case, natural convection <sup>5</sup>                       | Operating conditions  | 0.8           | °C/W |

<sup>1</sup> Junction-to-ambient thermal resistance determined per JEDEC JESD51-7. Thermal test board meets JEDEC specification for this package.

<sup>2</sup> Junction-to-board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

<sup>3</sup> Junction-to-case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

<sup>4</sup> Thermal characterization parameter indicating the temperature difference between the board and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JB.

<sup>5</sup> Thermal characterization parameter indicating the temperature difference between the case and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JC.

**Table 11. Thermal characteristics for 100-pin LQFP**

| Symbol             | Parameter   | Conditions            | Typical value | Unit |
|--------------------|---|-----------------------|---------------|------|
| $R_{\theta JA}$    | Thermal resistance junction-to-ambient, natural convection <sup>1</sup> | Single layer board—1s | 47.3          | °C/W |
|                    |   | Four layer board—2s2p | 35.3          | °C/W |
| $R_{\theta JB}$    | Thermal resistance junction-to-board <sup>2</sup>                       | Four layer board—2s2p | 19.1          | °C/W |
| $R_{\theta JCtop}$ | Thermal resistance junction-to-case (top) <sup>3</sup>                  | Single layer board—1s | 9.7           | °C/W |
| $\Psi_{JB}$        | Junction-to-board, natural convection <sup>4</sup>                      | Operating conditions  | 19.1          | °C/W |
| $\Psi_{JC}$        | Junction-to-case, natural convection <sup>5</sup>                       | Operating conditions  | 0.8           | °C/W |

<sup>1</sup> Junction-to-ambient thermal resistance determined per JEDEC JESD51-7. Thermal test board meets JEDEC specification for this package.

<sup>2</sup> Junction-to-board thermal resistance determined per JEDEC JESD51-8. Thermal test board meets JEDEC specification for the specified package.

<sup>3</sup> Junction-to-case at the top of the package determined using MIL-STD 883 Method 1012.1. The cold plate temperature is used for the case temperature. Reported value includes the thermal resistance of the interface layer.

<sup>4</sup> Thermal characterization parameter indicating the temperature difference between the board and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JB.

- <sup>5</sup> Thermal characterization parameter indicating the temperature difference between the case and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JC.

### 3.5.2 General notes for specifications at maximum junction temperature

An estimation of the chip junction temperature,  $T_J$ , can be obtained from [Equation 1](#):

$$T_J = T_A + (R_{\theta JA} * P_D) \quad \text{Eqn. 1}$$

where:

- $T_A$  = ambient temperature for the package (°C)
- $R_{\theta JA}$  = junction to ambient thermal resistance (°C/W)
- $P_D$  = power dissipation in the package (W)

The junction to ambient thermal resistance is an industry standard value that provides a quick and easy estimation of thermal performance. Unfortunately, there are two values in common usage: the value determined on a single layer board and the value obtained on a board with two planes. For packages such as the PBGA, these values can be different by a factor of two. Which value is closer to the application depends on the power dissipated by other components on the board. The value obtained on a single layer board is appropriate for the tightly packed printed circuit board. The value obtained on the board with the internal planes is usually appropriate if the board has low power dissipation and the components are well separated.

When a heat sink is used, the thermal resistance is expressed in [Equation 2](#) as the sum of a junction to case thermal resistance and a case to ambient thermal resistance:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA} \quad \text{Eqn. 2}$$

where:

- $R_{\theta JA}$  = junction to ambient thermal resistance (°C/W)
- $R_{\theta JC}$  = junction to case thermal resistance (°C/W)
- $R_{\theta CA}$  = case to ambient thermal resistance (°C/W)

$R_{\theta JC}$  is device related and cannot be influenced by the user. The user controls the thermal environment to change the case to ambient thermal resistance,  $R_{\theta CA}$ . For instance, the user can change the size of the heat sink, the air flow around the device, the interface material, the mounting arrangement on printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device.

To determine the junction temperature of the device in the application when heat sinks are not used, the Thermal Characterization Parameter ( $\Psi_{JT}$ ) can be used to determine the junction temperature with a measurement of the temperature at the top center of the package case using [Equation 3](#):

$$T_J = T_T + (\Psi_{JT} * P_D) \quad \text{Eqn. 3}$$

where:

- $T_T$  = thermocouple temperature on top of the package (°C)
- $\Psi_{JT}$  = thermal characterization parameter (°C/W)
- $P_D$  = power dissipation in the package (W)

The thermal characterization parameter is measured per JESD51-2 specification using a 40 gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over about 1 mm of wire extending from the junction. The thermocouple wire is placed flat against the package case to avoid measurement errors caused by cooling effects of the thermocouple wire.

References:

Semiconductor Equipment and Materials International  
 3081 Zanker Road  
 San Jose, CA 95134 U.S.A.  
 (408) 943-6900

MIL-SPEC and EIA/JESD (JEDEC) specifications are available from Global Engineering Documents at 800-854-7179 or 303-397-7956.

JEDEC specifications are available on the WEB at <http://www.jedec.org>.

1. C.E. Triplett and B. Joiner, *An Experimental Characterization of a 272 PBGA Within an Automotive Engine Controller Module*, Proceedings of SemiTherm, San Diego, 1998, pp. 47–54.
2. G. Kromann, S. Shidore, and S. Addison, *Thermal Modeling of a PBGA for Air-Cooled Applications*, Electronic Packaging and Production, pp. 53–58, March 1998.
3. B. Joiner and V. Adams, *Measurement and Simulation of Junction to Board Thermal Resistance and Its Application in Thermal Modeling*, Proceedings of SemiTherm, San Diego, 1999, pp. 212–220.

### 3.6 Electromagnetic interference (EMI) characteristics

Table 12. EMI testing specifications

| Symbol           | Parameter          | Conditions   | Clocks   | Frequency       | Level (Max) | Unit       |
|------------------|--------------------|--|--|-----------------|-------------|------------|
| V <sub>EME</sub> | Radiated emissions | Device configuration, test conditions and EM testing per standard IEC61967-2     | f <sub>OSC</sub> 8 MHz<br>f <sub>CPU</sub> 64 MHz<br>No PLL frequency modulation | 150 kHz–150 MHz | 16          | dB $\mu$ V |
|                  |                    |  |  | 150–1000 MHz    | 15          |            |
|                  |                    |  |  | IEC Level       | M           | —          |
|                  |                    | Supply voltage = 5 V DC<br>Ambient temperature = 25 °C<br>Worst-case orientation | f <sub>OSC</sub> 8 MHz<br>f <sub>CPU</sub> 64 MHz<br>1% PLL frequency modulation | 150 kHz–150 MHz | 15          | dB $\mu$ V |
|                  |                    |  |  | 150–1000 MHz    | 14          |            |
|                  |                    |  |  | IEC Level       | M           | —          |

### 3.7 Electrostatic discharge (ESD) characteristics

Table 13. ESD ratings<sup>1,2</sup>

| Symbol                | Parameter   | Conditions | Value         | Unit |
|-----------------------|---|------------|---------------|------|
| V <sub>ESD(HBM)</sub> | SR Electrostatic discharge (Human Body Model)     | —          | 2000          | V    |
| V <sub>ESD(CDM)</sub> | SR Electrostatic discharge (Charged Device Model) | —          | 750 (corners) | V    |
|                       |   |            | 500 (other)   |      |

<sup>1</sup> All ESD testing is in conformity with CDF-AEC-Q100 Stress Test Qualification for Automotive Grade Integrated Circuits.

<sup>2</sup> A device will be defined as a failure if after exposure to ESD pulses the device no longer meets the device specification requirements. Complete DC parametric and functional testing shall be performed per applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

## 3.8 Power management electrical characteristics

### 3.8.1 Voltage regulator electrical characteristics

The internal voltage regulator requires an external NPN ballast to be connected as shown in [Figure 8](#). [Table 14](#) contains all approved NPN ballast components. Capacitances should be placed on the board as near as possible to the associated pins. Care should also be taken to limit the serial inductance of the  $V_{DD\_HV\_REG}$  BCTRL and  $V_{DD\_LV\_CORx}$  pins to less than  $L_{Reg}$ , see [Table 15](#).

#### NOTE

The voltage regulator output cannot be used to drive external circuits. Output pins are used only for decoupling capacitances.

$V_{DD\_LV\_COR}$  must be generated using internal regulator and external NPN transistor. It is not possible to provide  $V_{DD\_LV\_COR}$  through external regulator.

For the MPC5604P microcontroller, capacitors, with total values not below  $C_{DEC1}$ , should be placed between  $V_{DD\_LV\_CORx}/V_{SS\_LV\_CORx}$  close to external ballast transistor emitter. 4 capacitors, with total values not below  $C_{DEC2}$ , should be placed close to microcontroller pins between each  $V_{DD\_LV\_CORx}/V_{SS\_LV\_CORx}$  supply pairs and the  $V_{DD\_LV\_REGCOR}/V_{SS\_LV\_REGCOR}$  pair. Additionally, capacitors with total values not below  $C_{DEC3}$ , should be placed between the  $V_{DD\_HV\_REG}/V_{SS\_HV\_REG}$  pins close to ballast collector. Capacitors values have to take into account capacitor accuracy, aging and variation versus temperature.

All reported information are valid for voltage and temperature ranges described in recommended operating condition, [Table 8](#) and [Table 9](#).

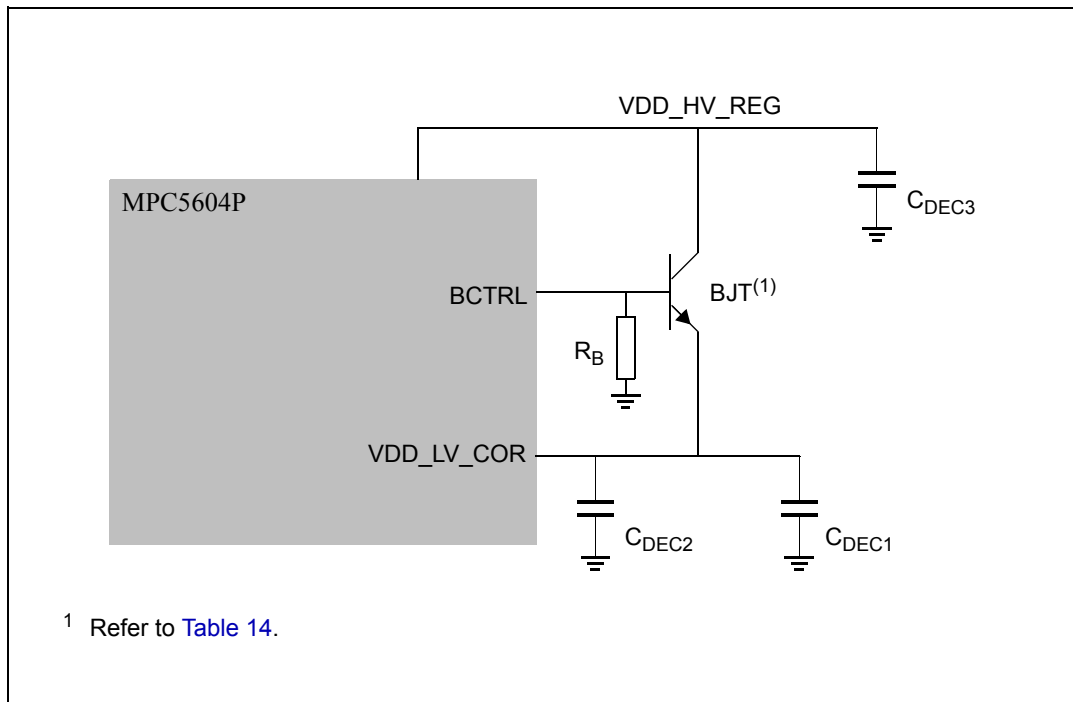


Figure 8. Configuration with resistor on base

**Table 14. Approved NPN ballast components (configuration with resistor on base)**

| Part  | Manufacturer | Approved derivatives <sup>1</sup> |
|-------|--------------|-----------------------------------|
| BCP68 | ON Semi      | BCP68                             |
|       | NXP          | BCP68-25                          |
|       | Infineon     | BCP68-25                          |
| BCX68 | Infineon     | BCX68-10;BCX68-16;BCX68-25        |
| BC868 | NXP          | BC868                             |
| BC817 | Infineon     | BC817-16;BC817-25;BC817SU;        |
|       | NXP          | BC817-16;BC817-25                 |
| BCP56 | ST           | BCP56-16                          |
|       | Infineon     | BCP56-10;BCP56-16                 |
|       | ON Semi      | BCP56-10                          |
|       | NXP          | BCP56-10;BCP56-16                 |

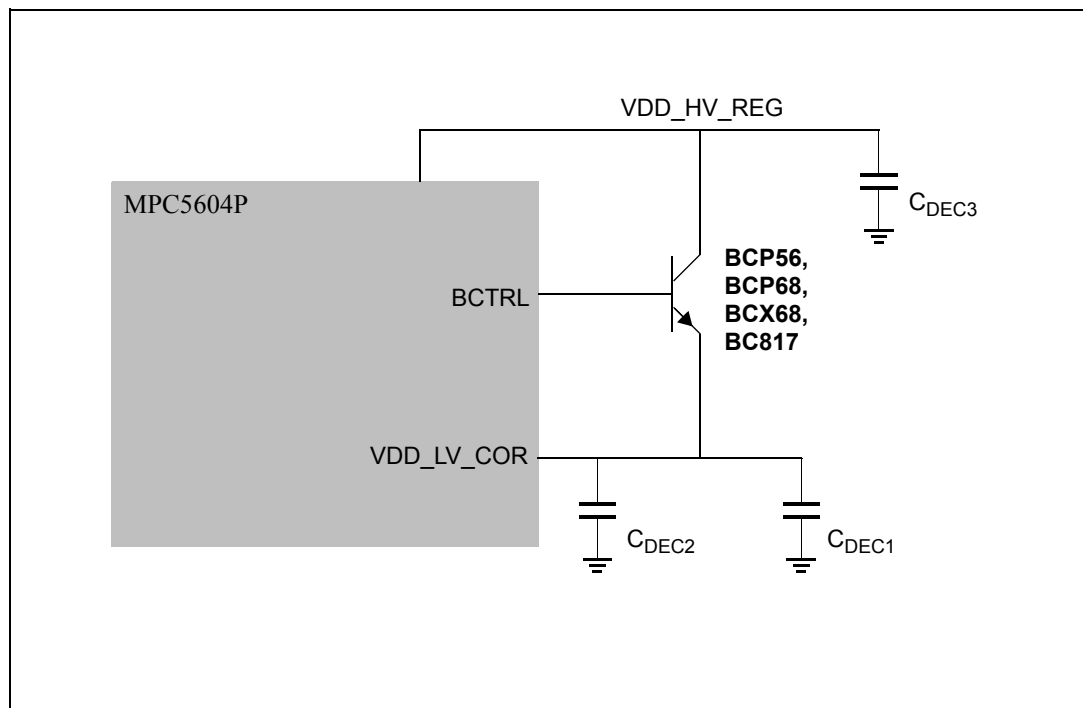
<sup>1</sup> For automotive applications please check with the appropriate transistor vendor for automotive grade certification

**Table 15. Voltage regulator electrical characteristics (configuration with resistor on base)**

| Symbol                    | C  | Parameter | Conditions   | Value  |      |     | Unit |    |
|---------------------------|----|-----------|--|--|------|-----|------|----|
|                           |    |           |  | Min  | Typ  | Max |      |    |
| V <sub>DD_LV_REGCOR</sub> | CC | P         | Output voltage under maximum load run supply current configuration | Post-trimming  | 1.15 | —   | 1.32 | V  |
| R <sub>B</sub>            | SR | —         | External resistance on bipolar junction transistor (BJT) base      | —  | 18   | —   | 22   | kΩ |
| C <sub>DEC1</sub>         | SR | —         | External decoupling/stability ceramic capacitor                    | BJT from <a href="#">Table 14. 3</a> capacitances (i.e. X7R or X8R capacitors) with nominal value of 10 μF | 19.5 | 30  | —    | μF |
|                           |    |           |  | BJT BC817, one capacitance of 22 μF  | 14.3 | 22  |      | μF |

**Table 15. Voltage regulator electrical characteristics (configuration with resistor on base) (continued)**

| Symbol            | C  | Parameter | Conditions   | Value |      |     | Unit |
|-------------------|----|-----------|--|-------|------|-----|------|
|                   |    |           |  | Min   | Typ  | Max |      |
| R <sub>REG</sub>  | SR | —         | Resulting ESR of all three capacitors of C <sub>DEC1</sub>                       | —     | —    | 50  | mΩ   |
|                   |    | —         | Resulting ESR of the unique capacitor C <sub>DEC1</sub>                          | 10    | —    | 40  | mΩ   |
| C <sub>DEC2</sub> | SR | —         | External decoupling/stability ceramic capacitor                                  | 1200  | 1760 | —   | nF   |
| C <sub>DEC3</sub> | SR | —         | External decoupling/stability ceramic capacitor on V <sub>DD_HV_REG</sub>        | 19.5  | 30   | —   | μF   |
| L <sub>Reg</sub>  | SR | —         | Resulting ESL of V <sub>DD_HV_REG</sub> , BCTRL and V <sub>DD_LV_CORx</sub> pins | —     | —    | 15  | nH   |



**Figure 9. Configuration without resistor on base**

**Table 16. Voltage regulator electrical characteristics (configuration without resistor on base)**

| Symbol                    | C  | Parameter | Conditions   | Value   |      |     | Unit |    |
|---------------------------|----|-----------|--|---|------|-----|------|----|
|                           |    |           |  | Min   | Typ  | Max |      |    |
| V <sub>DD_LV_REGCOR</sub> | CC | P         | Output voltage under maximum load run supply current configuration               | Post-trimming                                     | 1.15 | —   | 1.32 | V  |
| C <sub>DEC1</sub>         | SR | —         | External decoupling/stability ceramic capacitor                                  | 4 capacitances                                    | 40   | 56  | —    | μF |
| R <sub>REG</sub>          | SR | —         | Resulting ESR of all four C <sub>DEC1</sub>                                      | Absolute maximum value between 100 kHz and 10 MHz | —    | —   | 45   | mΩ |
| C <sub>DEC2</sub>         | SR | —         | External decoupling/stability ceramic capacitor                                  | 4 capacitances of 100 nF each                     | 400  | —   | —    | nF |
| C <sub>DEC3</sub>         | SR | —         | External decoupling/stability ceramic capacitor on VDD_HV_REG                    | —   | 40   | —   | —    | μF |
| L <sub>Reg</sub>          | SR | —         | Resulting ESL of V <sub>DD_HV_REG</sub> , BCTRL and V <sub>DD_LV_CORx</sub> pins | —   | —    | —   | 15   | nH |

### 3.8.2 Voltage monitor electrical characteristics

The device implements a Power-on Reset module to ensure correct power-up initialization, as well as three low voltage detectors to monitor the V<sub>DD</sub> and the V<sub>DD\_LV</sub> voltage while device is supplied:

- POR monitors V<sub>DD</sub> during the power-up phase to ensure device is maintained in a safe reset state
- LVDHV3 monitors V<sub>DD</sub> to ensure device reset below minimum functional supply
- LVDHV5 monitors V<sub>DD</sub> when application uses device in the 5.0V ± 10% range
- LVDLVCOR monitors low voltage digital power domain

**Table 17. Low voltage monitor electrical characteristics**

| Symbol                   | C | Parameter                                     | Conditions <sup>1</sup> | Value |      | Unit |
|--------------------------|---|---|-------------------------|-------|------|------|
|                          |   |   |                         | Min   | Max  |      |
| V <sub>PORH</sub>        | T | Power-on reset threshold                      | —                       | 1.5   | 2.7  | V    |
| V <sub>PORUP</sub>       | P | Supply for functional POR module              | T <sub>A</sub> = 25 °C  | 1.0   | —    | V    |
| V <sub>REGLVDMOK_H</sub> | P | Regulator low voltage detector high threshold | —                       | —     | 2.95 | V    |
| V <sub>REGLVDMOK_L</sub> | P | Regulator low voltage detector low threshold  | —                       | 2.6   | —    | V    |
| V <sub>FLLVDMOK_H</sub>  | P | Flash low voltage detector high threshold     | —                       | —     | 2.95 | V    |
| V <sub>FLLVDMOK_L</sub>  | P | Flash low voltage detector low threshold      | —                       | 2.6   | —    | V    |
| V <sub>IOLVDMOK_H</sub>  | P | I/O low voltage detector high threshold       | —                       | —     | 2.95 | V    |
| V <sub>IOLVDMOK_L</sub>  | P | I/O low voltage detector low threshold        | —                       | 2.6   | —    | V    |

**Table 17. Low voltage monitor electrical characteristics (continued)**

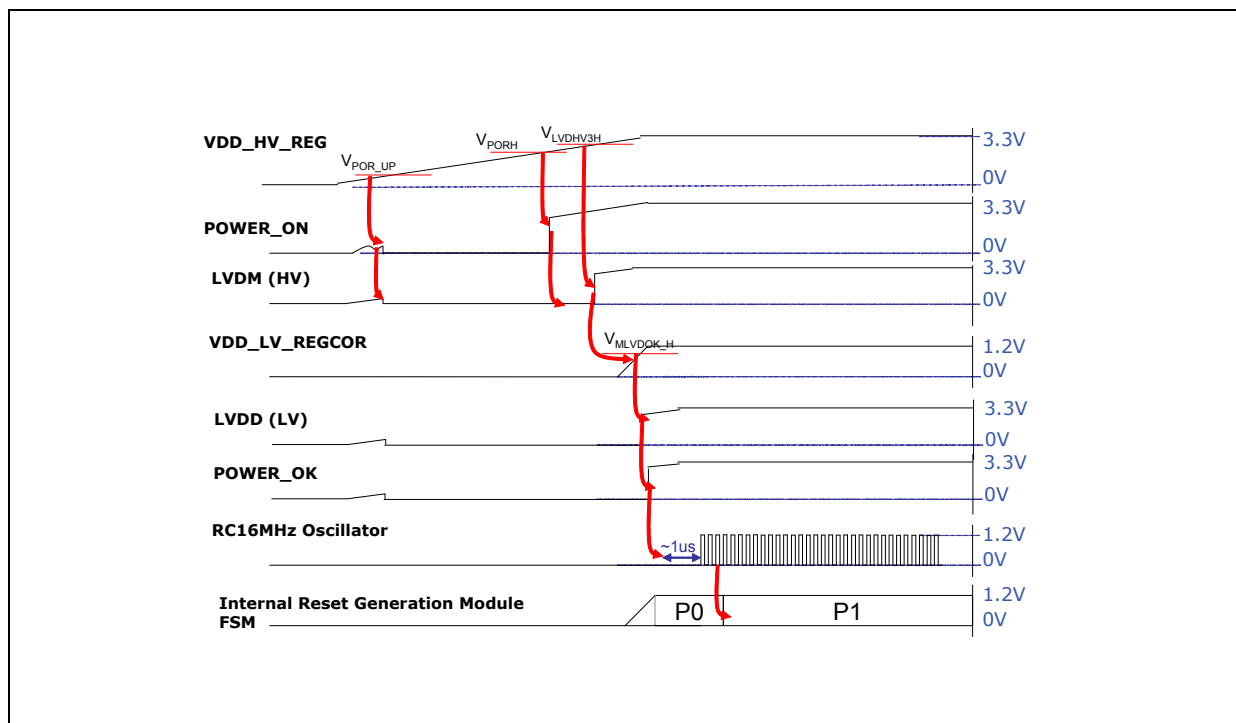
| Symbol                   | C | Parameter                                  | Conditions <sup>1</sup> | Value |       | Unit |
|--------------------------|---|--|-------------------------|-------|-------|------|
|                          |   |  |                         | Min   | Max   |      |
| V <sub>IOLVDM5OK_H</sub> | P | I/O 5V low voltage detector high threshold | —                       | —     | 4.4   | V    |
| V <sub>IOLVDM5OK_L</sub> | P | I/O 5V low voltage detector low threshold  | —                       | 3.8   | —     | V    |
| V <sub>MLVDDOK_H</sub>   | P | Digital supply low voltage detector high   | —                       | —     | 1.145 | V    |
| V <sub>MLVDDOK_L</sub>   | P | Digital supply low voltage detector low    | —                       | 1.08  | —     | V    |

<sup>1</sup> V<sub>DD</sub> = 3.3V ± 10% / 5.0V ± 10%, T<sub>A</sub> = -40 °C to T<sub>A</sub> MAX, unless otherwise specified

### 3.9 Power up/down sequencing

To prevent an overstress event or a malfunction within and outside the device, the MPC5604P implements the following sequence to ensure each module is started only when all conditions for switching it ON are available:

- A POWER\_ON module working on voltage regulator supply controls the correct start-up of the regulator. This is a key module ensuring safe configuration for all voltage regulator functionality when supply is below 1.5V. Associated POWER\_ON (or POR) signal is active low.
- Several low voltage detectors, working on voltage regulator supply monitor the voltage of the critical modules (voltage regulator, I/Os, flash memory and low voltage domain). LVDs are gated low when POWER\_ON is active.
- A POWER\_OK signal is generated when all critical supplies monitored by the LVD are available. This signal is active high and released to all modules including I/Os, flash memory and RC16 oscillator needed during power-up phase and reset phase. When POWER\_OK is low the associated module are set into a safe state.



**Figure 10. Power-up typical sequence**

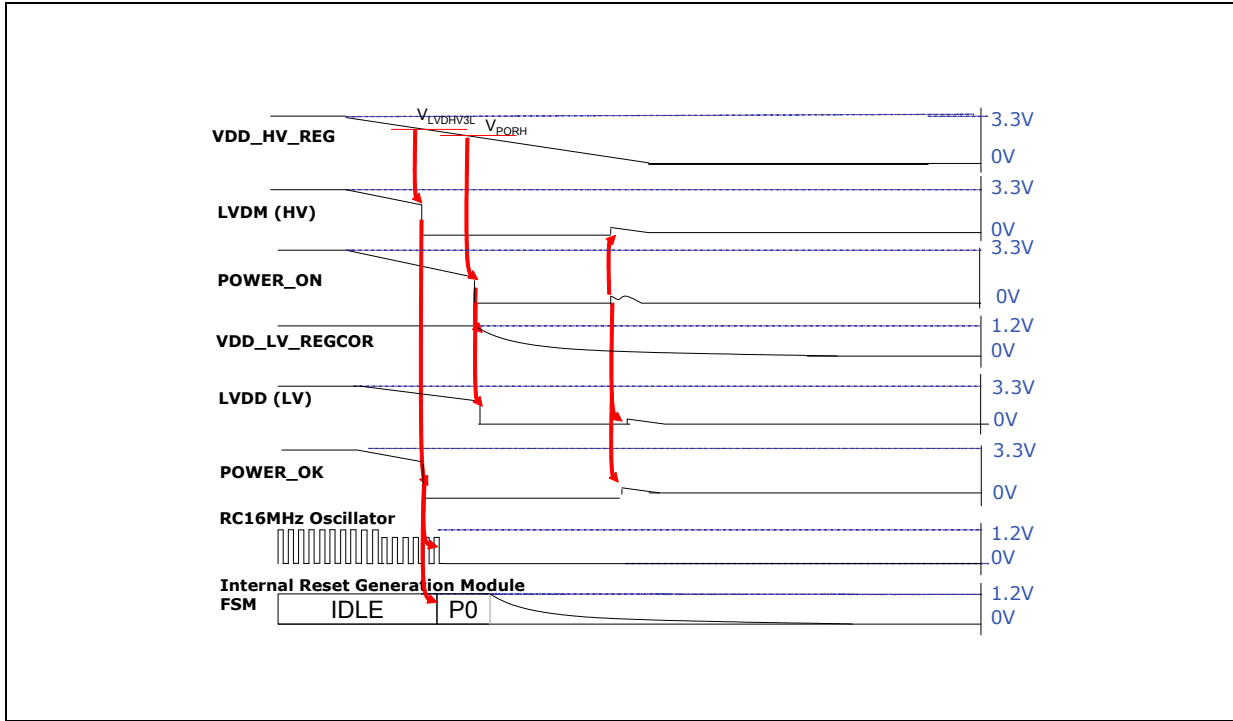


Figure 11. Power-down typical sequence

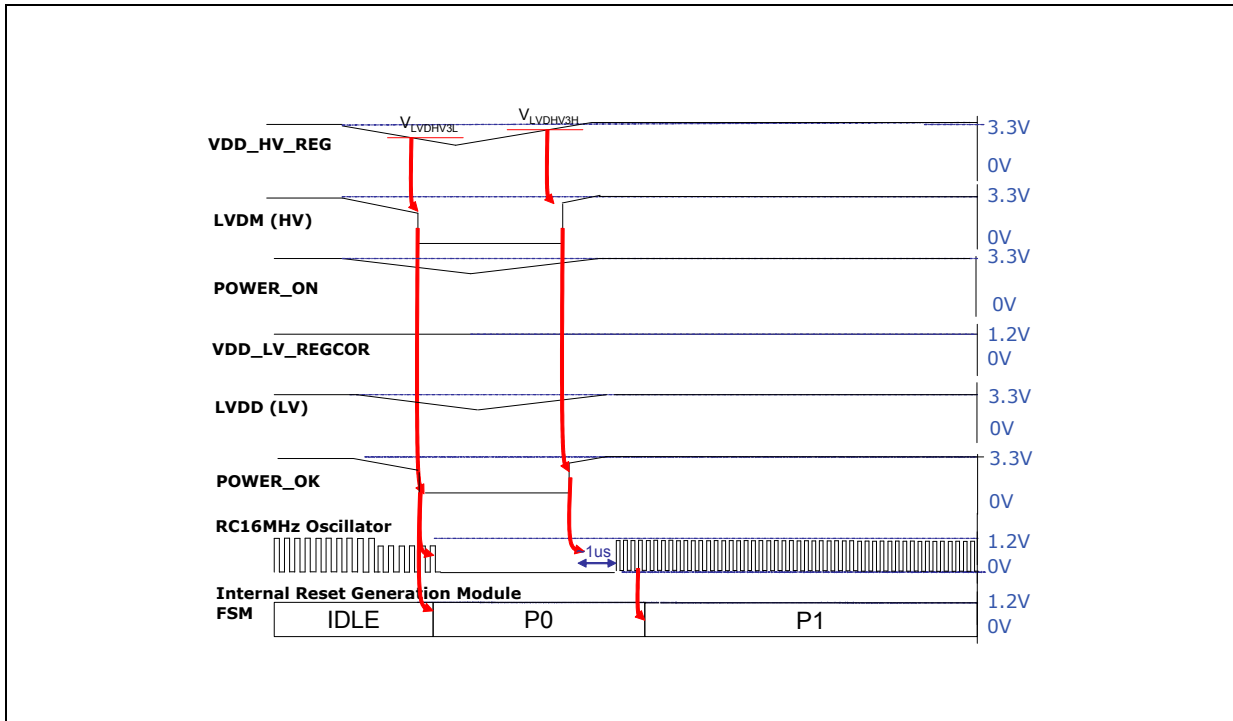


Figure 12. Brown-out typical sequence

## 3.10 DC electrical characteristics

### 3.10.1 NVUSRO register

Portions of the device configuration, such as high voltage supply, and watchdog enable/disable after reset are controlled via bit values in the non-volatile user options (NVUSRO) register.

For a detailed description of the NVUSRO register, please refer to the device reference manual.

#### 3.10.1.1 NVUSRO[PAD3V5V] field description

The DC electrical characteristics are dependent on the PAD3V5V bit value. [Table 18](#) shows how NVUSRO[PAD3V5V] controls the device configuration.

**Table 18. PAD3V5V field description**

| Value <sup>1</sup> | Description                  |
|--------------------|------------------------------|
| 0                  | High voltage supply is 5.0 V |
| 1                  | High voltage supply is 3.3 V |

<sup>1</sup> Default manufacturing value before flash initialization is '1' (3.3 V).

### 3.10.2 DC electrical characteristics (5 V)

[Table 19](#) gives the DC electrical characteristics at 5 V ( $4.5\text{ V} < V_{DD\_HV\_IOx} < 5.5\text{ V}$ , NVUSRO[PAD3V5V] = 0); see [Figure 13](#).

**Table 19. DC electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0)**

| Symbol              | C | Parameter                            | Conditions                        | Value                       |   | Unit |
|---------------------|---|--------------------------------------|-----------------------------------|-----------------------------|---|------|
|                     |   |                                      |                                   | Min                         | Max                                       |      |
| V <sub>IL</sub>     | D | Low level input voltage              | —                                 | -0.1 <sup>1</sup>           | —   | V    |
|                     | P |                                      | —                                 | —                           | 0.35 V <sub>DD_HV_IOx</sub>               | V    |
| V <sub>IH</sub>     | P | High level input voltage             | —                                 | 0.65 V <sub>DD_HV_IOx</sub> | —   | V    |
|                     | D |                                      | —                                 | —                           | V <sub>DD_HV_IOx</sub> + 0.1 <sup>1</sup> | V    |
| V <sub>HYS</sub>    | T | Schmitt trigger hysteresis           | —                                 | 0.1 V <sub>DD_HV_IOx</sub>  | —   | V    |
| V <sub>OL_S</sub>   | P | Slow, low level output voltage       | I <sub>OL</sub> = 3 mA            | —                           | 0.1 V <sub>DD_HV_IOx</sub>                | V    |
| V <sub>OH_S</sub>   | P | Slow, high level output voltage      | I <sub>OH</sub> = -3 mA           | 0.8 V <sub>DD_HV_IOx</sub>  | —   | V    |
| V <sub>OL_M</sub>   | P | Medium, low level output voltage     | I <sub>OL</sub> = 3 mA            | —                           | 0.1 V <sub>DD_HV_IOx</sub>                | V    |
| V <sub>OH_M</sub>   | P | Medium, high level output voltage    | I <sub>OH</sub> = -3 mA           | 0.8 V <sub>DD_HV_IOx</sub>  | —   | V    |
| V <sub>OL_F</sub>   | P | Fast, low level output voltage       | I <sub>OL</sub> = 3 mA            | —                           | 0.1 V <sub>DD_HV_IOx</sub>                | V    |
| V <sub>OH_F</sub>   | P | Fast, high level output voltage      | I <sub>OH</sub> = -3 mA           | 0.8 V <sub>DD_HV_IOx</sub>  | —   | V    |
| V <sub>OL_SYM</sub> | P | Symmetric, low level output voltage  | I <sub>OL</sub> = 3 mA            | —                           | 0.1 V <sub>DD_HV_IOx</sub>                | V    |
| V <sub>OH_SYM</sub> | P | Symmetric, high level output voltage | I <sub>OH</sub> = -3 mA           | 0.8 V <sub>DD_HV_IOx</sub>  | —   | V    |
| I <sub>PU</sub>     | P | Equivalent pull-up current           | V <sub>IN</sub> = V <sub>IL</sub> | -130                        | —   | μA   |
|                     |   |                                      | V <sub>IN</sub> = V <sub>IH</sub> | —                           | -10                                       |      |

**Table 19. DC electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0) (continued)**

| Symbol          | C | Parameter  | Conditions                        | Value |     | Unit |
|-----------------|---|--|-----------------------------------|-------|-----|------|
|                 |   |  |                                   | Min   | Max |      |
| I <sub>PD</sub> | P | Equivalent pull-down current                     | V <sub>IN</sub> = V <sub>IL</sub> | 10    | —   | μA   |
|                 |   |  | V <sub>IN</sub> = V <sub>IH</sub> | —     | 130 |      |
| I <sub>IL</sub> | P | Input leakage current (all bidirectional ports)  | T <sub>A</sub> = -40 to 125 °C    | -1    | 1   | μA   |
| I <sub>IL</sub> | P | Input leakage current (all ADC input-only ports) | T <sub>A</sub> = -40 to 125 °C    | -0.5  | 0.5 | μA   |
| C <sub>IN</sub> | D | Input capacitance                                | —                                 | —     | 10  | pF   |
| I <sub>PU</sub> | D | RESET, equivalent pull-up current                | V <sub>IN</sub> = V <sub>IL</sub> | -130  | —   | μA   |
|                 |   |  | V <sub>IN</sub> = V <sub>IH</sub> | —     | -10 |      |

<sup>1</sup> "SR" parameter values must not exceed the absolute maximum ratings shown in Table 7.

**Table 20. Supply current (5.0 V, NVUSRO[PAD3V5V] = 0)**

| Symbol                  | C | Parameter  | Conditions  | Value  |       | Unit  |    |
|-------------------------|---|--|---|--------|-------|-------|----|
|                         |   |  |   | Typ    | Max   |       |    |
| I <sub>DD_LV_CORx</sub> | T | RUN—Maximum mode <sup>1</sup>                      | V <sub>DD_LV_CORx</sub> externally forced at 1.3 V  | 40 MHz | 62    | 77    | mA |
|                         |   |  |   | 64 MHz | 71    | 88    |    |
|                         |   | RUN—Typical mode <sup>2</sup>                      |   | 40 MHz | 45    | 56    |    |
|                         |   |  |   | 64 MHz | 52    | 65    |    |
|                         | P | RUN—Maximum mode <sup>3</sup>                      | V <sub>DD_LV_CORx</sub> externally forced at 1.3 V  | 64 MHz | 60    | 75    |    |
|                         |   | HALT mode <sup>4</sup>                             | V <sub>DD_LV_CORx</sub> externally forced at 1.3 V  | —      | 1.5   | 10    |    |
| STOP mode <sup>5</sup>  |   | V <sub>DD_LV_CORx</sub> externally forced at 1.3 V | —   | 1      | 10    |       |    |
| I <sub>DD_FLASH</sub>   | T | Flash during read                                  | V <sub>DD_HV_FL</sub> at 5.0 V  | —      | 10    | 12    |    |
|                         |   | Flash during erase operation on 1 flash module     | V <sub>DD_HV_FL</sub> at 5.0 V  | —      | 15    | 19    |    |
| I <sub>DD_ADC</sub>     | T | ADC—Maximum mode <sup>1</sup>                      | V <sub>DD_HV_ADC0</sub> at 5.0 V<br>V <sub>DD_HV_ADC1</sub> at 5.0 V<br>f <sub>ADC</sub> = 16 MHz | ADC_1  | 3.5   | 5     |    |
|                         |   |  |   | ADC_0  | 3     | 4     |    |
|                         |   | ADC—Typical mode <sup>2</sup>                      |   | ADC_1  | 0.8   | 1     |    |
|                         |   |  |   | ADC_0  | 0.005 | 0.006 |    |
| I <sub>DD_OSC</sub>     | T | Oscillator   | V <sub>DD_OSC</sub> at 5.0 V  | 8 MHz  | 2.6   | 3.2   |    |

<sup>1</sup> Maximum mode: FlexPWM, ADCs, CTU, DSPI, LINFlex, FlexCAN, 15 output pins, 1st and 2nd PLL enabled. I/O supply current excluded.

<sup>2</sup> Typical mode configurations: DSPI, LINFlex, FlexCAN, 15 output pins, 1st PLL only. I/O supply current excluded.

- <sup>3</sup> Code fetched from RAM, PLL\_0: 64 MHz system clock (x4 multiplier with 16 MHz XTAL), PLL\_1 is ON at PHI\_div2 = 120 MHz and PHI\_div3 = 80 MHz, auxiliary clock sources set that all peripherals receive maximum frequency, all peripherals enabled.
- <sup>4</sup> Halt mode configurations: code fetched from RAM, code and data flash memories in low power mode, OSC/PLL\_0/PLL\_1 are OFF, core clock frozen, all peripherals are disabled.
- <sup>5</sup> STOP "P" mode Device Under Test (DUT) configuration: code fetched from RAM, code and data flash memories OFF, OSC/PLL\_0/PLL\_1 are OFF, core clock frozen, all peripherals are disabled.

### 3.10.3 DC electrical characteristics (3.3 V)

Table 21 gives the DC electrical characteristics at 3.3 V ( $3.0\text{ V} < V_{DD\_HV\_IOx} < 3.6\text{ V}$ , NVUSRO[PAD3V5V] = 1); see Figure 13.

**Table 21. DC electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1)<sup>1</sup>**

| Symbol              | C | Parameter  | Conditions                        | Value                        |   | Unit |
|---------------------|---|--|-----------------------------------|------------------------------|---|------|
|                     |   |  |                                   | Min                          | Max                                       |      |
| V <sub>IL</sub>     | D | Low level input voltage                          | —                                 | -0.1 <sup>2</sup>            | —   | V    |
|                     | P |  | —                                 | —                            | 0.35 V <sub>DD_HV_IOx</sub>               | V    |
| V <sub>IH</sub>     | P | High level input voltage                         | —                                 | 0.65 V <sub>DD_HV_IOx</sub>  | —   | V    |
|                     | D |  | —                                 | —                            | V <sub>DD_HV_IOx</sub> + 0.1 <sup>2</sup> | V    |
| V <sub>HYS</sub>    | T | Schmitt trigger hysteresis                       | —                                 | 0.1 V <sub>DD_HV_IOx</sub>   | —   | V    |
| V <sub>OL_S</sub>   | P | Slow, low level output voltage                   | I <sub>OL</sub> = 1.5 mA          | —                            | 0.5                                       | V    |
| V <sub>OH_S</sub>   | P | Slow, high level output voltage                  | I <sub>OH</sub> = -1.5 mA         | V <sub>DD_HV_IOx</sub> - 0.8 | —   | V    |
| V <sub>OL_M</sub>   | P | Medium, low level output voltage                 | I <sub>OL</sub> = 2 mA            | —                            | 0.5                                       | V    |
| V <sub>OH_M</sub>   | P | Medium, high level output voltage                | I <sub>OH</sub> = -2 mA           | V <sub>DD_HV_IOx</sub> - 0.8 | —   | V    |
| V <sub>OL_F</sub>   | P | Fast, low level output voltage                   | I <sub>OL</sub> = 1.5 mA          | —                            | 0.5                                       | V    |
| V <sub>OH_F</sub>   | P | Fast, high level output voltage                  | I <sub>OH</sub> = -1.5 mA         | V <sub>DD_HV_IOx</sub> - 0.8 | —   | V    |
| V <sub>OL_SYM</sub> | P | Symmetric, low level output voltage              | I <sub>OL</sub> = 1.5 mA          | —                            | 0.5                                       | V    |
| V <sub>OH_SYM</sub> | P | Symmetric, high level output voltage             | I <sub>OH</sub> = -1.5 mA         | V <sub>DD_HV_IOx</sub> - 0.8 | —   | V    |
| I <sub>PU</sub>     | P | Equivalent pull-up current                       | V <sub>IN</sub> = V <sub>IL</sub> | -130                         | —   | μA   |
|                     |   |  | V <sub>IN</sub> = V <sub>IH</sub> | —                            | -10                                       |      |
| I <sub>PD</sub>     | P | Equivalent pull-down current                     | V <sub>IN</sub> = V <sub>IL</sub> | 10                           | —   | μA   |
|                     |   |  | V <sub>IN</sub> = V <sub>IH</sub> | —                            | 130                                       |      |
| I <sub>IL</sub>     | P | Input leakage current (all bidirectional ports)  | T <sub>A</sub> = -40 to 125 °C    | —                            | 1   | μA   |
| I <sub>IL</sub>     | P | Input leakage current (all ADC input-only ports) | T <sub>A</sub> = -40 to 125 °C    | —                            | 0.5                                       | μA   |
| C <sub>IN</sub>     | D | Input capacitance                                | —                                 | —                            | 10  | pF   |
| I <sub>PU</sub>     | D | RESET, equivalent pull-up current                | V <sub>IN</sub> = V <sub>IL</sub> | -130                         | —   | μA   |
|                     |   |  | V <sub>IN</sub> = V <sub>IH</sub> | —                            | -10                                       |      |

<sup>1</sup> These specifications are design targets and subject to change per device characterization.

<sup>2</sup> “SR” parameter values must not exceed the absolute maximum ratings shown in [Table 7](#).

**Table 22. Supply current (3.3 V, NVUSRO[PAD3V5V] = 1)**

| Symbol                  | C     | Parameter                                   | Conditions  | Value  |     | Unit |    |
|-------------------------|-------|---|---|--------|-----|------|----|
|                         |       |   |   | Typ    | Max |      |    |
| I <sub>DD_LV_CORx</sub> | T     | RUN—Maximum mode <sup>1</sup>               | V <sub>DD_LV_CORx</sub><br>externally forced at 1.3 V   | 40 MHz | 62  | 77   | mA |
|                         |       |   |   | 64 MHz | 71  | 89   |    |
|                         |       | RUN—Typical mode <sup>2</sup>               |   | 40 MHz | 45  | 56   |    |
|                         |       |   |   | 64 MHz | 53  | 66   |    |
|                         | P     | RUN—Maximum mode <sup>3</sup>               | V <sub>DD_LV_CORx</sub><br>externally forced at 1.3 V   | 64 MHz | 60  | 75   |    |
| I <sub>DD_FLASH</sub>   | T     | Flash during read on single mode            | V <sub>DD_HV_FL</sub> at 3.3 V  | —      | 8   | 10   |    |
|                         |       | Flash during erase operation on single mode | V <sub>DD_HV_FL</sub> at 3.3 V  | —      | 10  | 12   |    |
|                         | T     | ADC—Maximum mode <sup>1</sup>               | V <sub>DD_HV_ADC0</sub> at 3.3 V<br>V <sub>DD_HV_ADC1</sub> at 3.3 V<br>f <sub>ADC</sub> = 16 MHz | ADC_1  | 2.5 | 4    |    |
|                         |       |   |   | ADC_0  | 2   | 4    |    |
|                         |       | ADC—Typical mode <sup>2</sup>               |   | ADC_1  | 0.8 | 1    |    |
| ADC_0                   | 0.005 |   | 0.006   |        |     |      |    |
| I <sub>DD_OSC</sub>     | T     | Oscillator                                  | V <sub>DD_OSC</sub> at 3.3 V  | 8 MHz  | 2.4 | 3    |    |

<sup>1</sup> Maximum mode: FlexPWM, ADCs, CTU, DSPI, LINFlex, FlexCAN, 15 output pins, 1st and 2nd PLL enabled. I/O supply current excluded.

<sup>2</sup> Typical mode: DSPI, LINFlex, FlexCAN, 15 output pins, 1st PLL only. I/O supply current excluded.

<sup>3</sup> Code fetched from RAM, PLL\_0: 64 MHz system clock (x4 multiplier with 16 MHz XTAL), PLL\_1 is ON at PHI\_div2 = 120 MHz and PHI\_div3 = 80 MHz, auxiliary clock sources set that all peripherals receive maximum frequency, all peripherals enabled.

<sup>4</sup> Halt mode configurations: code fetched from RAM, code and data flash memories in low power mode, OSC/PLL\_0/PLL\_1 are OFF, core clock frozen, all peripherals are disabled.

<sup>5</sup> STOP “P” mode Device Under Test (DUT) configuration: code fetched from RAM, code and data flash memories OFF, OSC/PLL\_0/PLL\_1 are OFF, core clock frozen, all peripherals are disabled.

### 3.10.4 Input DC electrical characteristics definition

[Figure 13](#) shows the DC electrical characteristics behavior as function of time.

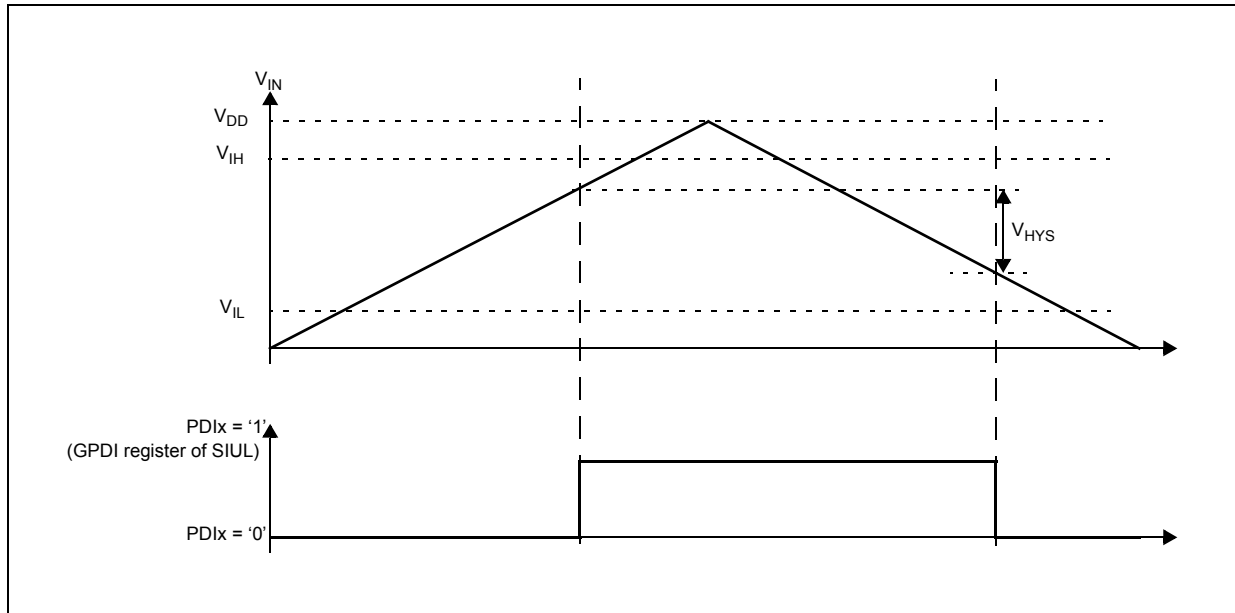


Figure 13. Input DC electrical characteristics definition

### 3.10.5 I/O pad current specification

The I/O pads are distributed across the I/O supply segment. Each I/O supply segment is associated to a  $V_{DD}/V_{SS}$  supply pair as described in [Table 23](#).

Table 23. I/O supply segment

| Package  | Supply segment |               |               |               |               |                |               |
|----------|----------------|---------------|---------------|---------------|---------------|----------------|---------------|
|          | 1              | 2             | 3             | 4             | 5             | 6              | 7             |
| 144 LQFP | pin8 – pin20   | pin23 – pin38 | pin39 – pin55 | pin58 – pin68 | pin73 – pin89 | pin92 – pin125 | pin128 – pin5 |
| 100 LQFP | pin15 – pin26  | pin27 – pin38 | pin41 – pin46 | pin51 – pin61 | pin64 – pin86 | pin89 – pin10  | —             |

[Table 24](#) provides the weight of concurrent switching I/Os.

In order to ensure device functionality, the sum of the weight of concurrent switching I/Os on a single segment should remain below 100%.

Table 24. I/O weight

| Pad     | 144 LQFP  |             | 100 LQFP  |             |
|---------|-----------|-------------|-----------|-------------|
|         | Weight 5V | Weight 3.3V | Weight 5V | Weight 3.3V |
| NMI     | 1%        | 1%          | 1%        | 1%          |
| PAD[6]  | 6%        | 5%          | 14%       | 13%         |
| PAD[49] | 5%        | 4%          | 14%       | 12%         |
| PAD[84] | 14%       | 10%         | —         | —           |
| PAD[85] | 9%        | 7%          | —         | —           |

**Table 24. I/O weight (continued)**

| Pad     | 144 LQFP  |             | 100 LQFP  |             |
|---------|-----------|-------------|-----------|-------------|
|         | Weight 5V | Weight 3.3V | Weight 5V | Weight 3.3V |
| PAD[86] | 9%        | 6%          | —         | —           |
| MOD0[0] | 12%       | 8%          | —         | —           |
| PAD[7]  | 4%        | 4%          | 11%       | 10%         |
| PAD[36] | 5%        | 4%          | 11%       | 9%          |
| PAD[8]  | 5%        | 4%          | 10%       | 9%          |
| PAD[37] | 5%        | 4%          | 10%       | 9%          |
| PAD[5]  | 5%        | 4%          | 9%        | 8%          |
| PAD[39] | 5%        | 4%          | 9%        | 8%          |
| PAD[35] | 5%        | 4%          | 8%        | 7%          |
| PAD[87] | 12%       | 9%          | —         | —           |
| PAD[88] | 9%        | 6%          | —         | —           |
| PAD[89] | 10%       | 7%          | —         | —           |
| PAD[90] | 15%       | 11%         | —         | —           |
| PAD[91] | 6%        | 5%          | —         | —           |
| PAD[57] | 8%        | 7%          | 8%        | 7%          |
| PAD[56] | 13%       | 11%         | 13%       | 11%         |
| PAD[53] | 14%       | 12%         | 14%       | 12%         |
| PAD[54] | 15%       | 13%         | 15%       | 13%         |
| PAD[55] | 25%       | 22%         | 25%       | 22%         |
| PAD[96] | 27%       | 24%         | —         | —           |
| PAD[65] | 1%        | 1%          | 1%        | 1%          |
| PAD[67] | 1%        | 1%          | —         | —           |
| PAD[33] | 1%        | 1%          | 1%        | 1%          |
| PAD[68] | 1%        | 1%          | —         | —           |
| PAD[23] | 1%        | 1%          | 1%        | 1%          |
| PAD[69] | 1%        | 1%          | —         | —           |
| PAD[34] | 1%        | 1%          | 1%        | 1%          |
| PAD[70] | 1%        | 1%          | —         | —           |
| PAD[24] | 1%        | 1%          | 1%        | 1%          |
| PAD[71] | 1%        | 1%          | —         | —           |
| PAD[66] | 1%        | 1%          | 1%        | 1%          |
| PAD[25] | 1%        | 1%          | 1%        | 1%          |
| PAD[26] | 1%        | 1%          | 1%        | 1%          |

**Table 24. I/O weight (continued)**

| Pad      | 144 LQFP  |             | 100 LQFP  |             |
|----------|-----------|-------------|-----------|-------------|
|          | Weight 5V | Weight 3.3V | Weight 5V | Weight 3.3V |
| PAD[27]  | 1%        | 1%          | 1%        | 1%          |
| PAD[28]  | 1%        | 1%          | 1%        | 1%          |
| PAD[63]  | 1%        | 1%          | 1%        | 1%          |
| PAD[72]  | 1%        | 1%          | —         | —           |
| PAD[29]  | 1%        | 1%          | 1%        | 1%          |
| PAD[73]  | 1%        | 1%          | —         | —           |
| PAD[31]  | 1%        | 1%          | 1%        | 1%          |
| PAD[74]  | 1%        | 1%          | —         | —           |
| PAD[30]  | 1%        | 1%          | 1%        | 1%          |
| PAD[75]  | 1%        | 1%          | —         | —           |
| PAD[32]  | 1%        | 1%          | 1%        | 1%          |
| PAD[76]  | 1%        | 1%          | —         | —           |
| PAD[64]  | 1%        | 1%          | 1%        | 1%          |
| PAD[0]   | 23%       | 20%         | 23%       | 20%         |
| PAD[1]   | 21%       | 18%         | 21%       | 18%         |
| PAD[107] | 20%       | 17%         | —         | —           |
| PAD[58]  | 19%       | 16%         | 19%       | 16%         |
| PAD[106] | 18%       | 16%         | —         | —           |
| PAD[59]  | 17%       | 15%         | 17%       | 15%         |
| PAD[105] | 16%       | 14%         | —         | —           |
| PAD[43]  | 15%       | 13%         | 15%       | 13%         |
| PAD[104] | 14%       | 13%         | —         | —           |
| PAD[44]  | 13%       | 12%         | 13%       | 12%         |
| PAD[103] | 12%       | 11%         | —         | —           |
| PAD[2]   | 11%       | 10%         | 11%       | 10%         |
| PAD[101] | 11%       | 9%          | —         | —           |
| PAD[21]  | 10%       | 8%          | 10%       | 8%          |
| TMS      | 1%        | 1%          | 1%        | 1%          |
| TCK      | 1%        | 1%          | 1%        | 1%          |
| PAD[20]  | 16%       | 11%         | 16%       | 11%         |
| PAD[3]   | 4%        | 3%          | 4%        | 3%          |
| PAD[61]  | 9%        | 8%          | 9%        | 8%          |
| PAD[102] | 11%       | 10%         | —         | —           |

**Table 24. I/O weight (continued)**

| Pad      | 144 LQFP  |             | 100 LQFP  |             |
|----------|-----------|-------------|-----------|-------------|
|          | Weight 5V | Weight 3.3V | Weight 5V | Weight 3.3V |
| PAD[60]  | 11%       | 10%         | 11%       | 10%         |
| PAD[100] | 12%       | 10%         | —         | —           |
| PAD[45]  | 12%       | 10%         | 12%       | 10%         |
| PAD[98]  | 12%       | 11%         | —         | —           |
| PAD[46]  | 12%       | 11%         | 12%       | 11%         |
| PAD[99]  | 13%       | 11%         | —         | —           |
| PAD[62]  | 13%       | 11%         | 13%       | 11%         |
| PAD[92]  | 13%       | 12%         | —         | —           |
| VPP_TEST | 1%        | 1%          | 1%        | 1%          |
| PAD[4]   | 14%       | 12%         | 14%       | 12%         |
| PAD[16]  | 13%       | 12%         | 13%       | 12%         |
| PAD[17]  | 13%       | 11%         | 13%       | 11%         |
| PAD[42]  | 13%       | 11%         | 13%       | 11%         |
| PAD[93]  | 12%       | 11%         | —         | —           |
| PAD[95]  | 12%       | 11%         | —         | —           |
| PAD[18]  | 12%       | 10%         | 12%       | 10%         |
| PAD[94]  | 11%       | 10%         | —         | —           |
| PAD[19]  | 11%       | 10%         | 11%       | 10%         |
| PAD[77]  | 10%       | 9%          | —         | —           |
| PAD[10]  | 10%       | 9%          | 10%       | 9%          |
| PAD[78]  | 9%        | 8%          | —         | —           |
| PAD[11]  | 9%        | 8%          | 9%        | 8%          |
| PAD[79]  | 8%        | 7%          | —         | —           |
| PAD[12]  | 7%        | 7%          | 7%        | 7%          |
| PAD[41]  | 7%        | 6%          | 7%        | 6%          |
| PAD[47]  | 5%        | 4%          | 5%        | 4%          |
| PAD[48]  | 4%        | 4%          | 4%        | 4%          |
| PAD[51]  | 4%        | 4%          | 4%        | 4%          |
| PAD[52]  | 5%        | 4%          | 5%        | 4%          |
| PAD[40]  | 5%        | 5%          | 6%        | 5%          |
| PAD[80]  | 9%        | 8%          | —         | —           |
| PAD[9]   | 10%       | 9%          | 11%       | 10%         |
| PAD[81]  | 10%       | 9%          | —         | —           |

**Table 24. I/O weight (continued)**

| Pad     | 144 LQFP  |             | 100 LQFP  |             |
|---------|-----------|-------------|-----------|-------------|
|         | Weight 5V | Weight 3.3V | Weight 5V | Weight 3.3V |
| PAD[13] | 10%       | 9%          | 12%       | 11%         |
| PAD[82] | 10%       | 9%          | —         | —           |
| PAD[22] | 10%       | 9%          | 13%       | 12%         |
| PAD[83] | 10%       | 9%          | —         | —           |
| PAD[50] | 10%       | 9%          | 14%       | 12%         |
| PAD[97] | 10%       | 9%          | —         | —           |
| PAD[38] | 10%       | 9%          | 14%       | 13%         |
| PAD[14] | 9%        | 8%          | 14%       | 13%         |
| PAD[15] | 9%        | 8%          | 15%       | 13%         |

**Table 25. I/O consumption**

| Symbol             | C  | Parameter | Conditions <sup>1</sup>                               | Value                                 |  |     | Unit |     |    |
|--------------------|----|-----------|---|---------------------------------------|--|-----|------|-----|----|
|                    |    |           |   | Min                                   | Typ  | Max |      |     |    |
| $I_{SWTSLW}^{(2)}$ | CC | D         | Dynamic I/O current for SLOW configuration            | $C_L = 25 \text{ pF}$                 | $V_{DD} = 5.0 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 0$ | —   | —    | 20  | mA |
|                    |    |           |   |                                       | $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 1$ | —   | —    | 16  |    |
| $I_{SWTMED}^{(2)}$ | CC | D         | Dynamic I/O current for MEDIUM configuration          | $C_L = 25 \text{ pF}$                 | $V_{DD} = 5.0 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 0$ | —   | —    | 29  | mA |
|                    |    |           |   |                                       | $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 1$ | —   | —    | 17  |    |
| $I_{SWTFST}^{(2)}$ | CC | D         | Dynamic I/O current for FAST configuration            | $C_L = 25 \text{ pF}$                 | $V_{DD} = 5.0 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 0$ | —   | —    | 110 | mA |
|                    |    |           |   |                                       | $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 1$ | —   | —    | 50  |    |
| $I_{RMSSLW}$       | CC | D         | Root medium square I/O current for SLOW configuration | $C_L = 25 \text{ pF}, 2 \text{ MHz}$  | $V_{DD} = 5.0 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 0$ | —   | —    | 2.3 | mA |
|                    |    |           |   | $C_L = 25 \text{ pF}, 4 \text{ MHz}$  |  | —   | —    | 3.2 |    |
|                    |    |           |   | $C_L = 100 \text{ pF}, 2 \text{ MHz}$ |  | —   | —    | 6.6 |    |
|                    |    |           |   | $C_L = 25 \text{ pF}, 2 \text{ MHz}$  | $V_{DD} = 3.3 \text{ V} \pm 10\%$ ,<br>$PAD3V5V = 1$ | —   | —    | 1.6 |    |
|                    |    |           |   | $C_L = 25 \text{ pF}, 4 \text{ MHz}$  |  | —   | —    | 2.3 |    |
|                    |    |           |   | $C_L = 100 \text{ pF}, 2 \text{ MHz}$ |  | —   | —    | 4.7 |    |

**Table 25. I/O consumption (continued)**

| Symbol              | C  | Parameter | Conditions <sup>1</sup>                                   |  | Value   |     |     | Unit |    |
|---------------------|----|-----------|---|--|---|-----|-----|------|----|
|                     |    |           |   |  | Min   | Typ | Max |      |    |
| I <sub>RMSMED</sub> | CC | D         | Root medium square I/O current for MEDIUM configuration   | C <sub>L</sub> = 25 pF, 13 MHz             | V <sub>DD</sub> = 5.0 V ± 10%,<br>PAD3V5V = 0 | —   | —   | 6.6  | mA |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 40 MHz             |   | —   | —   | 13.4 |    |
|                     |    |           |   | C <sub>L</sub> = 100 pF, 13 MHz            |   | —   | —   | 18.3 |    |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 13 MHz             | V <sub>DD</sub> = 3.3 V ± 10%,<br>PAD3V5V = 1 | —   | —   | 5    |    |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 40 MHz             |   | —   | —   | 8.5  |    |
|                     |    |           |   | C <sub>L</sub> = 100 pF, 13 MHz            |   | —   | —   | 11   |    |
| I <sub>RMSFST</sub> | CC | D         | Root medium square I/O current for FAST configuration     | C <sub>L</sub> = 25 pF, 40 MHz             | V <sub>DD</sub> = 5.0 V ± 10%,<br>PAD3V5V = 0 | —   | —   | 22   | mA |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 64 MHz             |   | —   | —   | 33   |    |
|                     |    |           |   | C <sub>L</sub> = 100 pF, 40 MHz            |   | —   | —   | 56   |    |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 40 MHz             | V <sub>DD</sub> = 3.3 V ± 10%,<br>PAD3V5V = 1 | —   | —   | 14   |    |
|                     |    |           |   | C <sub>L</sub> = 25 pF, 64 MHz             |   | —   | —   | 20   |    |
|                     |    |           |   | C <sub>L</sub> = 100 pF, 40 MHz            |   | —   | —   | 35   |    |
| I <sub>AVGSEG</sub> | SR | D         | Sum of all the static I/O current within a supply segment | V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0 |   | —   | —   | 70   | mA |
|                     |    |           |   | V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1 |   | —   | —   | 65   |    |

<sup>1</sup> V<sub>DD</sub> = 3.3 V ± 10% / 5.0 V ± 10%, T<sub>A</sub> = -40 to 125 °C, unless otherwise specified

<sup>2</sup> Stated maximum values represent peak consumption that lasts only a few ns during I/O transition.

### 3.11 Main oscillator electrical characteristics

The MPC5604P provides an oscillator/resonator driver.

**Table 26. Main oscillator output electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0)**

| Symbol             | C  | Parameter | Value                             |     | Unit |      |
|--------------------|----|-----------|-----------------------------------|-----|------|------|
|                    |    |           | Min                               | Max |      |      |
| f <sub>OSC</sub>   | SR | —         | Oscillator frequency              | 4   | 40   | MHz  |
| g <sub>m</sub>     | —  | P         | Transconductance                  | 6.5 | 25   | mA/V |
| V <sub>OSC</sub>   | —  | T         | Oscillation amplitude on XTAL pin | 1   | —    | V    |
| t <sub>OSCSU</sub> | —  | T         | Start-up time <sup>1,2</sup>      | 8   | —    | ms   |

<sup>1</sup> The start-up time is dependent upon crystal characteristics, board leakage, etc., high ESR and excessive capacitive loads can cause long start-up time.

<sup>2</sup> Value captured when amplitude reaches 90% of XTAL

**Table 27. Main oscillator output electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1)**

| Symbol             | C  | Parameter | Value                             |     | Unit |      |
|--------------------|----|-----------|-----------------------------------|-----|------|------|
|                    |    |           | Min                               | Max |      |      |
| f <sub>OSC</sub>   | SR | —         | Oscillator frequency              | 4   | 40   | MHz  |
| g <sub>m</sub>     | —  | P         | Transconductance                  | 4   | 20   | mA/V |
| V <sub>OSC</sub>   | —  | T         | Oscillation amplitude on XTAL pin | 1   | —    | V    |
| t <sub>OSCSU</sub> | —  | T         | Start-up time <sup>1,2</sup>      | 8   | —    | ms   |

<sup>1</sup> The start-up time is dependent upon crystal characteristics, board leakage, etc., high ESR and excessive capacitive loads can cause long start-up time.

<sup>2</sup> Value captured when amplitude reaches 90% of XTAL

**Table 28. Input clock characteristics**

| Symbol            | C  | Parameter | Value                    |      |     | Unit |     |
|-------------------|----|-----------|--------------------------|------|-----|------|-----|
|                   |    |           | Min                      | Typ  | Max |      |     |
| f <sub>OSC</sub>  | SR | —         | Oscillator frequency     | 4    | —   | 40   | MHz |
| f <sub>CLK</sub>  | SR | —         | Frequency in bypass      | —    | —   | 64   | MHz |
| t <sub>rCLK</sub> | SR | —         | Rise/fall time in bypass | —    | —   | 1    | ns  |
| t <sub>DC</sub>   | SR | —         | Duty cycle               | 47.5 | 50  | 52.5 | %   |

### 3.12 FMPLL electrical characteristics

**Table 29. FMPLL electrical characteristics**

| Symbol   | C | Parameter  | Conditions <sup>1</sup>                       | Value |                      | Unit |
|--|---|--|---|-------|----------------------|------|
|  |   |  |   | Min   | Max                  |      |
| f <sub>ref_crystal</sub><br>f <sub>ref_ext</sub> | D | PLL reference frequency range <sup>2</sup>               | Crystal reference                             | 4     | 40                   | MHz  |
| f <sub>PLLIN</sub>                               | D | Phase detector input frequency range (after pre-divider) | —   | 4     | 16                   | MHz  |
| f <sub>FMPLLOUT</sub>                            | D | Clock frequency range in normal mode                     | —   | 16    | 120                  | MHz  |
| f <sub>FREE</sub>                                | P | Free-running frequency                                   | Measured using clock division — typically /16 | 20    | 150                  | MHz  |
| t <sub>CYC</sub>                                 | D | System clock period                                      | —   | —     | 1 / f <sub>SYS</sub> | ns   |
| f <sub>LORL</sub><br>f <sub>LORH</sub>           | D | Loss of reference frequency window <sup>3</sup>          | Lower limit                                   | 1.6   | 3.7                  | MHz  |
|  |   |  | Upper limit                                   | 24    | 56                   |      |
| f <sub>SCM</sub>                                 | D | Self-clocked mode frequency <sup>4,5</sup>               | —   | 20    | 150                  | MHz  |

**Table 29. FMPLL electrical characteristics (continued)**

| Symbol                             | C | Parameter                               |  | Conditions <sup>1</sup>  | Value |                    | Unit                  |
|------------------------------------|---|---|--|--|-------|--------------------|-----------------------|
|                                    |   |   |  |  | Min   | Max                |                       |
| C <sub>JITTER</sub>                | T | CLKOUT period jitter <sup>6,7,8,9</sup> | Short-term jitter <sup>10</sup>            | f <sub>SYS</sub> maximum   | -4    | 4                  | % f <sub>CLKOUT</sub> |
|                                    |   |   | Long-term jitter (avg. over 2 ms interval) | f <sub>PLLIN</sub> = 16 MHz (resonator), f <sub>PLLCLK</sub> at 64 MHz, 4,000 cycles | —     | 10                 | ns                    |
| t <sub>pll</sub>                   | D | PLL lock time <sup>11, 12</sup>         |  | —  | —     | 200                | μs                    |
| t <sub>dc</sub>                    | D | Duty cycle of reference                 |  | —  | 40    | 60                 | %                     |
| f <sub>LCK</sub>                   | D | Frequency LOCK range                    |  | —  | -6    | 6                  | % f <sub>SYS</sub>    |
| f <sub>UL</sub>                    | D | Frequency un-LOCK range                 |  | —  | -18   | 18                 | % f <sub>SYS</sub>    |
| f <sub>CS</sub><br>f <sub>DS</sub> | D | Modulation depth                        |  | Center spread  | ±0.25 | ±4.0 <sup>13</sup> | % f <sub>SYS</sub>    |
|                                    |   |   |  | Down spread  | -0.5  | -8.0               |                       |
| f <sub>MOD</sub>                   | D | Modulation frequency <sup>14</sup>      |  | —  | —     | 70                 | kHz                   |

<sup>1</sup> V<sub>DD\_LV\_CORx</sub> = 1.2 V ±10%; V<sub>SS</sub> = 0 V; T<sub>A</sub> = -40 to 125 °C, unless otherwise specified

<sup>2</sup> Considering operation with PLL not bypassed

<sup>3</sup> “Loss of Reference Frequency” window is the reference frequency range outside of which the PLL is in self-clocked mode.

<sup>4</sup> Self-clocked mode frequency is the frequency that the PLL operates at when the reference frequency falls outside the f<sub>LOR</sub> window.

<sup>5</sup> f<sub>VCO</sub> self clock range is 20–150 MHz. f<sub>SCM</sub> represents f<sub>SYS</sub> after PLL output divider (ERFD) of 2 through 16 in enhanced mode.

<sup>6</sup> This value is determined by the crystal manufacturer and board design.

<sup>7</sup> Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f<sub>SYS</sub>. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via V<sub>DDPLL</sub> and V<sub>SSPLL</sub> and variation in crystal oscillator frequency increase the C<sub>JITTER</sub> percentage for a given interval.

<sup>8</sup> Proper PC board layout procedures must be followed to achieve specifications.

<sup>9</sup> Values are with frequency modulation disabled. If frequency modulation is enabled, jitter is the sum of C<sub>JITTER</sub> and either f<sub>CS</sub> or f<sub>DS</sub> (depending on whether center spread or down spread modulation is enabled).

<sup>10</sup> Short term jitter is measured on the clock rising edge at cycle n and cycle n+4.

<sup>11</sup> This value is determined by the crystal manufacturer and board design. For 4 MHz to 20 MHz crystals specified for this PLL, load capacitors should not exceed these limits.

<sup>12</sup> This specification applies to the period required for the PLL to relock after changing the MFD frequency control bits in the synthesizer control register (SYNCR).

<sup>13</sup> This value is true when operating at frequencies above 60 MHz, otherwise f<sub>CS</sub> is 2% (above 64 MHz).

<sup>14</sup> Modulation depth will be attenuated from depth setting when operating at modulation frequencies above 50 kHz.

### 3.13 16 MHz RC oscillator electrical characteristics

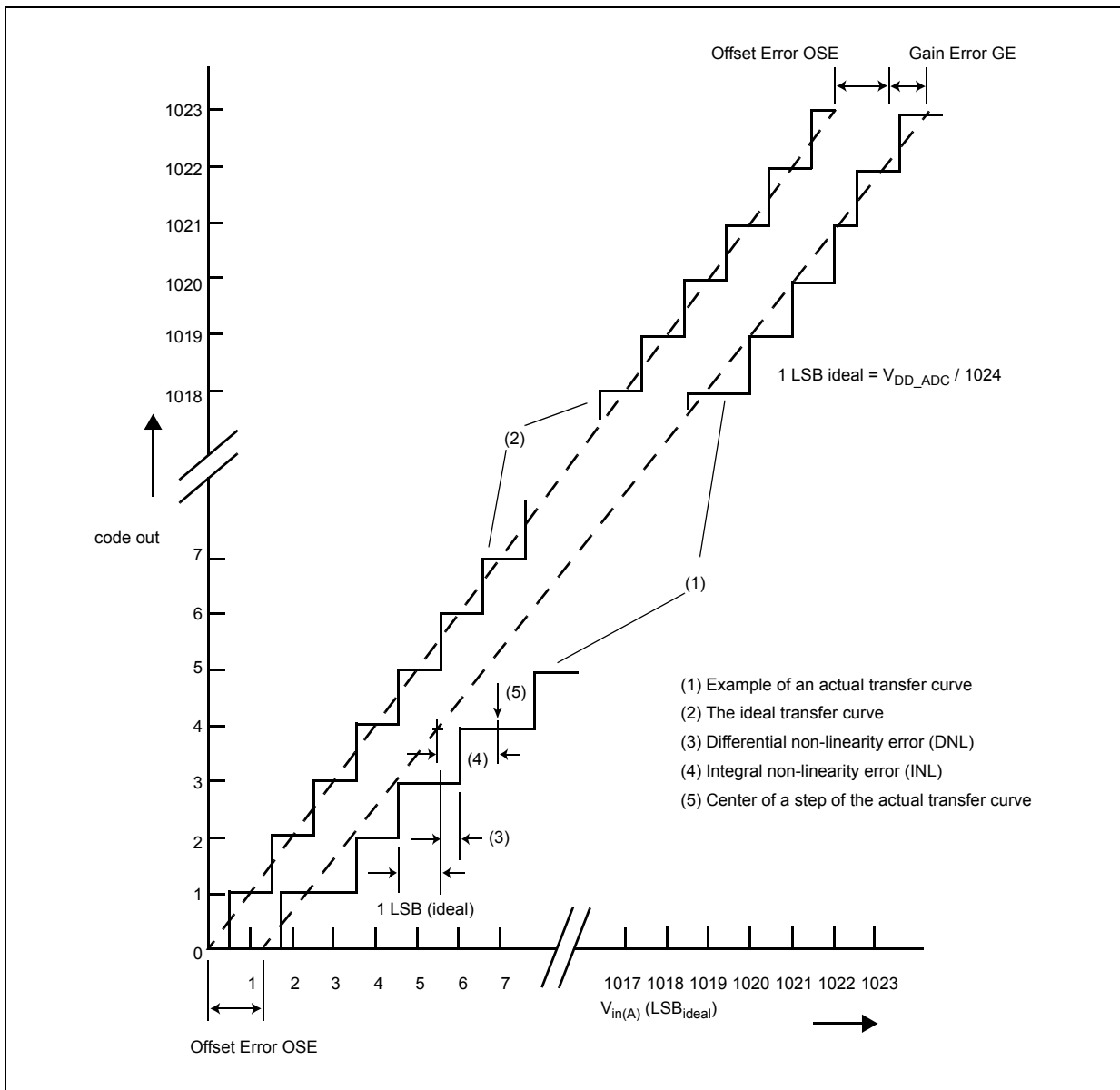
Table 30. 16 MHz RC oscillator electrical characteristics

| Symbol             | C | Parameter  | Conditions                       | Value |     |     | Unit |
|--------------------|---|--|----------------------------------|-------|-----|-----|------|
|                    |   |  |                                  | Min   | Typ | Max |      |
| $f_{RC}$           | P | RC oscillator frequency  | $T_A = 25\text{ }^\circ\text{C}$ | —     | 16  | —   | MHz  |
| $\Delta_{RCMVAR}$  | P | Fast internal RC oscillator variation over temperature and supply with respect to $f_{RC}$ at $T_A = 25\text{ }^\circ\text{C}$ in high-frequency configuration | —                                | -5    | —   | 5   | %    |
| $\Delta_{RCMTRIM}$ | T | Post Trim Accuracy: The variation of the PTF <sup>1</sup> from the 16 MHz  | $T_A = 25\text{ }^\circ\text{C}$ | -1    | —   | 1   | %    |
| $\Delta_{RCMSTEP}$ | T | Fast internal RC oscillator trimming step  | $T_A = 25\text{ }^\circ\text{C}$ | —     | 1.6 | —   | %    |

<sup>1</sup> PTF = Post Trimming Frequency: The frequency of the output clock after trimming at typical supply voltage and temperature

### 3.14 Analog-to-digital converter (ADC) electrical characteristics

The device provides a 10-bit successive approximation register (SAR) analog-to-digital converter.



**Figure 14. ADC characteristics and error definitions**

### 3.14.1 Input impedance and ADC accuracy

To preserve the accuracy of the A/D converter, it is necessary that analog input pins have low AC impedance. Placing a capacitor with good high frequency characteristics at the input pin of the device can be effective: the capacitor should be as large as possible, ideally infinite. This capacitor contributes to attenuating the noise present on the input pin; further, it sources charge during the sampling phase, when the analog signal source is a high-impedance source.

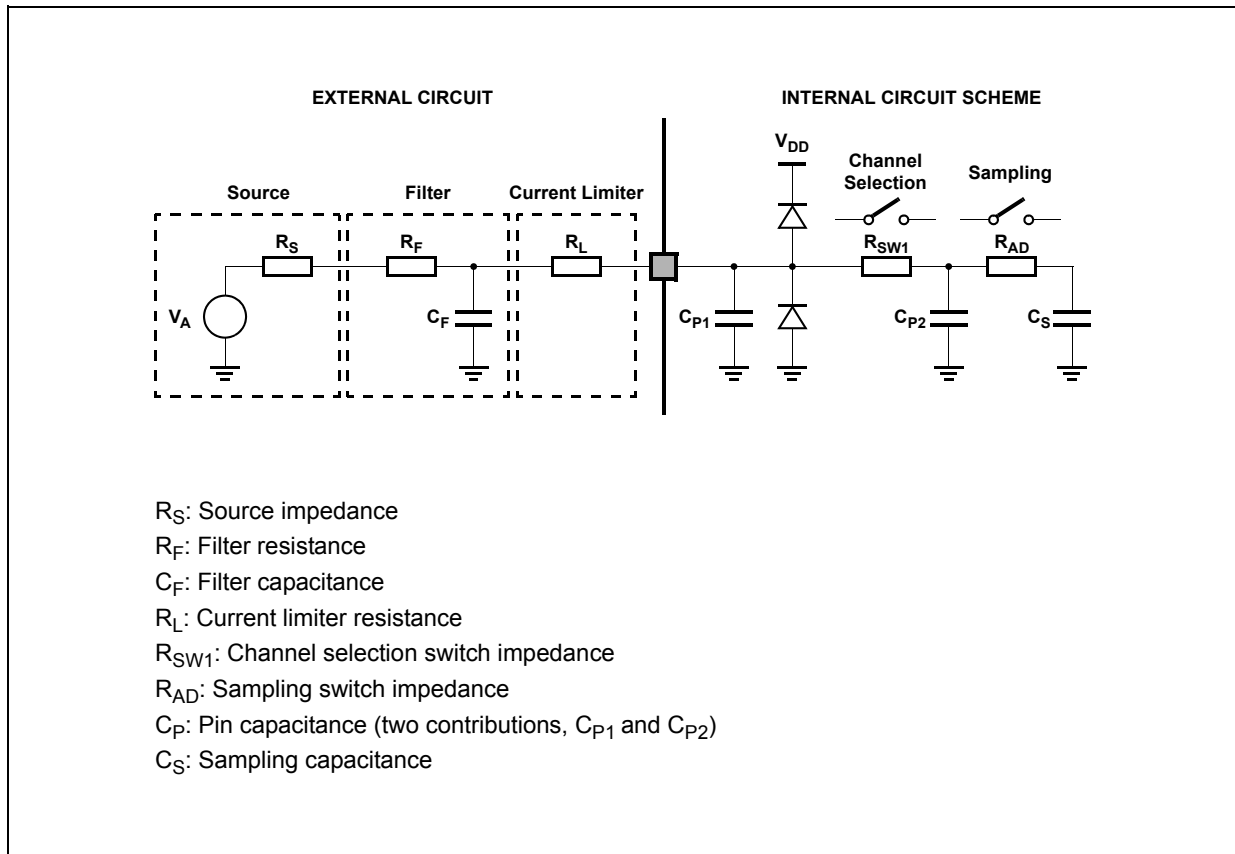
A real filter can typically be obtained by using a series resistance with a capacitor on the input pin (simple RC filter). The RC filtering may be limited according to the source impedance value of the transducer or circuit supplying the analog signal to be measured. The filter at the input pins must be designed taking into account the dynamic characteristics of the input signal (bandwidth) and the equivalent input impedance of the ADC itself.

In fact a current sink contributor is represented by the charge sharing effects with the sampling capacitance:  $C_S$  and  $C_{P2}$  being substantially two switched capacitances, with a frequency equal to the ADC conversion rate, it can be seen as a resistive path to ground. For instance, assuming a conversion rate of 1 MHz, with  $C_S+C_{P2}$  equal to 3 pF, a resistance of 330 k $\Omega$  is obtained ( $R_{EQ} = 1 / (fc \times (C_S+C_{P2}))$ ), where  $fc$  represents the conversion rate at the considered channel). To minimize the error induced by the voltage partitioning between this resistance (sampled voltage on  $C_S+C_{P2}$ ) and the sum of  $R_S + R_F$ , the external circuit must be designed to respect the [Equation 4](#):

**Eqn. 4**

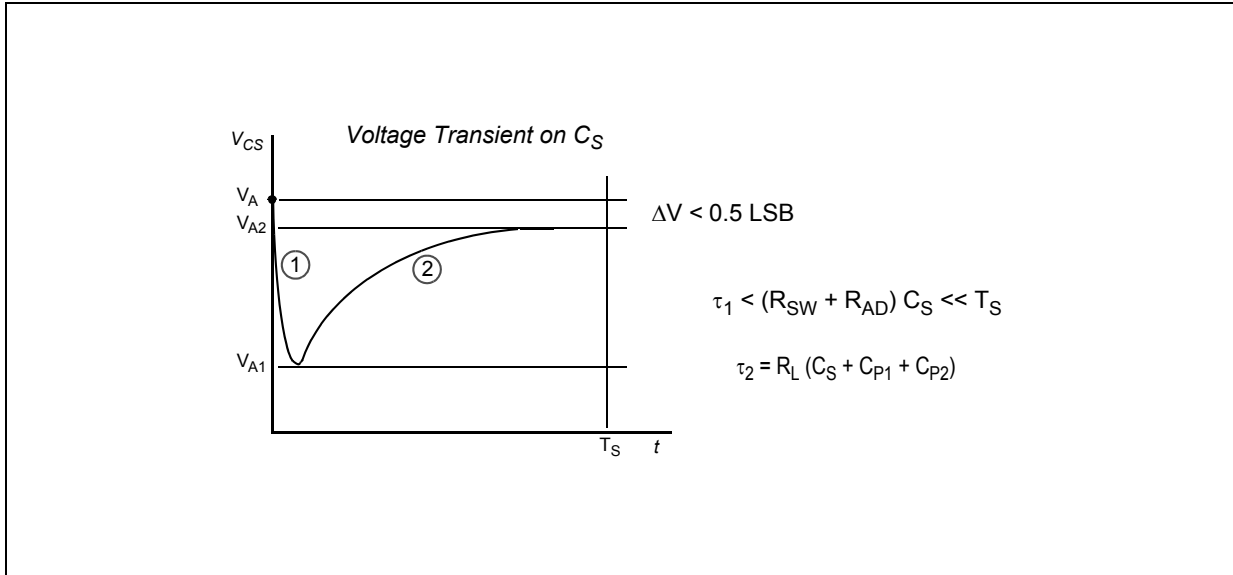
$$V_A \cdot \frac{R_S + R_F}{R_{EQ}} < \frac{1}{2} \text{ LSB}$$

[Equation 4](#) generates a constraint for external network design, in particular on resistive path.



**Figure 15. Input equivalent circuit**

A second aspect involving the capacitance network shall be considered. Assuming the three capacitances  $C_F$ ,  $C_{P1}$  and  $C_{P2}$  are initially charged at the source voltage  $V_A$  (refer to the equivalent circuit reported in [Figure 15](#)): A charge sharing phenomenon is installed when the sampling phase is started (A/D switch closed).



**Figure 16. Transient behavior during sampling phase**

In particular two different transient periods can be distinguished:

- A first and quick charge transfer from the internal capacitance  $C_{P1}$  and  $C_{P2}$  to the sampling capacitance  $C_S$  occurs ( $C_S$  is supposed initially completely discharged): considering a worst case (since the time constant in reality would be faster) in which  $C_{P2}$  is reported in parallel to  $C_{P1}$  (call  $C_P = C_{P1} + C_{P2}$ ), the two capacitances  $C_P$  and  $C_S$  are in series, and the time constant is

**Eqn. 5**

$$\tau_1 = (R_{SW} + R_{AD}) \cdot \frac{C_P \cdot C_S}{C_P + C_S}$$

Equation 5 can again be simplified considering only  $C_S$  as an additional worst condition. In reality, the transient is faster, but the A/D converter circuitry has been designed to be robust also in the very worst case: the sampling time  $T_S$  is always much longer than the internal time constant:

**Eqn. 6**

$$\tau_1 < (R_{SW} + R_{AD}) \cdot C_S \ll T_S$$

The charge of  $C_{P1}$  and  $C_{P2}$  is redistributed also on  $C_S$ , determining a new value of the voltage  $V_{A1}$  on the capacitance according to Equation 7:

**Eqn. 7**

$$V_{A1} \cdot (C_S + C_{P1} + C_{P2}) = V_A \cdot (C_{P1} + C_{P2})$$

- A second charge transfer involves also  $C_F$  (that is typically bigger than the on-chip capacitance) through the resistance  $R_L$ : again considering the worst case in which  $C_{P2}$  and  $C_S$  were in parallel to  $C_{P1}$  (since the time constant in reality would be faster), the time constant is:

**Eqn. 8**

$$\tau_2 < R_L \cdot (C_S + C_{P1} + C_{P2})$$

In this case, the time constant depends on the external circuit: in particular imposing that the transient is completed well before the end of sampling time  $T_S$ , a constraints on  $R_L$  sizing is obtained:

**Eqn. 9**

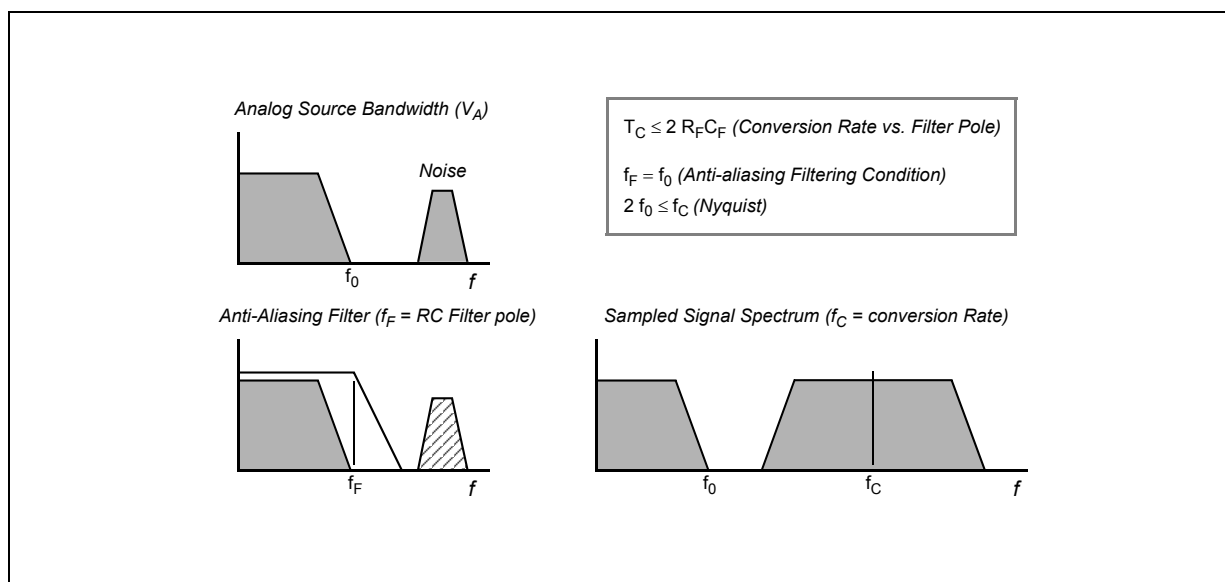
$$8.5 \cdot \tau_2 = 8.5 \cdot R_L \cdot (C_S + C_{P1} + C_{P2}) < T_S$$

Of course,  $R_L$  shall be sized also according to the current limitation constraints, in combination with  $R_S$  (source impedance) and  $R_F$  (filter resistance). Being  $C_F$  definitively bigger than  $C_{P1}$ ,  $C_{P2}$  and  $C_S$ , then the final voltage  $V_{A2}$  (at the end of the charge transfer transient) will be much higher than  $V_{A1}$ . Equation 10 must be respected (charge balance assuming now  $C_S$  already charged at  $V_{A1}$ ):

**Eqn. 10**

$$V_{A2} \cdot (C_S + C_{P1} + C_{P2} + C_F) = V_A \cdot C_F + V_{A1} \cdot (C_{P1} + C_{P2} + C_S)$$

The two transients above are not influenced by the voltage source that, due to the presence of the  $R_F C_F$  filter, is not able to provide the extra charge to compensate the voltage drop on  $C_S$  with respect to the ideal source  $V_A$ ; the time constant  $R_F C_F$  of the filter is very high with respect to the sampling time ( $T_S$ ). The filter is typically designed to act as anti-aliasing.



**Figure 17. Spectral representation of input signal**

Calling  $f_0$  the bandwidth of the source signal (and as a consequence the cut-off frequency of the anti-aliasing filter,  $f_F$ ), according to the Nyquist theorem the conversion rate  $f_C$  must be at least  $2f_0$ ; it means that the constant time of the filter is greater than or at least equal to twice the conversion period ( $T_C$ ). Again the conversion period  $T_C$  is longer than the sampling time  $T_S$ , which is just a portion of it, even when fixed channel continuous conversion mode is selected (fastest conversion rate at a specific channel): in conclusion it is evident that the time constant of the filter  $R_F C_F$  is definitively much higher than the sampling time  $T_S$ , so the charge level on  $C_S$  cannot be modified by the analog signal source during the time in which the sampling switch is closed.

The considerations above lead to impose new constraints on the external circuit, to reduce the accuracy error due to the voltage drop on  $C_S$ ; from the two charge balance equations above, it is simple to derive Equation 11 between the ideal and real sampled voltage on  $C_S$ :

Eqn. 11

$$\frac{V_A}{V_{A2}} = \frac{C_{P1} + C_{P2} + C_F}{C_{P1} + C_{P2} + C_F + C_S}$$

From this formula, in the worst case (when  $V_A$  is maximum, that is for instance 5 V), assuming to accept a maximum error of half a count, a constraint is evident on  $C_F$  value:

Eqn. 12

$$C_F > 2048 \cdot C_S$$

### 3.14.2 ADC conversion characteristics

Table 31. ADC conversion characteristics

| Symbol                 | C  | Parameter   | Conditions <sup>1</sup>   | Value   |       |                                 | Unit |
|------------------------|----|---|---|---|-------|---------------------------------|------|
|                        |    |   |   | Min   | Typ   | Max                             |      |
| $V_{INAN0}$            | SR | ADC0 and shared ADC0/1 analog input voltage <sup>2, 3</sup>   | —   | $V_{SS\_HV\_ADV0}$<br>0<br>-0.3                 | —     | $V_{DD\_HV\_ADV0}$<br>0<br>+0.3 | V    |
| $V_{INAN1}$            | SR | ADC1 analog input voltage <sup>2, 4</sup>   | —   | $V_{SS\_HV\_ADV1}$<br>1<br>-0.3                 | —     | $V_{DD\_HV\_ADV1}$<br>1<br>+0.3 | V    |
| $f_{CK}$               | SR | ADC clock frequency (depends on ADC configuration)<br>(The duty cycle depends on AD_clk <sup>5</sup> frequency) | —   | 3 <sup>6</sup>                                  | —     | 60                              | MHz  |
| $f_s$                  | SR | Sampling frequency  | —   | —   | —     | 1.53                            | MHz  |
| $t_{ADC\_S}$           | —  | D   | Sample time <sup>7</sup>  | $f_{ADC} = 20$ MHz,<br>INPSAMP = 3              | —     | —                               | ns   |
|                        |    |   |   | $f_{ADC} = 9$ MHz,<br>INPSAMP = 255             | —     | —                               | 28.2 |
| $t_{ADC\_C}$           | —  | P   | Conversion time <sup>8</sup>  | $f_{ADC} = 20$ MHz <sup>9</sup> ,<br>INPCMP = 1 | 0.650 | —                               | μs   |
| $t_{ADC\_PU}$          | SR | —   | ADC power-up delay (time needed for ADC to settle exiting from software power down; PWDN bit = 0) | —   | —     | 1.5                             | μs   |
| $C_S$ <sup>10</sup>    | —  | D   | ADC input sampling capacitance  | —   | —     | 2.5                             | pF   |
| $C_{P1}$ <sup>10</sup> | —  | D   | ADC input pin capacitance 1   | —   | —     | 3                               | pF   |
| $C_{P2}$ <sup>10</sup> | —  | D   | ADC input pin capacitance 2   | —   | —     | 1                               | pF   |

**Table 31. ADC conversion characteristics (continued)**

| Symbol                         | C  | Parameter | Conditions <sup>1</sup>                          | Value  |      |     | Unit |     |
|--------------------------------|----|-----------|--|--|------|-----|------|-----|
|                                |    |           |  | Min  | Typ  | Max |      |     |
| R <sub>SW1</sub> <sup>10</sup> | —  | D         | Internal resistance of analog source             | V <sub>DD_HV_ADC</sub> = 5 V ± 10%   | —    | —   | 0.6  | kΩ  |
|                                |    |           |  | V <sub>DD_HV_ADC</sub> = 3.3 V ± 10%   | —    | —   | 3    | kΩ  |
| R <sub>AD</sub> <sup>10</sup>  | —  | D         | Internal resistance of analog source             | —  | —    | 2   | kΩ   |     |
| I <sub>INJ</sub>               | —  | T         | Input current injection                          | Current injection on one ADC input, different from the converted one. Remains within TUE spec. | –5   | —   | 5    | mA  |
| INL                            | CC | P         | Integral non-linearity                           | No overload  | –1.5 | —   | 1.5  | LSB |
| DNL                            | CC | P         | Differential non-linearity                       | No overload  | –1.0 | —   | 1.0  | LSB |
| OSE                            | CC | T         | Offset error                                     | —  | —    | ±1  | —    | LSB |
| GE                             | CC | T         | Gain error                                       | —  | —    | ±1  | —    | LSB |
| TUE                            | CC | P         | Total unadjusted error without current injection | —  | –2.5 | —   | 2.5  | LSB |
| TUE                            | CC | T         | Total unadjusted error with current injection    | —  | –3   | —   | 3    | LSB |

<sup>1</sup> V<sub>DD</sub> = 3.3 V to 3.6 V / 4.5 V to 5.5 V, T<sub>A</sub> = –40 °C to T<sub>A</sub> MAX, unless otherwise specified and analog input voltage from V<sub>SS\_HV\_ADCx</sub> to V<sub>DD\_HV\_ADCx</sub>.

<sup>2</sup> V<sub>AINx</sub> may exceed V<sub>SS\_HV\_AD</sub> and V<sub>DD\_HV\_AD</sub> limits, remaining on absolute maximum ratings, but the results of the conversion will be clamped respectively to 0x000 or 0x3FF.

<sup>3</sup> Not allowed to refer this voltage to V<sub>DD\_HV\_ADV1</sub>, V<sub>SS\_HV\_ADV1</sub>

<sup>4</sup> Not allowed to refer this voltage to V<sub>DD\_HV\_ADV0</sub>, V<sub>SS\_HV\_ADV0</sub>

<sup>5</sup> AD\_clk clock is always half of the ADC module input clock defined via the auxiliary clock divider for the ADC.

<sup>6</sup> When configured to allow 60 MHz ADC, the minimum ADC clock speed is 9 MHz, below which precision is lost.

<sup>7</sup> During the sample time the input capacitance CS can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach its final voltage level within t<sub>ADC\_S</sub>. After the end of the sample time t<sub>ADC\_S</sub>, changes of the analog input voltage have no effect on the conversion result. Values for the sample clock t<sub>ADC\_S</sub> depend on programming.

<sup>8</sup> This parameter includes the sample time t<sub>ADC\_S</sub>.

<sup>9</sup> 20 MHz ADC clock. Specific prescaler is programmed on MC\_PLL\_CLK to provide 20 MHz clock to the ADC.

<sup>10</sup> See Figure 15.

### 3.15 Flash memory electrical characteristics

Table 32. Program and erase specifications

| Symbol                   | C | Parameter                                       | Value |                      |                          |                  | Unit |
|--------------------------|---|---|-------|----------------------|--------------------------|------------------|------|
|                          |   |   | Min   | Typical <sup>1</sup> | Initial max <sup>2</sup> | Max <sup>3</sup> |      |
| T <sub>dwprogram</sub>   | P | Double Word (64 bits) Program Time <sup>4</sup> | —     | 22                   | 50                       | 500              | μs   |
| T <sub>BKPRG</sub>       | P | Bank Program (512 KB) <sup>4, 5</sup>           | —     | 1.45                 | 1.65                     | 33               | s    |
|                          | P | Bank Program (64 KB) <sup>4, 5</sup>            | —     | 0.18                 | 0.21                     | 4.10             | s    |
| T <sub>16kpperase</sub>  | P | 16 KB Block Pre-program and Erase Time          | —     | 300                  | 500                      | 5000             | ms   |
| T <sub>32kpperase</sub>  | P | 32 KB Block Pre-program and Erase Time          | —     | 400                  | 600                      | 5000             | ms   |
| T <sub>128kpperase</sub> | P | 128 KB Block Pre-program and Erase Time         | —     | 800                  | 1300                     | 7500             | ms   |

- <sup>1</sup> Typical program and erase times assume nominal supply values and operation at 25 °C. All times are subject to change pending device characterization.
- <sup>2</sup> Initial factory condition: < 100 program/erase cycles, 25 °C, typical supply voltage.
- <sup>3</sup> The maximum program and erase times occur after the specified number of program/erase cycles. These maximum values are characterized but not guaranteed.
- <sup>4</sup> Actual hardware programming times. This does not include software overhead.
- <sup>5</sup> Typical Bank programming time assumes that all cells are programmed in a single pulse. In reality some cells will require more than one pulse, adding a small overhead to total bank programming time (see Initial Max column).

Table 33. Flash memory module life

| Symbol    | C | Parameter   | Conditions                     | Value   |         | Unit   |
|-----------|---|---|--------------------------------|---------|---------|--------|
|           |   |   |                                | Min     | Typ     |        |
| P/E       | C | Number of program/erase cycles per block for 16 KB blocks over the operating temperature range (T <sub>J</sub> )  | —                              | 100,000 | —       | cycles |
| P/E       | C | Number of program/erase cycles per block for 32 KB blocks over the operating temperature range (T <sub>J</sub> )  | —                              | 10,000  | 100,000 | cycles |
| P/E       | C | Number of program/erase cycles per block for 128 KB blocks over the operating temperature range (T <sub>J</sub> ) | —                              | 1,000   | 100,000 | cycles |
| Retention | C | Minimum data retention at 85 °C average ambient temperature <sup>1</sup>  | Blocks with 0–1,000 P/E cycles | 20      | —       | years  |
|           |   |   | Blocks with 10,000 P/E cycles  | 10      | —       | years  |
|           |   |   | Blocks with 100,000 P/E cycles | 5       | —       | years  |

<sup>1</sup> Ambient temperature averaged over duration of application, not to exceed recommended product operating temperature range.

**Table 34. Flash memory read access timing**

| Symbol           | C | Parameter  | Conditions <sup>1</sup> | Max value | Unit |
|------------------|---|--|-------------------------|-----------|------|
| f <sub>max</sub> | C | Maximum working frequency at given number of wait states in worst conditions | 2 wait states           | 66        | MHz  |
|                  |   |  | 0 wait states           | 18        |      |

<sup>1</sup> V<sub>DD</sub> = 3.3 V ± 10% / 5.0 V ± 10%, T<sub>A</sub> = -40 to 125 °C, unless otherwise specified

## 3.16 AC specifications

### 3.16.1 Pad AC specifications

**Table 35. Output pin transition times**

| Symbol                        | C  | Parameter   | Conditions <sup>1</sup>                    | Value  |     |     | Unit |    |
|-------------------------------|----|---|--|--|-----|-----|------|----|
|                               |    |   |  | Min  | Typ | Max |      |    |
| t <sub>tr</sub>               | CC | Output transition time output pin <sup>2</sup><br>SLOW configuration      | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 5.0 V ± 10%,<br>PAD3V5V = 0                      | —   | —   | 50   | ns |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 100  |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 125  |    |
|                               |    |   | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 3.3 V ± 10%,<br>PAD3V5V = 1                      | —   | —   | 40   |    |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 50   |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 75   |    |
| t <sub>tr</sub>               | CC | Output transition time output pin <sup>2</sup><br>MEDIUM configuration    | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 5.0 V ± 10%,<br>PAD3V5V = 0<br>SIUL.PCRx.SRC = 1 | —   | —   | 10   | ns |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 20   |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 40   |    |
|                               |    |   | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 3.3 V ± 10%,<br>PAD3V5V = 1<br>SIUL.PCRx.SRC = 1 | —   | —   | 12   |    |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 25   |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 40   |    |
| t <sub>tr</sub>               | CC | Output transition time output pin <sup>2</sup><br>FAST configuration      | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 5.0 V ± 10%,<br>PAD3V5V = 0<br>SIUL.PCRx.SRC = 1 | —   | —   | 4    | ns |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 6    |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 12   |    |
|                               |    |   | C <sub>L</sub> = 25 pF                     | V <sub>DD</sub> = 3.3 V ± 10%,<br>PAD3V5V = 1<br>SIUL.PCRx.SRC = 1 | —   | —   | 4    |    |
|                               |    |   | C <sub>L</sub> = 50 pF                     |  | —   | —   | 7    |    |
|                               |    |   | C <sub>L</sub> = 100 pF                    |  | —   | —   | 12   |    |
| t <sub>SYM</sub> <sup>3</sup> | CC | Symmetric transition time, same drive strength between N and P transistor | V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0 | —  | —   | 4   | ns   |    |
|                               |    |   | V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1 | —  | —   | 5   |      |    |

<sup>1</sup> V<sub>DD</sub> = 3.3 V ± 10% / 5.0 V ± 10%, T<sub>A</sub> = -40 °C to T<sub>A</sub> MAX, unless otherwise specified

<sup>2</sup> C<sub>L</sub> includes device and package capacitances (C<sub>PKG</sub> < 5 pF).

<sup>3</sup> Transition timing of both positive and negative slopes will differ maximum 50%

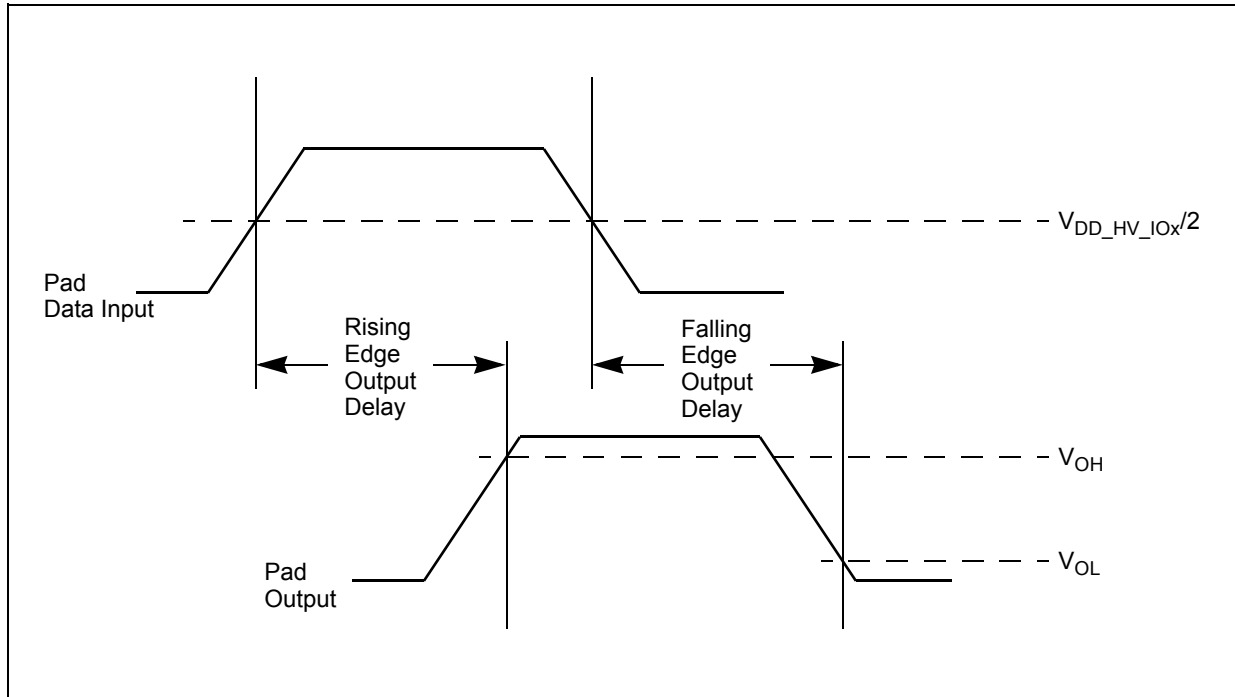


Figure 18. Pad output delay

### 3.17 AC timing characteristics

#### 3.17.1 $\overline{\text{RESET}}$ pin characteristics

The MPC5604P implements a dedicated bidirectional  $\overline{\text{RESET}}$  pin.

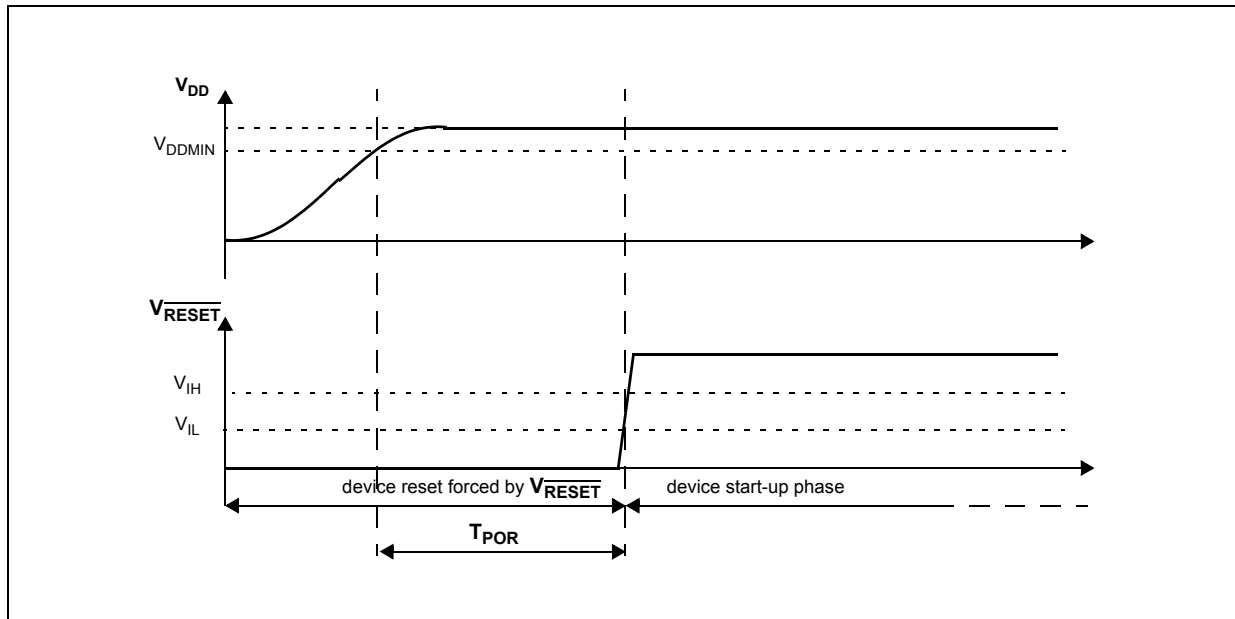


Figure 19. Start-up reset requirements

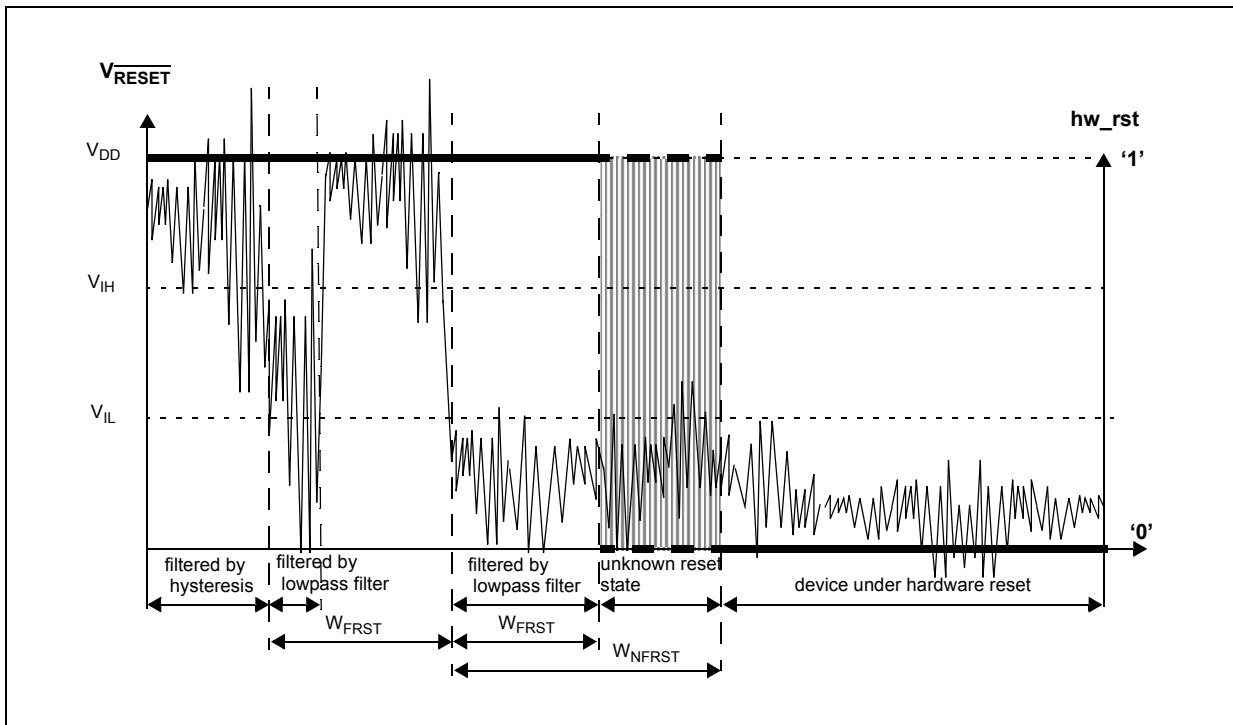


Figure 20. Noise filtering on reset signal

Table 36.  $\overline{\text{RESET}}$  electrical characteristics

| Symbol    | C  | Parameter | Conditions <sup>1</sup>  | Value  |     |              | Unit        |   |
|-----------|----|-----------|--|--|-----|--------------|-------------|---|
|           |    |           |  | Min  | Typ | Max          |             |   |
| $V_{IH}$  | SR | P         | Input High Level CMOS (Schmitt Trigger)  | $0.65V_{DD}$   | —   | $V_{DD}+0.4$ | V           |   |
| $V_{IL}$  | SR | P         | Input low Level CMOS (Schmitt Trigger)   | -0.4   | —   | $0.35V_{DD}$ | V           |   |
| $V_{HYS}$ | CC | C         | Input hysteresis CMOS (Schmitt Trigger)  | $0.1V_{DD}$  | —   | —            | V           |   |
| $V_{OL}$  | CC | P         | Output low level   | Push Pull, $I_{OL} = 2\text{mA}$ ,<br>$V_{DD} = 5.0\text{ V} \pm 10\%$ , $\text{PAD3V5V} = 0$<br>(recommended) | —   | —            | $0.1V_{DD}$ | V |
|           |    |           | Push Pull, $I_{OL} = 1\text{mA}$ ,<br>$V_{DD} = 5.0\text{ V} \pm 10\%$ , $\text{PAD3V5V} = 1^2$                | —  | —   | $0.1V_{DD}$  |             |   |
|           |    |           | Push Pull, $I_{OL} = 1\text{mA}$ ,<br>$V_{DD} = 3.3\text{ V} \pm 10\%$ , $\text{PAD3V5V} = 1$<br>(recommended) | —  | —   | 0.5          |             |   |

**Table 36. RESET electrical characteristics (continued)**

| Symbol             | C  | Parameter   | Conditions <sup>1</sup>   | Value |     |     | Unit |
|--------------------|----|---|---|-------|-----|-----|------|
|                    |    |   |   | Min   | Typ | Max |      |
| t <sub>tr</sub>    | CC | D Output transition time output pin <sup>3</sup><br>MEDIUM configuration                            | C <sub>L</sub> = 25pF,<br>V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0  | —     | —   | 10  | ns   |
|                    |    |   | C <sub>L</sub> = 50pF,<br>V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0  | —     | —   | 20  |      |
|                    |    |   | C <sub>L</sub> = 100pF,<br>V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0 | —     | —   | 40  |      |
|                    |    |   | C <sub>L</sub> = 25pF,<br>V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1  | —     | —   | 12  |      |
|                    |    |   | C <sub>L</sub> = 50pF,<br>V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1  | —     | —   | 25  |      |
|                    |    |   | C <sub>L</sub> = 100pF,<br>V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1 | —     | —   | 40  |      |
| W <sub>FRST</sub>  | SR | P RESET input filtered pulse  | —   | —     | —   | 40  | ns   |
| W <sub>NFRST</sub> | SR | P RESET input not filtered pulse  | —   | 500   | —   | —   | ns   |
| t <sub>POR</sub>   | CC | D Maximum delay before internal reset is released after all V <sub>DD_HV</sub> reach nominal supply | Monotonic V <sub>DD_HV</sub> supply ramp                              | —     | —   | 1   | ms   |
| I <sub>WPUL</sub>  | CC | P Weak pull-up current absolute value   | V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1                            | 10    | —   | 150 | μA   |
|                    |    |   | V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0                            | 10    | —   | 150 |      |
|                    |    |   | V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 1 <sup>4</sup>               | 10    | —   | 250 |      |

<sup>1</sup> V<sub>DD</sub> = 3.3 V ± 10% / 5.0 V ± 10%, T<sub>A</sub> = -40 °C to T<sub>A MAX</sub>, unless otherwise specified

<sup>2</sup> This is a transient configuration during power-up, up to the end of reset PHASE2 (refer to RGM module section of device reference manual).

<sup>3</sup> C<sub>L</sub> includes device and package capacitance (C<sub>PKG</sub> < 5 pF).

<sup>4</sup> The configuration PAD3V5 = 1 when V<sub>DD</sub> = 5 V is only transient configuration during power-up. All pads but RESET and Nexus output (MDOx, EVTO, MCKO) are configured in input or in high impedance state.

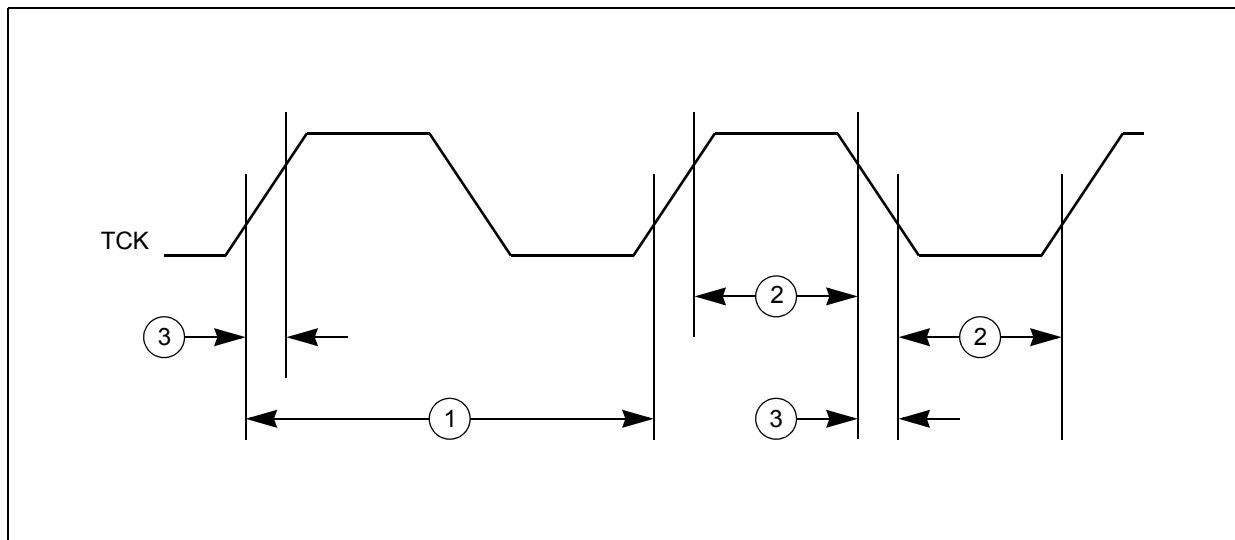
### 3.17.2 IEEE 1149.1 interface timing

**Table 37. JTAG pin AC electrical characteristics**

| No. | Symbol                                | C  | Parameter   | Conditions | Value |     | Unit |
|-----|---------------------------------------|----|---|------------|-------|-----|------|
|     |                                       |    |   |            | Min   | Max |      |
| 1   | t <sub>JCYC</sub>                     | CC | D TCK cycle time  | —          | 100   | —   | ns   |
| 2   | t <sub>JDC</sub>                      | CC | D TCK clock pulse width (measured at V <sub>DD_HV_IOx/2</sub> ) | —          | 40    | 60  | ns   |
| 3   | t <sub>TCKRISE</sub>                  | CC | D TCK rise and fall times (40% – 70%)                           | —          | —     | 3   | ns   |
| 4   | t <sub>TMSS</sub> , t <sub>TDIS</sub> | CC | D TMS, TDI data setup time                                      | —          | 5     | —   | ns   |

**Table 37. JTAG pin AC electrical characteristics (continued)**

| No. | Symbol               | C  | D | Parameter  | Conditions | Value |     | Unit |
|-----|----------------------|----|---|--|------------|-------|-----|------|
|     |                      |    |   |  |            | Min   | Max |      |
| 5   | $t_{TMSH}, t_{TDIH}$ | CC | D | TMS, TDI data hold time                                | —          | 25    | —   | ns   |
| 6   | $t_{TDOV}$           | CC | D | TCK low to TDO data valid                              | —          | —     | 40  | ns   |
| 7   | $t_{TDOI}$           | CC | D | TCK low to TDO data invalid                            | —          | 0     | —   | ns   |
| 8   | $t_{TDOHZ}$          | CC | D | TCK low to TDO high impedance                          | —          | 40    | —   | ns   |
| 11  | $t_{BSDV}$           | CC | D | TCK falling edge to output valid                       | —          | —     | 50  | ns   |
| 12  | $t_{BSDVZ}$          | CC | D | TCK falling edge to output valid out of high impedance | —          | —     | 50  | ns   |
| 13  | $t_{BSDHZ}$          | CC | D | TCK falling edge to output high impedance              | —          | —     | 50  | ns   |
| 14  | $t_{BSDST}$          | CC | D | Boundary scan input valid to TCK rising edge           | —          | 50    | —   | ns   |
| 15  | $t_{BSDHT}$          | CC | D | TCK rising edge to boundary scan input invalid         | —          | 50    | —   | ns   |



**Figure 21. JTAG test clock input timing**

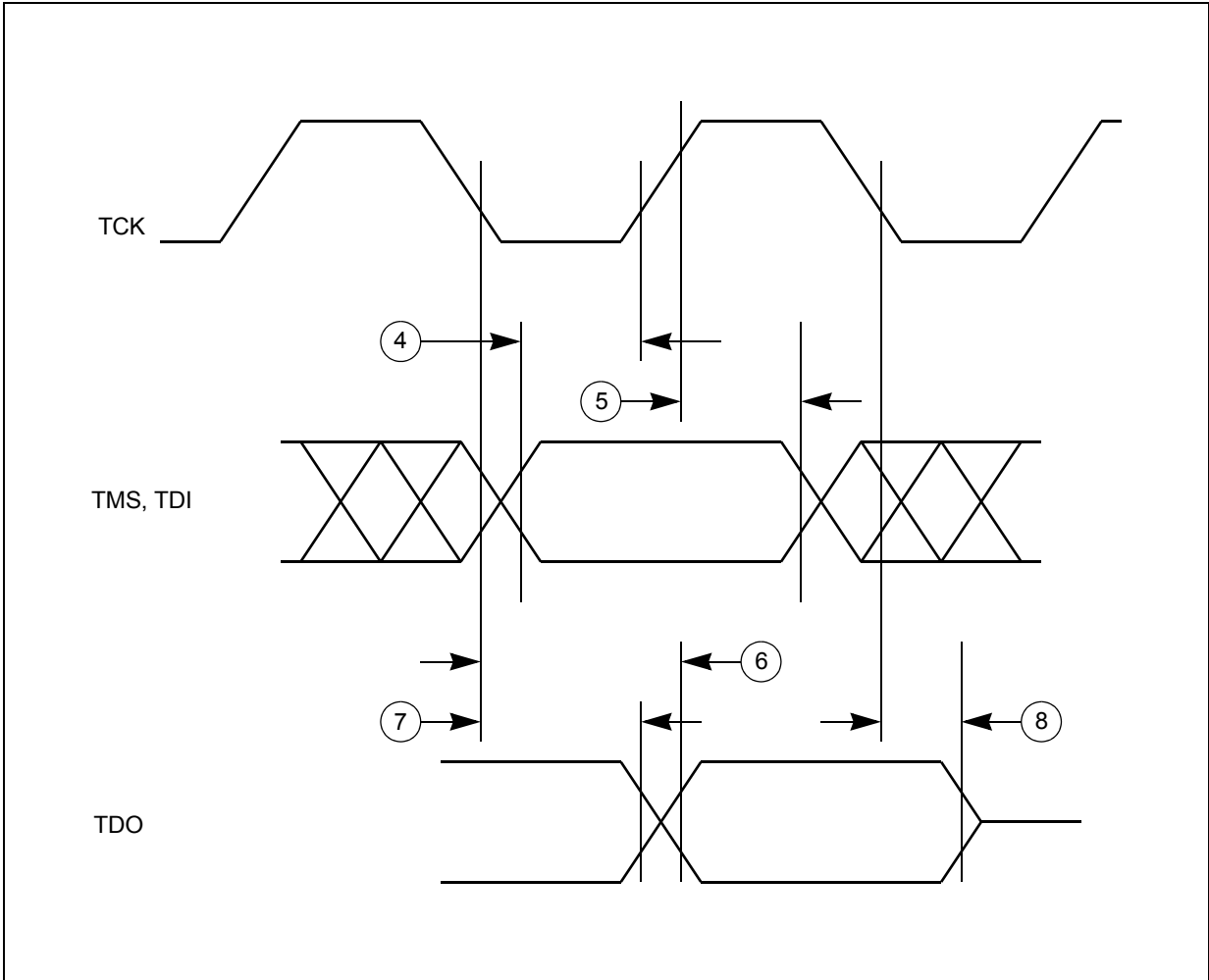


Figure 22. JTAG test access port timing

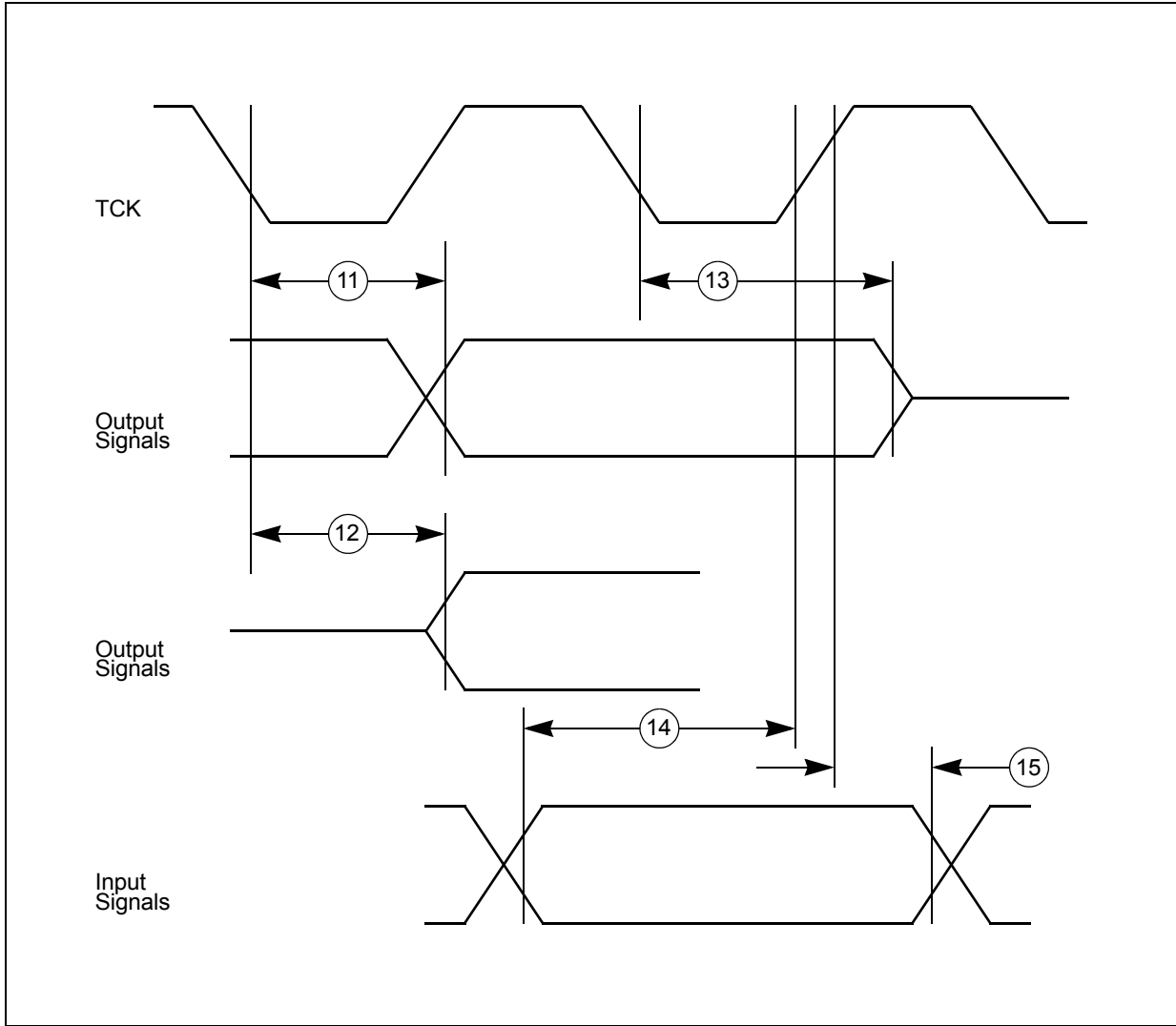


Figure 23. JTAG boundary scan timing

### 3.17.3 Nexus timing

Table 38. Nexus debug port timing<sup>1</sup>

| No. | Symbol      | C  | Parameter | Value   |                 |     | Unit |    |
|-----|-------------|----|-----------|---|-----------------|-----|------|----|
|     |             |    |           | Min   | Typ             | Max |      |    |
| 1   | $t_{MCCY}$  | CC | D         | MCKO cycle time                                       | 32              | —   | —    | ns |
| 2   | $t_{MDOV}$  | CC | D         | MCKO low to MDO data valid <sup>2</sup>               | —               | —   | 6    | ns |
| 3   | $t_{MSEOV}$ | CC | D         | MCKO low to $\overline{MSEO}$ data valid <sup>2</sup> | —               | —   | 6    | ns |
| 4   | $t_{EVTOV}$ | CC | D         | MCKO low to $\overline{EVTO}$ data valid <sup>2</sup> | —               | —   | 6    | ns |
| 5   | $t_{TCYC}$  | CC | D         | TCK cycle time  | 64 <sup>3</sup> | —   | —    | ns |

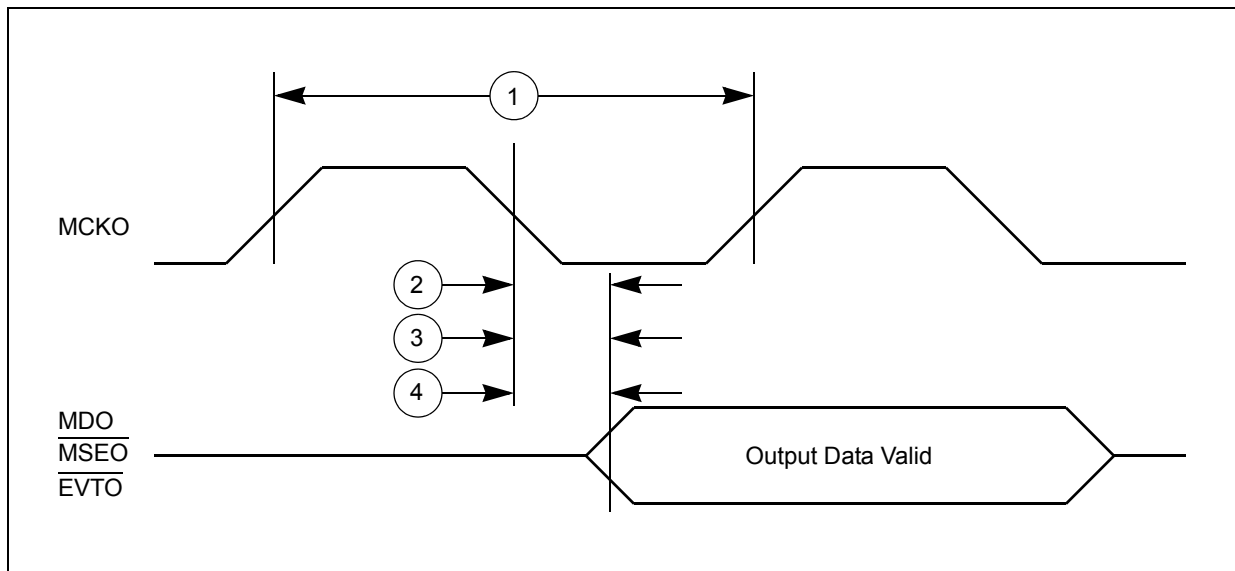
**Table 38. Nexus debug port timing<sup>1</sup> (continued)**

| No. | Symbol      | C  | Parameter | Value                       |     |     | Unit |    |
|-----|-------------|----|-----------|-----------------------------|-----|-----|------|----|
|     |             |    |           | Min                         | Typ | Max |      |    |
| 6   | $t_{NTDIS}$ | CC | D         | TDI data setup time         | 6   | —   | —    | ns |
|     | $t_{NTMSS}$ | CC | D         | TMS data setup time         | 6   | —   | —    | ns |
| 7   | $t_{NTDIH}$ | CC | D         | TDI data hold time          | 10  | —   | —    | ns |
|     | $t_{NTMSH}$ | CC | D         | TMS data hold time          | 10  | —   | —    | ns |
| 8   | $t_{TDOV}$  | CC | D         | TCK low to TDO data valid   | —   | —   | 35   | ns |
| 9   | $t_{TDOI}$  | CC | D         | TCK low to TDO data invalid | 6   | —   | —    | ns |

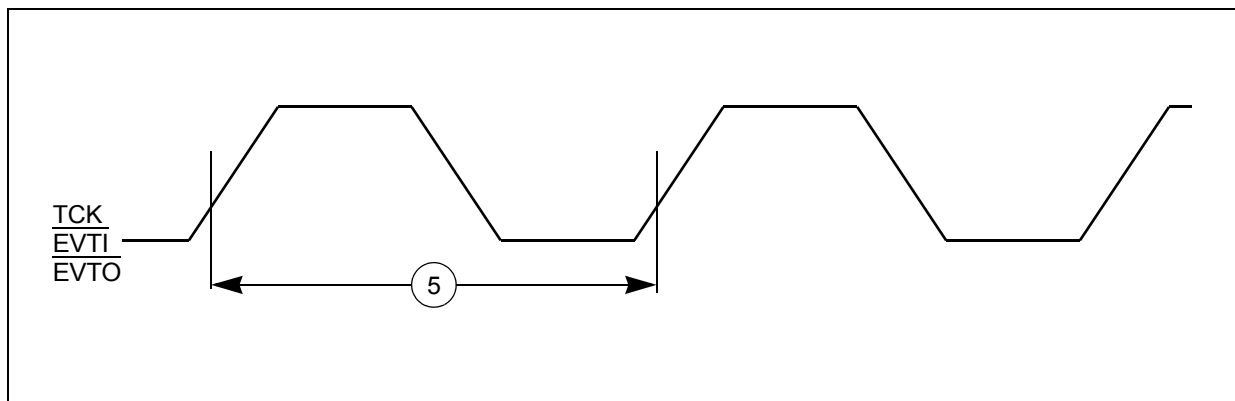
<sup>1</sup> All Nexus timing relative to MCKO is measured from 50% of MCKO and 50% of the respective signal.

<sup>2</sup>  $\overline{MDO}$ ,  $\overline{MSEO}$ , and  $\overline{EVTO}$  data is held valid until next MCKO low cycle.

<sup>3</sup> Lower frequency is required to be fully compliant to standard.



**Figure 24. Nexus output timing**



**Figure 25. Nexus event trigger and test clock timings**

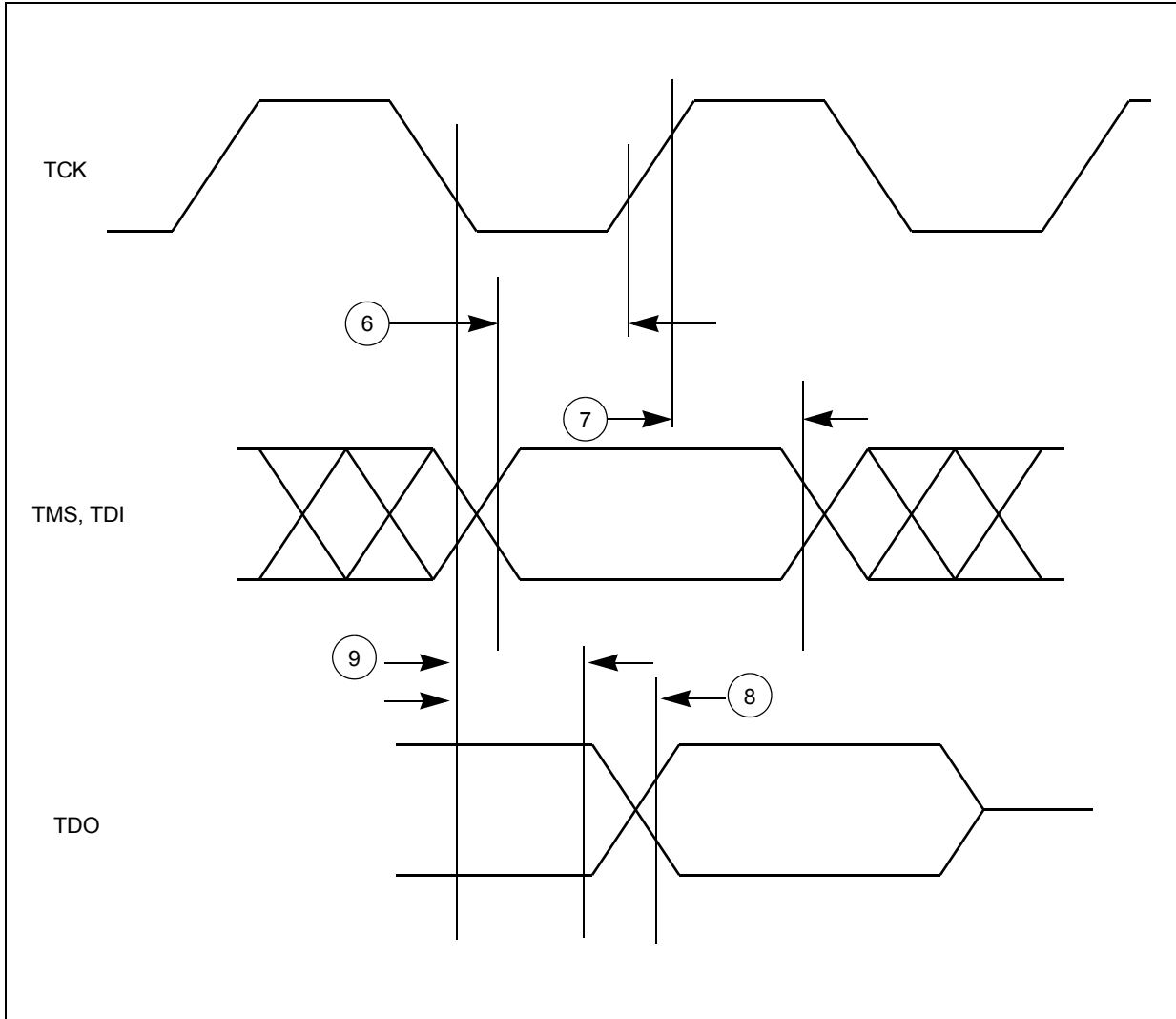


Figure 26. Nexus TDI, TMS, TDO timing

### 3.17.4 External interrupt timing (IRQ pin)

Table 39. External interrupt timing<sup>1</sup>

| No. | Symbol     | C  | Parameter | Conditions                         | Value     |     | Unit      |
|-----|------------|----|-----------|------------------------------------|-----------|-----|-----------|
|     |            |    |           |                                    | Min       | Max |           |
| 1   | $t_{IPWL}$ | CC | D         | IRQ pulse width low                | 4         | —   | $t_{CYC}$ |
| 2   | $t_{IPWH}$ | CC | D         | IRQ pulse width high               | 4         | —   | $t_{CYC}$ |
| 3   | $t_{ICYC}$ | CC | D         | IRQ edge to edge time <sup>2</sup> | $4 + N^3$ | —   | $t_{CYC}$ |

<sup>1</sup> IRQ timing specified at  $f_{SYS} = 64$  MHz and  $V_{DD\_HV\_IOx} = 3.0$  V to 5.5 V,  $T_A = T_L$  to  $T_H$ , and  $C_L = 200$  pF with SRC = 0b00.

<sup>2</sup> Applies when IRQ pins are configured for rising edge or falling edge events, but not both.

<sup>3</sup> N = ISR time to clear the flag

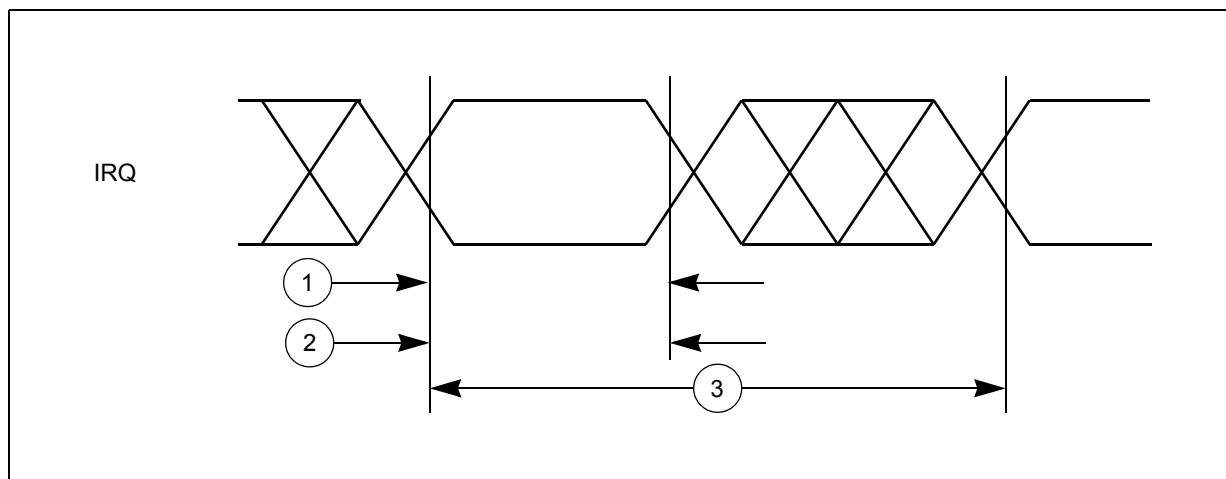


Figure 27. External interrupt timing

### 3.17.5 DSPI timing

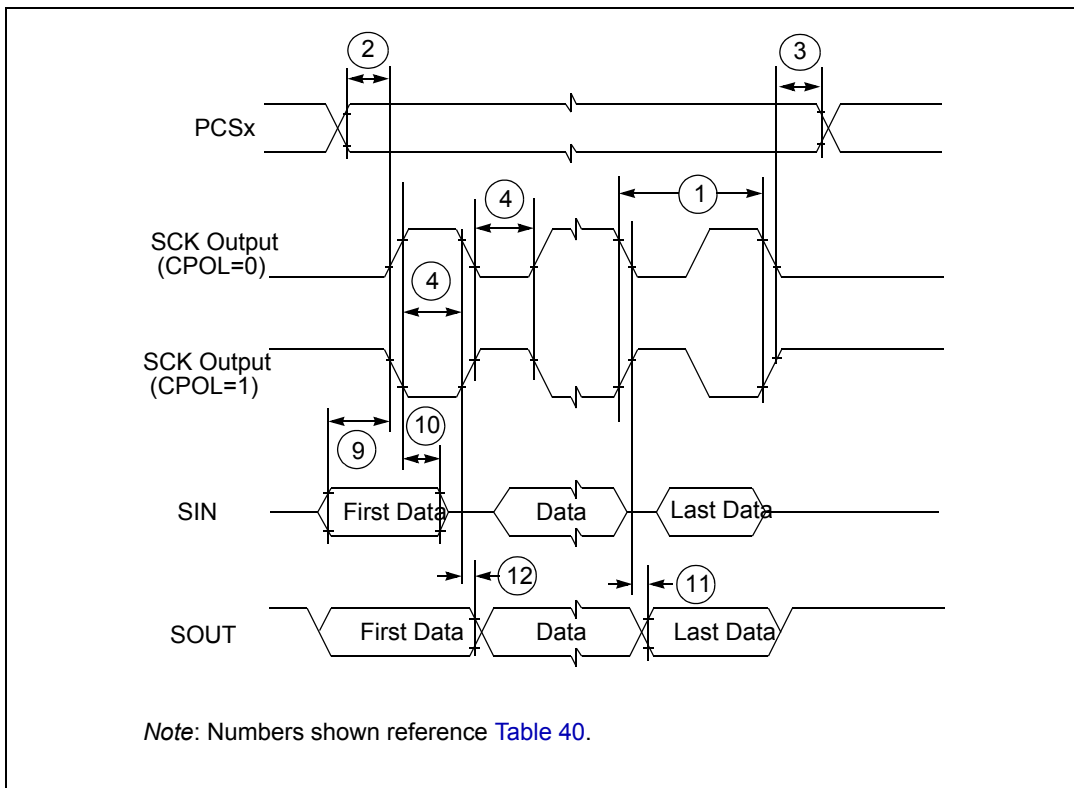
Table 40. DSPI timing<sup>1</sup>

| No. | Symbol            | C  | Parameter | Conditions                     | Value  |                        | Unit                   |    |
|-----|-------------------|----|-----------|--------------------------------|--|------------------------|------------------------|----|
|     |                   |    |           |                                | Min  | Max                    |                        |    |
| 1   | t <sub>SCK</sub>  | CC | D         | DSPI cycle time                | Master (MTFE = 0)  | 60                     | —                      | ns |
|     |                   |    |           |                                | Slave (MTFE = 0)   | 60                     | —                      |    |
| 2   | t <sub>CSC</sub>  | CC | D         | CS to SCK delay                | —  | 16                     | —                      | ns |
| 3   | t <sub>ASC</sub>  | CC | D         | After SCK delay                | —  | 26                     | —                      | ns |
| 4   | t <sub>SDC</sub>  | CC | D         | SCK duty cycle                 | —  | 0.4 * t <sub>SCK</sub> | 0.6 * t <sub>SCK</sub> | ns |
| 5   | t <sub>A</sub>    | CC | D         | Slave access time              | $\overline{SS}$ active to SOUT valid                       | —                      | 30                     | ns |
| 6   | t <sub>DIS</sub>  | CC | D         | Slave SOUT disable time        | $\overline{SS}$ inactive to SOUT high impedance or invalid | —                      | 16                     | ns |
| 7   | t <sub>PCSC</sub> | CC | D         | PCSx to $\overline{PCSS}$ time | —  | 13                     | —                      | ns |
| 8   | t <sub>PASC</sub> | CC | D         | $\overline{PCSS}$ to PCSx time | —  | 13                     | —                      | ns |
| 9   | t <sub>SUI</sub>  | CC | D         | Data setup time for inputs     | Master (MTFE = 0)  | 35                     | —                      | ns |
|     |                   |    |           |                                | Slave  | 4                      | —                      |    |
|     |                   |    |           |                                | Master (MTFE = 1, CPHA = 0)                                | 35                     | —                      |    |
|     |                   |    |           |                                | Master (MTFE = 1, CPHA = 1)                                | 35                     | —                      |    |
| 10  | t <sub>HI</sub>   | CC | D         | Data hold time for inputs      | Master (MTFE = 0)  | -5                     | —                      | ns |
|     |                   |    |           |                                | Slave  | 4                      | —                      |    |
|     |                   |    |           |                                | Master (MTFE = 1, CPHA = 0)                                | 11                     | —                      |    |
|     |                   |    |           |                                | Master (MTFE = 1, CPHA = 1)                                | -5                     | —                      |    |

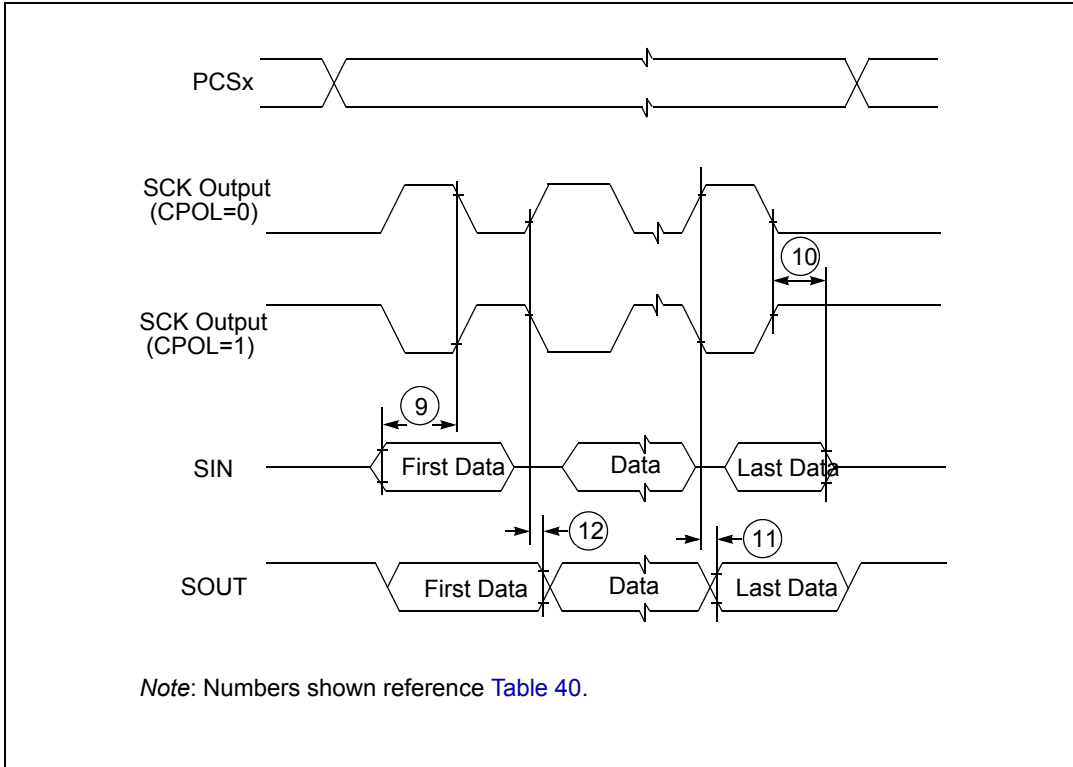
**Table 40. DSPI timing<sup>1</sup> (continued)**

| No. | Symbol           | C  | Parameter | Conditions                  | Value                       |     | Unit |    |
|-----|------------------|----|-----------|-----------------------------|-----------------------------|-----|------|----|
|     |                  |    |           |                             | Min                         | Max |      |    |
| 11  | t <sub>SUO</sub> | CC | D         | Data valid (after SCK edge) | Master (MTFE = 0)           | —   | 12   | ns |
|     |                  |    |           |                             | Slave                       | —   | 36   |    |
|     |                  |    |           |                             | Master (MTFE = 1, CPHA = 0) | —   | 12   |    |
|     |                  |    |           |                             | Master (MTFE = 1, CPHA = 1) | —   | 12   |    |
| 12  | t <sub>HO</sub>  | CC | D         | Data hold time for outputs  | Master (MTFE = 0)           | -2  | —    | ns |
|     |                  |    |           |                             | Slave                       | 6   | —    |    |
|     |                  |    |           |                             | Master (MTFE = 1, CPHA = 0) | 6   | —    |    |
|     |                  |    |           |                             | Master (MTFE = 1, CPHA = 1) | -2  | —    |    |

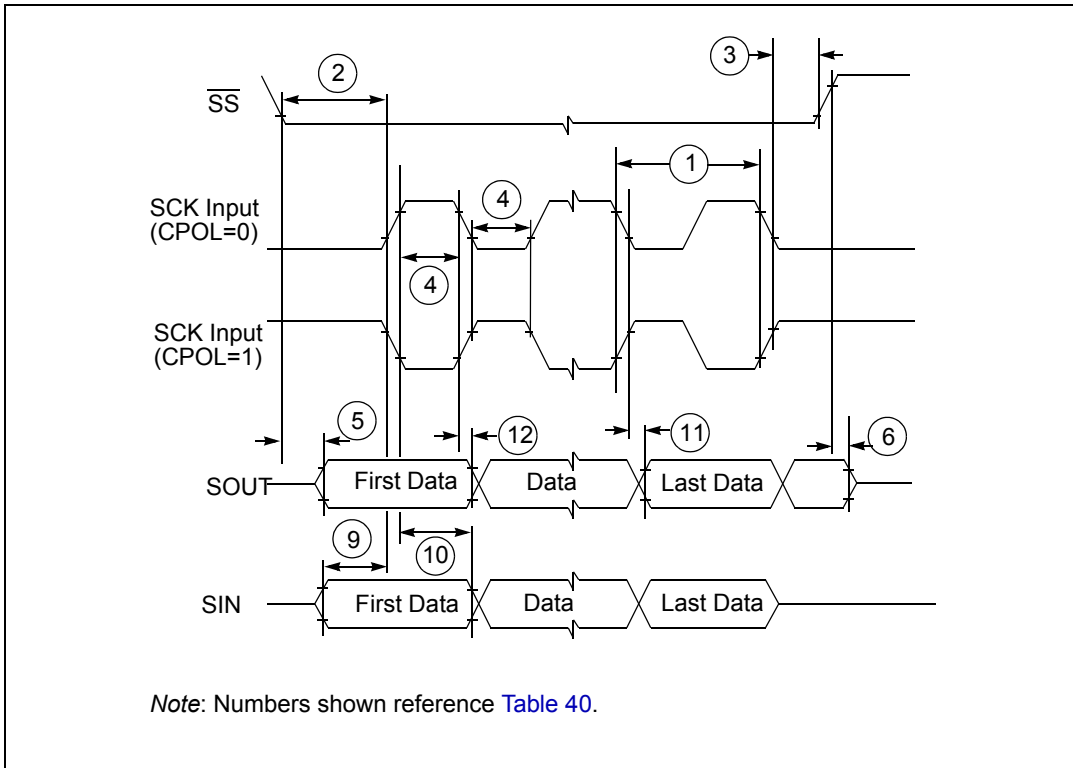
<sup>1</sup> All timing is provided with 50 pF capacitance on output, 1 ns transition time on input signal.



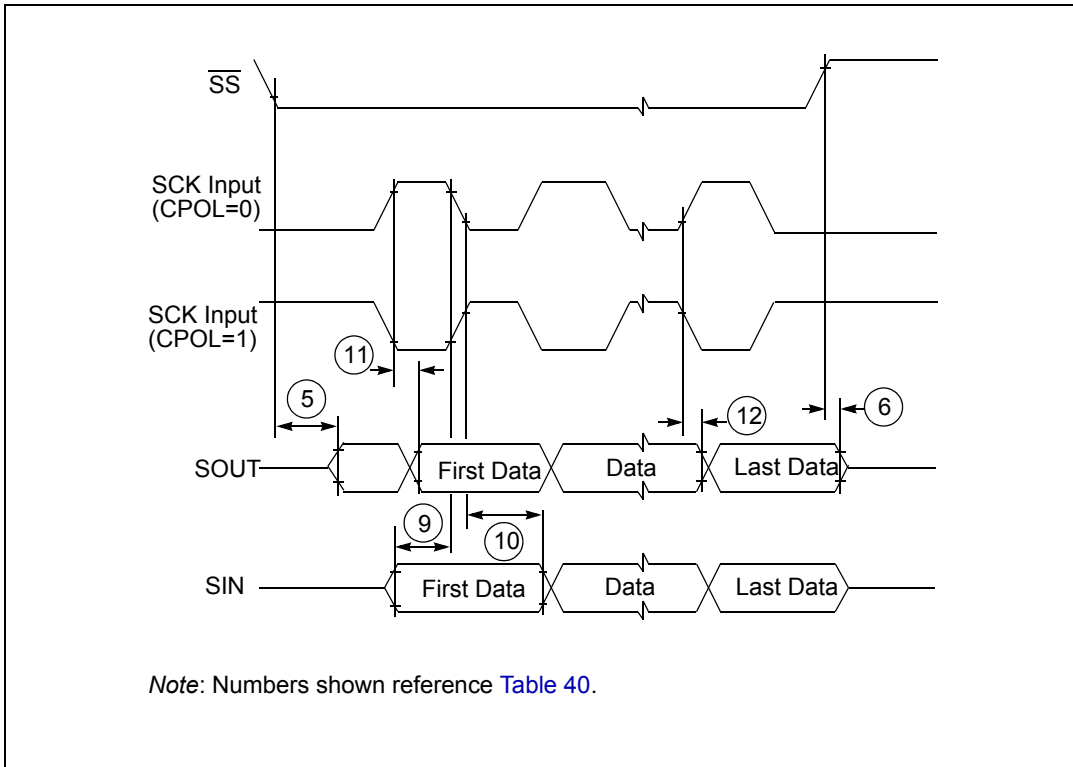
**Figure 28. DSPI classic SPI timing – Master, CPHA = 0**



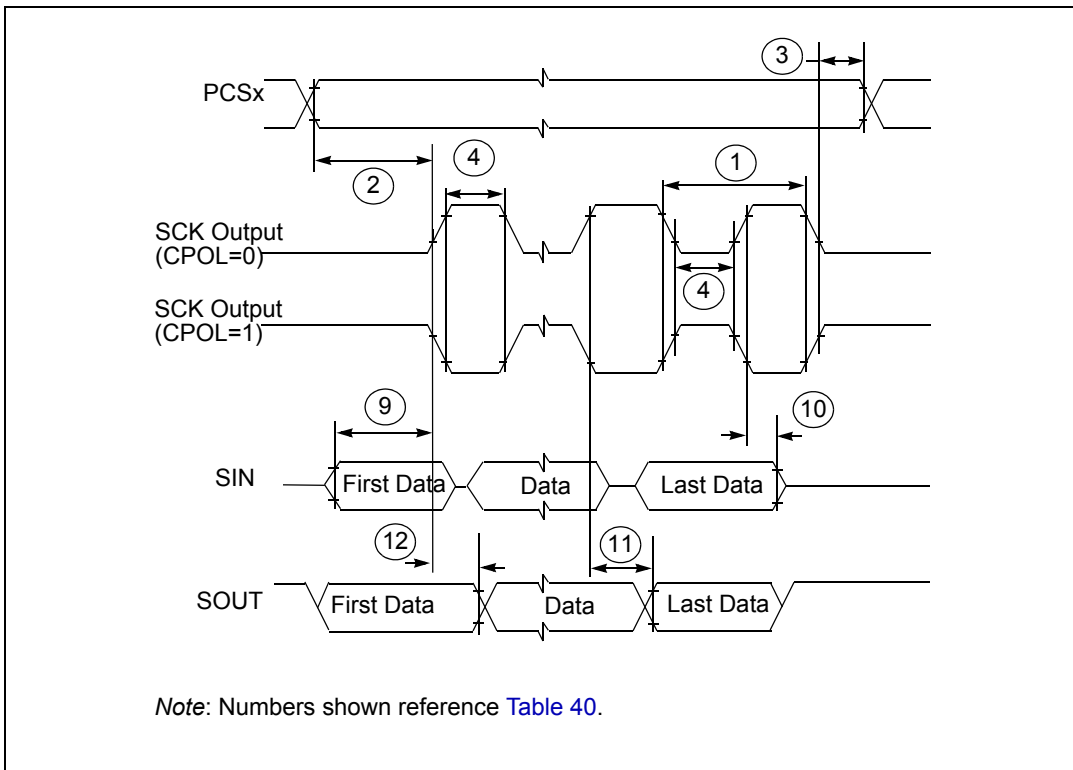
**Figure 29. DSPI classic SPI timing – Master, CPHA = 1**



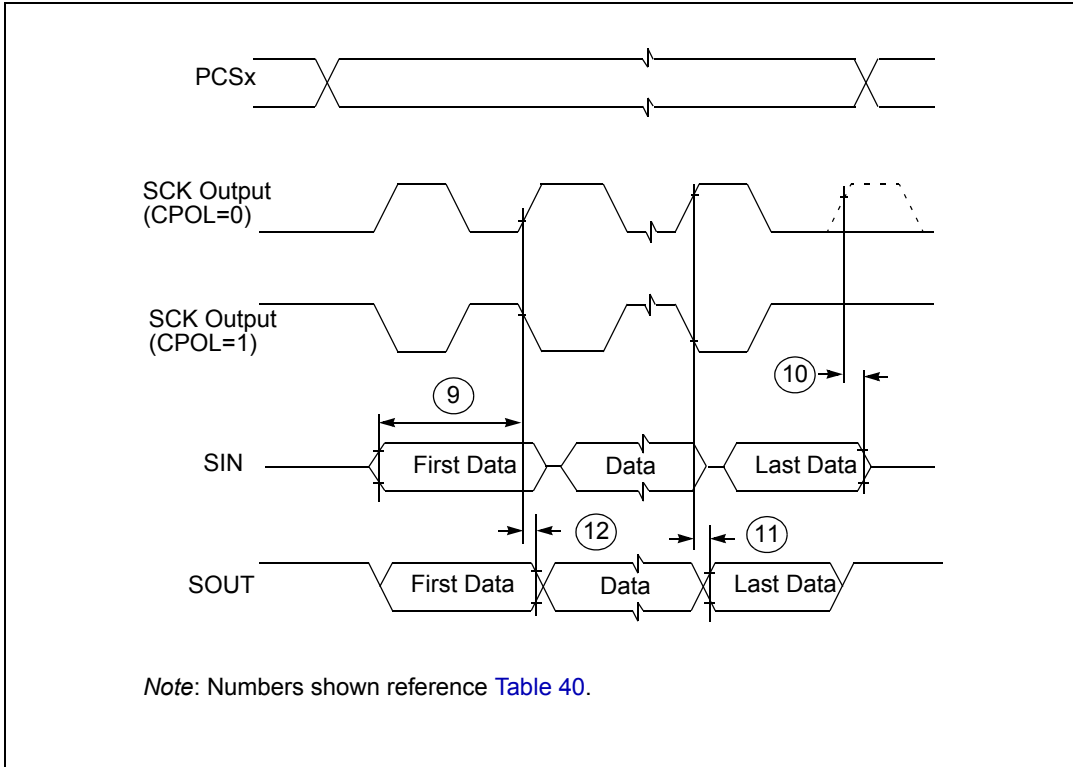
**Figure 30. DSPI classic SPI timing – Slave, CPHA = 0**



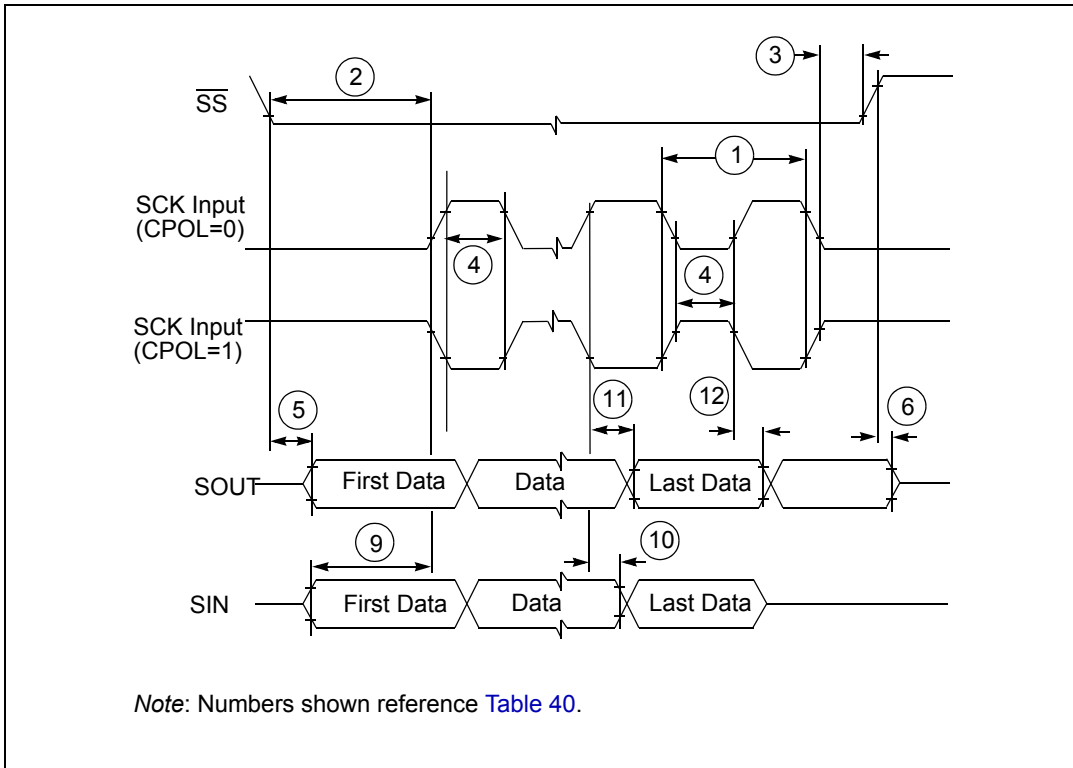
**Figure 31. DSPI classic SPI timing – Slave, CPHA = 1**



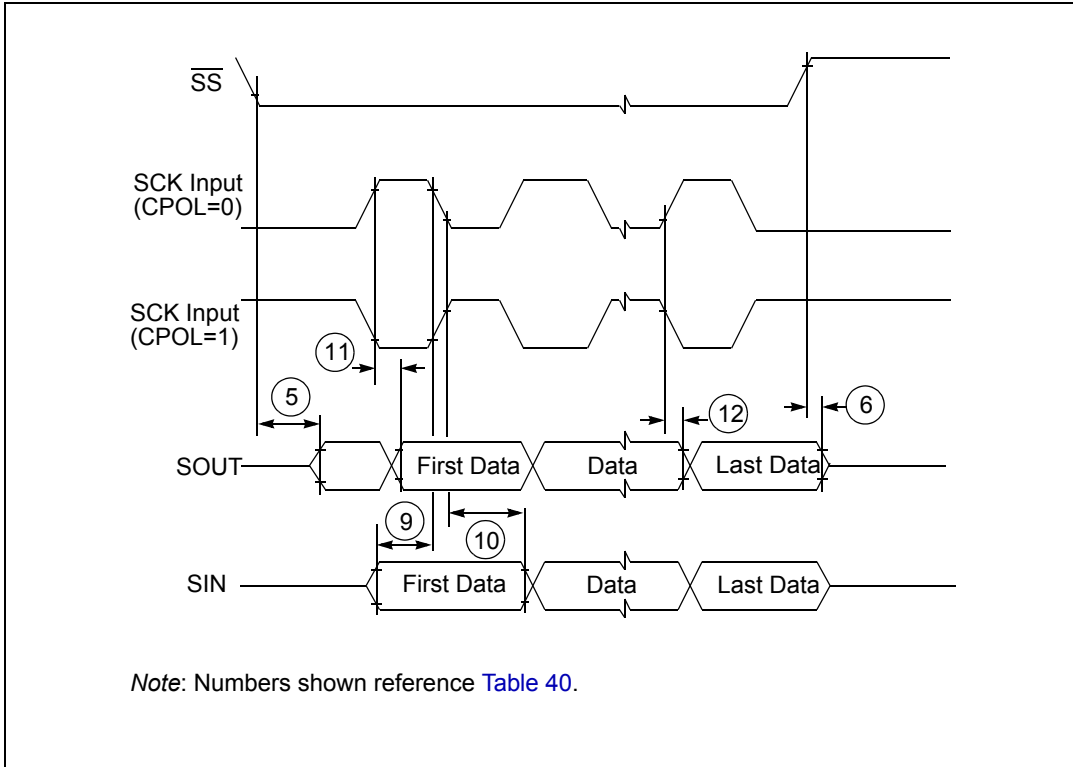
**Figure 32. DSPI modified transfer format timing – Master, CPHA = 0**



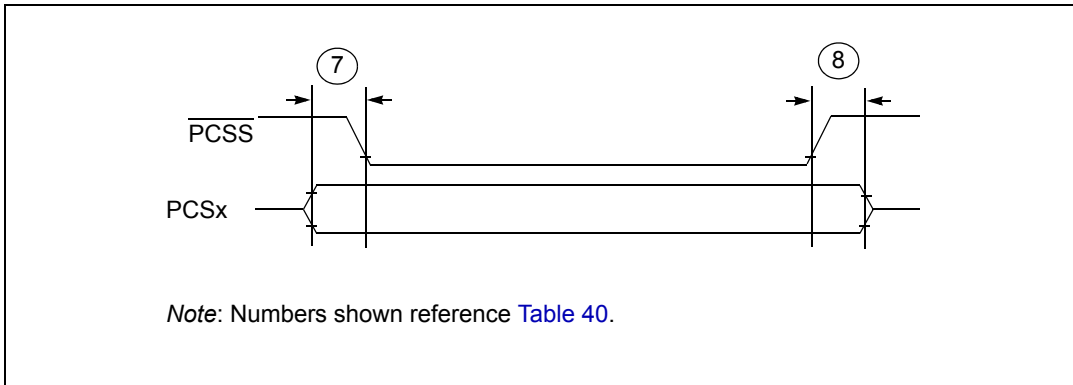
**Figure 33. DSPI modified transfer format timing – Master, CPHA = 1**



**Figure 34. DSPI modified transfer format timing – Slave, CPHA = 0**



**Figure 35. DSPI modified transfer format timing – Slave, CPHA = 1**



**Figure 36. DSPI PCS strobe (PCSS) timing**

# 4 Package characteristics

## 4.1 Package mechanical data

### 4.1.1 144 LQFP mechanical outline drawing

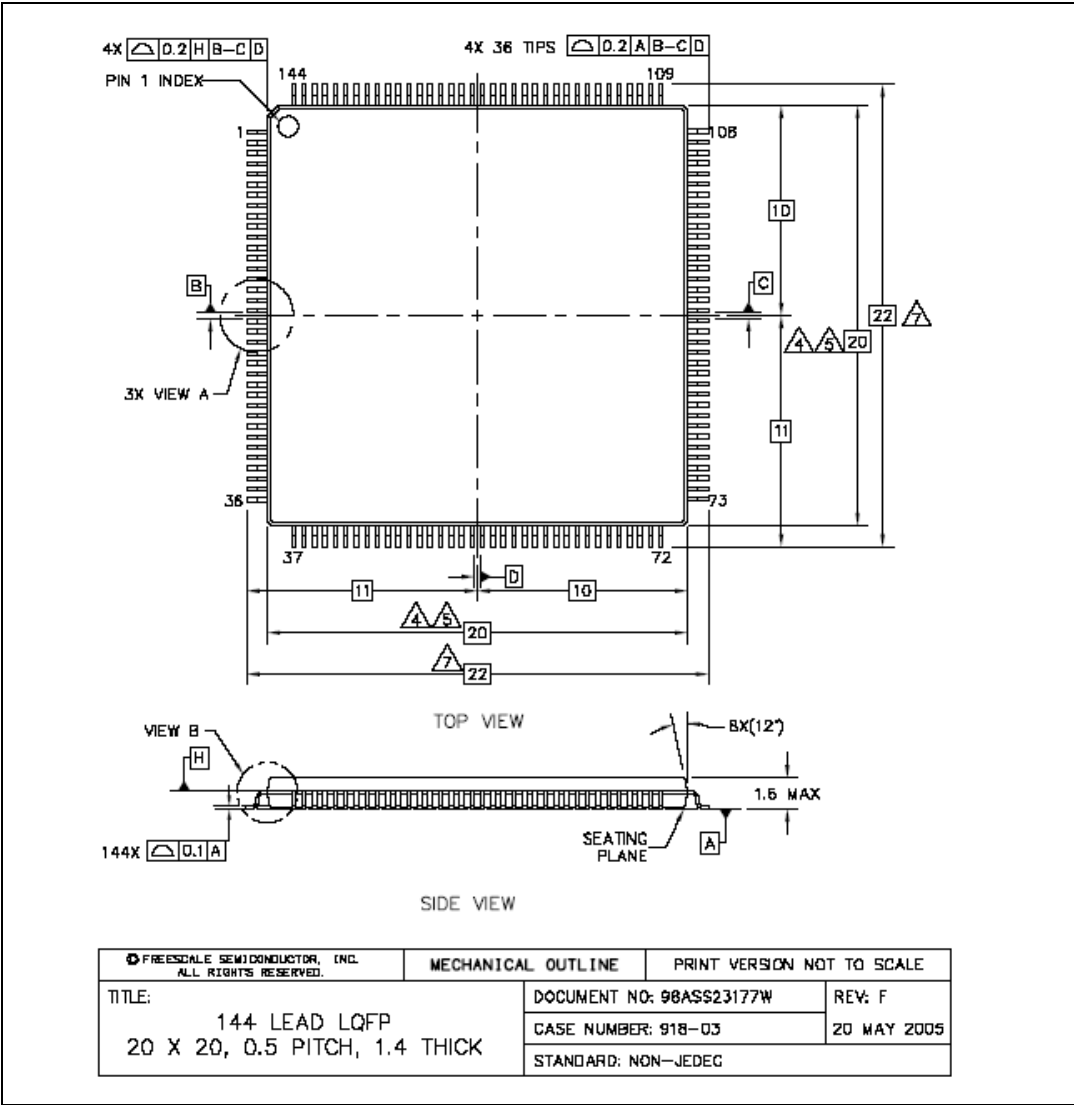


Figure 37. 144 LQFP package mechanical drawing (part 1)

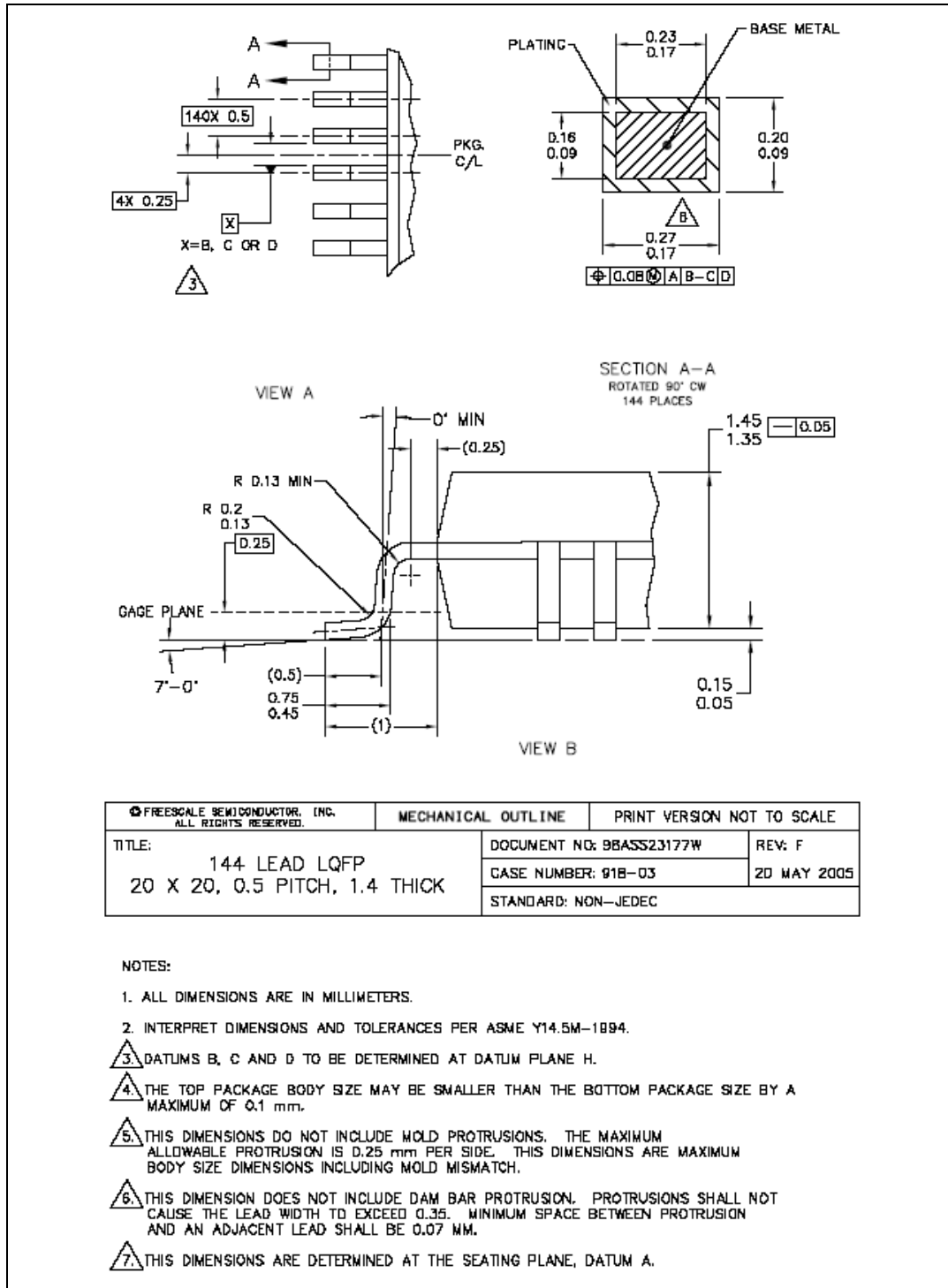


Figure 38. 144 LQFP package mechanical drawing (part 2)

## 4.1.2 100 LQFP mechanical outline drawing

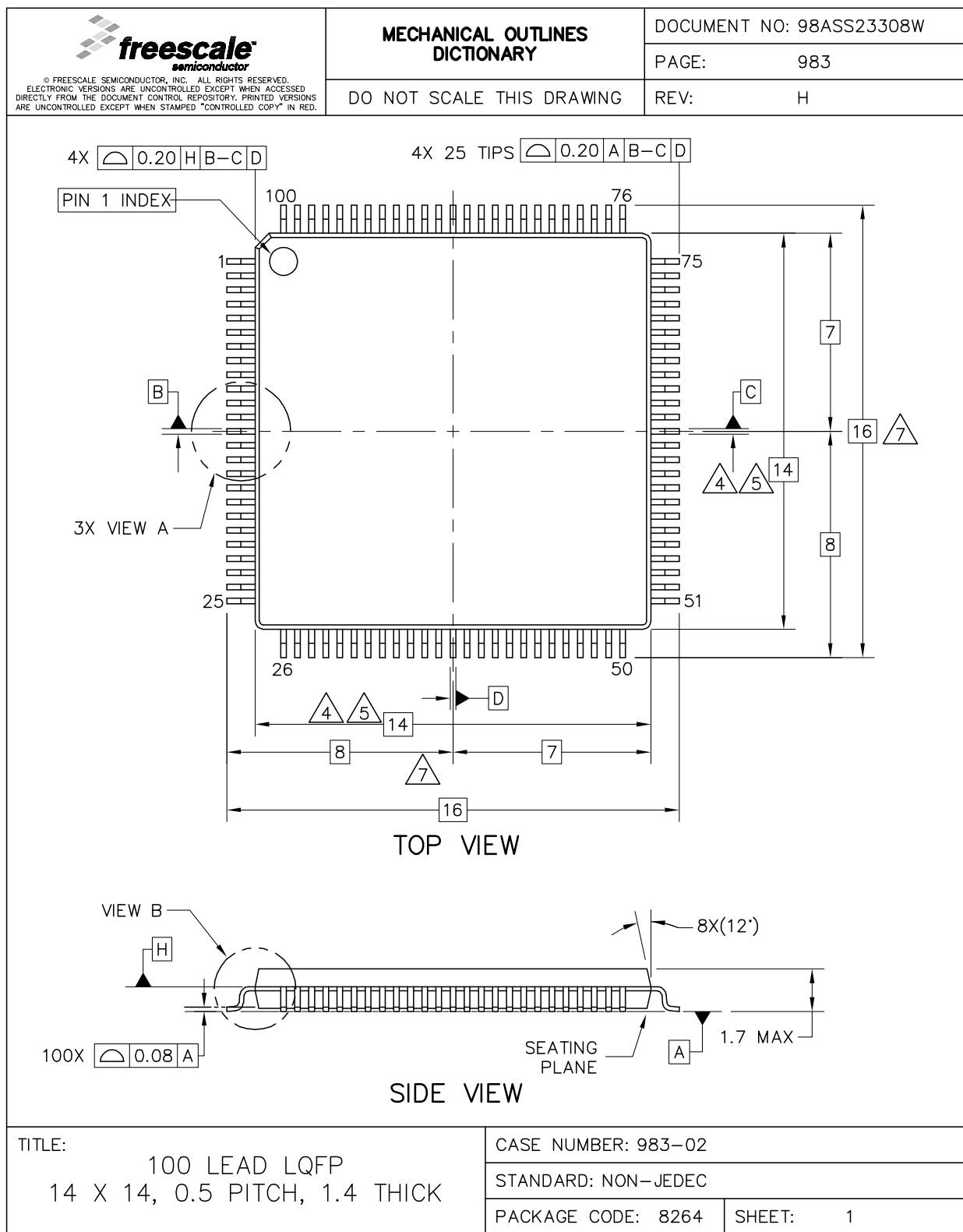
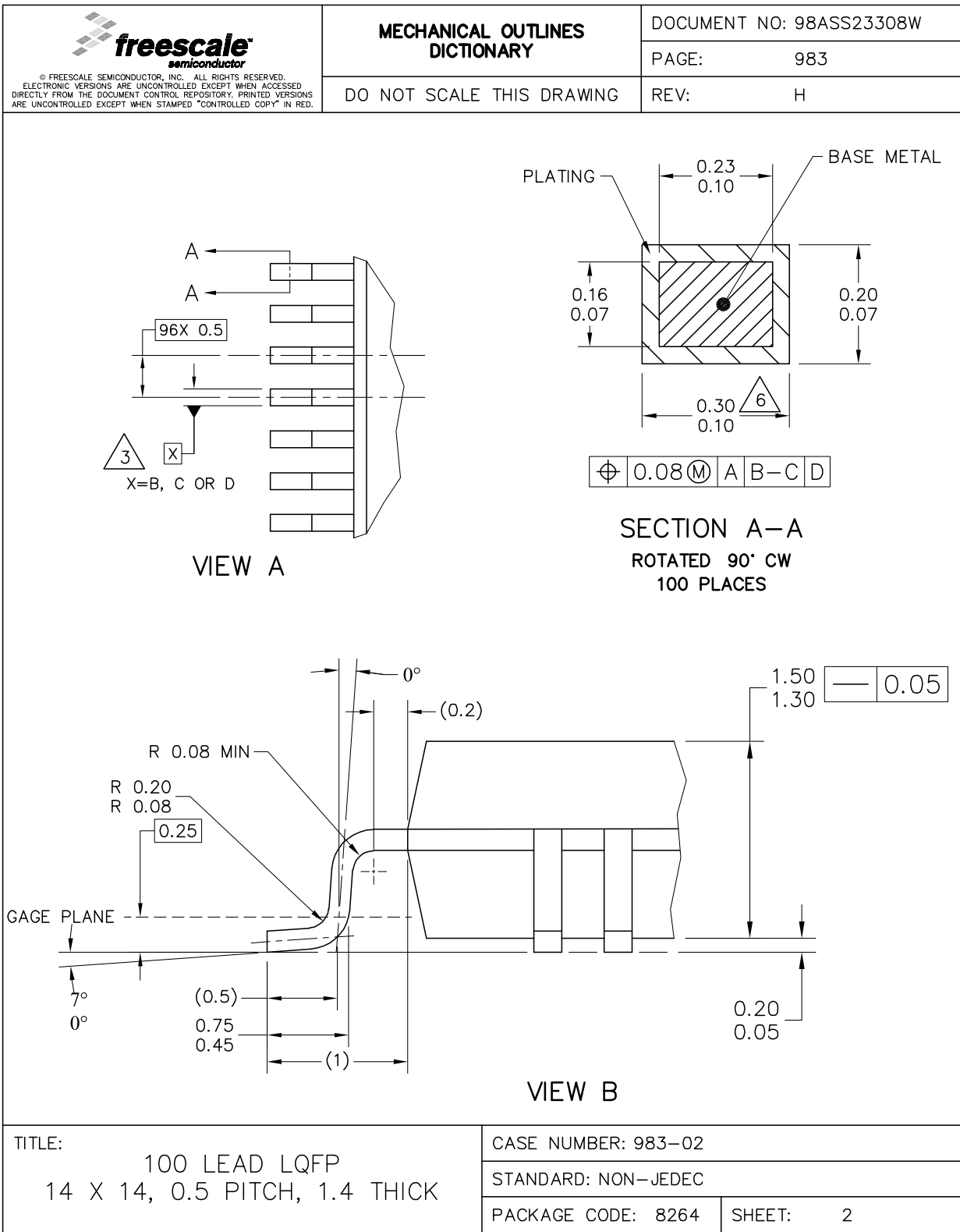


Figure 39. 100 LQFP package mechanical drawing (part 1)



**Figure 40. 100 LQFP package mechanical drawing (part 2)**

|  |   |                     |                          |     |
|--|---|---------------------|--------------------------|-----|
| <p>© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.<br/>ELECTRONIC VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED<br/>DIRECTLY FROM THE DOCUMENT CONTROL REPOSITORY. PRINTED VERSIONS<br/>ARE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED.</p>   | <b>MECHANICAL OUTLINES<br/>DICTIONARY</b> |                     | DOCUMENT NO: 98ASS23308W |     |
|  |   |                     | PAGE:                    | 983 |
|  | DO NOT SCALE THIS DRAWING                 |                     | REV:                     | H   |
| <p>NOTES:</p> <ol style="list-style-type: none"> <li>1. ALL DIMENSIONS ARE IN MILLIMETERS.</li> <li>2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.</li> <li>3. DATUMS B, C AND D TO BE DETERMINED AT DATUM PLANE H.</li> <li>4. THE TOP PACKAGE BODY SIZE MAY BE SMALLER THAN THE BOTTOM PACKAGE SIZE BY A MAXIMUM OF 0.1 MM.</li> <li>5. DIMENSIONS DO NOT INCLUDE MOLD PROTRUSIONS. THE MAXIMUM ALLOWABLE PROTRUSION IS 0.25 mm PER SIDE. THE DIMENSIONS ARE MAXIMUM BODY SIZE DIMENSIONS INCLUDING MOLD MISMATCH.</li> <li>6. DIMENSION DOES NOT INCLUDE DAM BAR PROTRUSION. PROTRUSIONS SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED 0.35. MINIMUM SPACE BETWEEN PROTRUSION AND AN ADJACENT LEAD SHALL BE 0.07 MM.</li> <li>7. DIMENSIONS ARE DETERMINED AT THE SEATING PLANE, DATUM A.</li> </ol> |   |                     |                          |     |
| TITLE:   |   | CASE NUMBER: 983-02 |                          |     |
| <p style="text-align: center;">100 LEAD LQFP<br/>14 X 14, 0.5 PITCH, 1.4 THICK</p>   |   | STANDARD: NON-JEDEC |                          |     |
|  |   | PACKAGE CODE: 8264  | SHEET:                   | 3   |

**Figure 41. 100 LQFP package mechanical drawing (part 3)**

**Table 41.**

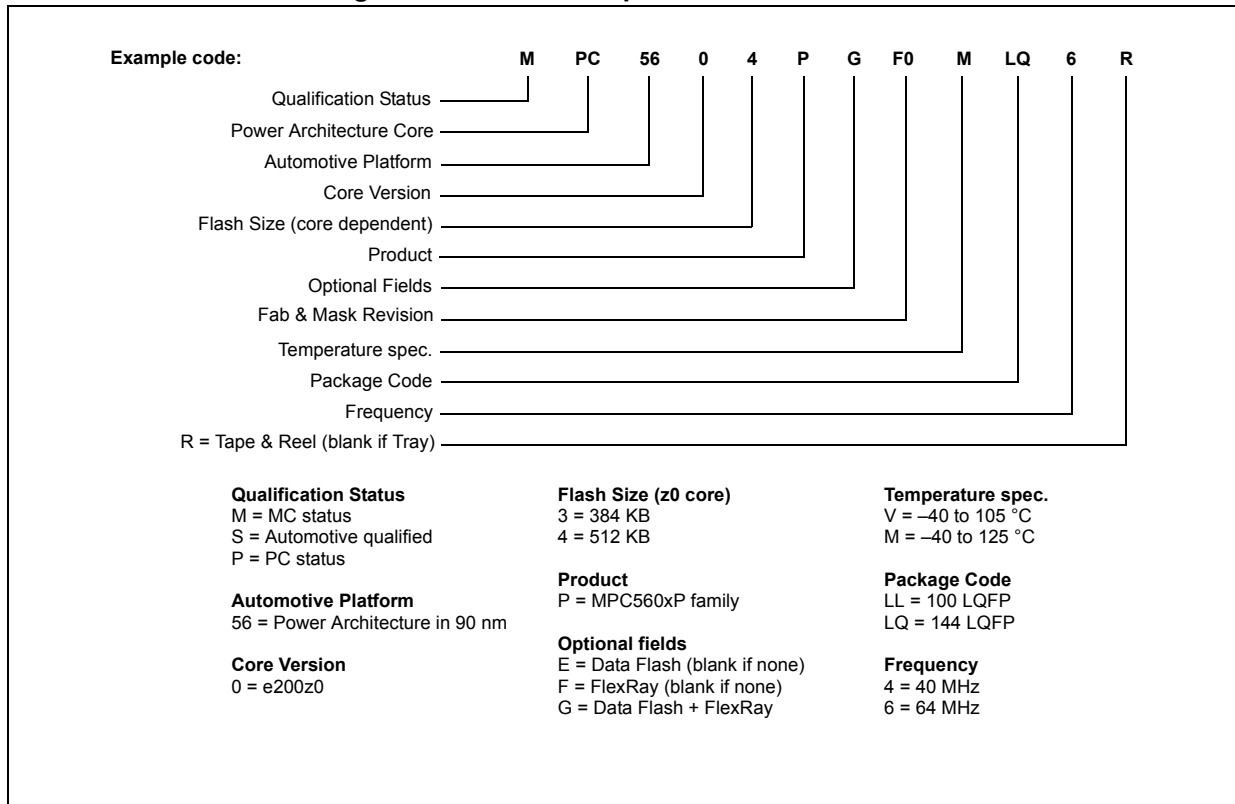
| Symbol           | Dimensions |        |        |                     |        |        |
|------------------|------------|--------|--------|---------------------|--------|--------|
|                  | mm         |        |        | inches <sup>1</sup> |        |        |
|                  | Min        | Typ    | Max    | Min                 | Typ    | Max    |
| A                | —          | —      | 1.600  | —                   | —      | 0.0630 |
| A1               | 0.050      | —      | 0.150  | 0.0020              | —      | 0.0059 |
| A2               | 1.350      | 1.400  | 1.450  | 0.0531              | 0.0551 | 0.0571 |
| b                | 0.170      | 0.220  | 0.270  | 0.0067              | 0.0087 | 0.0106 |
| c                | 0.090      | —      | 0.200  | 0.0035              | —      | 0.0079 |
| D                | 15.800     | 16.000 | 16.200 | 0.6220              | 0.6299 | 0.6378 |
| D1               | 13.800     | 14.000 | 14.200 | 0.5433              | 0.5512 | 0.5591 |
| D3               | —          | 12.000 | —      | —                   | 0.4724 | —      |
| E                | 15.800     | 16.000 | 16.200 | 0.6220              | 0.6299 | 0.6378 |
| E1               | 13.800     | 14.000 | 14.200 | 0.5433              | 0.5512 | 0.5591 |
| E3               | —          | 12.000 | —      | —                   | 0.4724 | —      |
| e                | —          | 0.500  | —      | —                   | 0.0197 | —      |
| L                | 0.450      | 0.600  | 0.750  | 0.0177              | 0.0236 | 0.0295 |
| L1               | —          | 1.000  | —      | —                   | 0.0394 | —      |
| k                | 0.0°       | 3.5°   | 7.0°   | 0.0°                | 3.5°   | 7.0°   |
| ccc <sup>2</sup> | 0.08       |        |        | 0.0031              |        |        |

<sup>1</sup> Values in inches are converted from millimeters (mm) and rounded to four decimal digits.

<sup>2</sup> Tolerance

# 5 Ordering information

Figure 42. Commercial product code structure



## Appendix A Abbreviations

Table A-1 lists abbreviations used in this document.

**Table A-1. Abbreviations**

| Abbreviation | Meaning                                 |
|--------------|---|
| CMOS         | Complementary metal–oxide–semiconductor |
| CPHA         | Clock phase                             |
| CPOL         | Clock polarity                          |
| CS           | Peripheral chip select                  |
| DUT          | Device under test                       |
| ECC          | Error code correction                   |
| EVTO         | Event out                               |
| GPIO         | General purpose input/output            |
| MC           | Modulus counter                         |
| MCKO         | Message clock out                       |
| MCU          | Microcontroller unit                    |
| MDO          | Message data out                        |
| MSEO         | Message start/end out                   |
| MTFE         | Modified timing format enable           |
| NPN          | Negative-positive-negative              |
| NVUSRO       | Non-volatile user options register      |
| PTF          | Post trimming frequency                 |
| PWM          | Pulse width modulation                  |
| RBW          | Resolution bandwidth                    |
| SCK          | Serial communications clock             |
| SOUT         | Serial data out                         |
| TCK          | Test clock input                        |
| TDI          | Test data input                         |
| TDO          | Test data output                        |
| TMS          | Test mode select                        |

## 6 Document revision history

Table 42 summarizes revisions to this document.

**Table 42. Revision history**

| Revision | Date     | Substantive changes   |
|----------|----------|---|
| Rev. 1   | Aug 2008 | Initial release   |
| Rev. 2   | Nov 2008 | <p><b>Table 5:</b><br/>TDO and TDI pins (Port pins B[4:5] are single function pins.</p> <p><b>Table 10, Table 11:</b><br/>Thermal characteristics added.</p> <p><b>Table 11, Table 12:</b><br/>EMI testing specifications split into separate tables for Normal mode and Airbag mode; data to be added in a later revision.</p> <p><b>Table 16, Table 17, Table 19, Table 20:</b><br/>Supply current specifications split into separate tables for Normal mode and Airbag mode; data to be added in a later revision.</p> <p><b>Table 21:</b></p> <ul style="list-style-type: none"> <li>• Values for <math>I_{OL}</math> and <math>I_{OH}</math> (in Conditions column) changed.</li> <li>• Max values for <math>V_{OH\_S}</math>, <math>V_{OH\_M}</math>, <math>V_{OH\_F}</math> and <math>V_{OH\_SYM}</math> deleted.</li> <li>• <math>V_{ILR}</math> max value changed.</li> <li>• <math>I_{PUR}</math> min and max values changed.</li> </ul> <p><b>Table 27:</b><br/>Sensitivity value changed.</p> <p><b>Table 30:</b><br/>Most values in table changed.</p> |
| Rev. 3   | Feb 2009 | <ul style="list-style-type: none"> <li>• Description of system requirements, controller characteristics and how controller characteristics are guaranteed updated.</li> <li>• Electrical parameters updated.</li> <li>• EMI characteristics are now in one table; values have been updated.</li> <li>• ESD characteristics are now in one table.</li> <li>• Electrical parameters are identified as either system requirements or controller characteristics. Method used to guarantee each controller characteristic is noted in table.</li> <li>• AC Timings: 1149.1 (JTAG) Timing, Nexus Timing, External Interrupt Timing, and DSPI Timing sections deleted</li> </ul>  |

**Table 42. Revision history (continued)**

| Revision | Date        | Substantive changes   |
|----------|-------------|---|
| Rev. 4   | 24-Jun-2009 | <p>Through all document:</p> <ul style="list-style-type: none"> <li>– Replaced all “RESET_B” occurrences with “RESET” through all document.</li> <li>– AC Timings: 1149.1 (JTAG) Timing, Nexus Timing, External Interrupt Timing, and DSPI Timing sections inserted again.</li> <li>– Electrical parameters updated.</li> <li>–</li> </ul> <p><a href="#">Table 2</a></p> <ul style="list-style-type: none"> <li>– Added row for Data Flash.</li> </ul> <p><a href="#">Table 3</a></p> <ul style="list-style-type: none"> <li>– Added a footnote regarding the decoupling capacitors.</li> </ul> <p><a href="#">Table 5</a></p> <ul style="list-style-type: none"> <li>– Removed the “other function” column.</li> <li>– Rearranged the contents.</li> </ul> <p><a href="#">Table 15</a></p> <ul style="list-style-type: none"> <li>– Updated definition of Condition column.</li> </ul> <p><a href="#">Table 20</a></p> <ul style="list-style-type: none"> <li>– merged in an unique Table the power consumption data related to "Maximum mode" and "Airbag mode".</li> </ul> <p><a href="#">Table 22</a></p> <ul style="list-style-type: none"> <li>– merged in an unique Table the power consumption data related to "Maximum mode" and "Airbag mode".</li> </ul> <p><a href="#">Table 30</a></p> <ul style="list-style-type: none"> <li>– Updated the parameter definition of <math>\Delta RCMVAR</math>.</li> <li>– Removed the condition definition of <math>\Delta RCMVAR</math>.</li> </ul> <p><a href="#">Table 30</a></p> <ul style="list-style-type: none"> <li>– Added <math>t_{ADC\_C}</math> and TUE rows.</li> </ul> <p><a href="#">Table 31</a></p> <ul style="list-style-type: none"> <li>– Added <math>t_{ADC\_C}</math> and TUE rows.</li> <li>– Removed <math>R_{sw2}</math>.</li> </ul> <p><a href="#">Table 34</a></p> <ul style="list-style-type: none"> <li>– Added.</li> </ul> <p><a href="#">Table 29</a></p> <ul style="list-style-type: none"> <li>– Updated and added footnotes.</li> </ul> <p><a href="#">Section 3.17.1, “RESET pin characteristics</a></p> <ul style="list-style-type: none"> <li>– Replaces whole section.</li> </ul> <p><a href="#">Table 38</a></p> <ul style="list-style-type: none"> <li>– Renamed the “Flash (KB)” heading column in “Code Flash / Data Flash (EE) (KB)”</li> <li>– Replaced the value of RAM from 32 to 36KB in the last four rows.</li> </ul> |

**Table 42. Revision history (continued)**

| Revision | Date        | Substantive changes   |
|----------|-------------|---|
| Rev. 5   | 06-Oct-2009 | <ul style="list-style-type: none"> <li>- Removed B[4] and B[5] rows from “Pin muxing” table and inserted them on “System pins” table.</li> <li>- Updated package pinout.</li> <li>- Rewrote entirely section “Power Up/down Sequencing” section.</li> <li>- Renamend “V<sub>DD_LV_PLL</sub>” and “V<sub>SS_LV_PLL</sub>” supply pins with respectively “V<sub>DD_LV_COR3</sub>” and “V<sub>SS_LV_COR3</sub>”.</li> <li>- Added explicative figures on “Electrical characteristics” section.</li> <li>- Updated “Thermal characteristics” for 100-pin.</li> <li>- Proposed two different configuration of “voltage regulator. - Inserted Power Up/Down sequence.</li> <li>- Added explicative figures on “DC Electrical characteristics”.</li> <li>- Added “I/O pad current specification” section.</li> <li>- Renamed the “Airbag mode” with “Typical mode” and updated the values on “supply current” tables.</li> </ul>   |
| Rev. 6   | 12-Feb-2010 | <p>Inserted label of Y-axis in the “Independent ADC supply” figure.</p> <p>“Recommended Operating Conditions” tables:</p> <ul style="list-style-type: none"> <li>Updated the T<sub>A</sub> value</li> <li>Moved the T<sub>J</sub> row to “Absolute Maximum Ratings” table.</li> <li>Rewrite note 1 and 3</li> </ul> <p>Inverted Min a Typ value of C<sub>DEC2</sub> on “Voltage Regulator Electrical Characteristics” table.</p> <p>Removed an useless duplicate of “Voltage Regulator Electrical Characteristics” table.</p> <p>Inserted the name of C<sub>S</sub> into “Input Equivalent Circuit” figure.</p> <p>Removed leakage I<sub>vpp</sub> from datasheet.</p> <p>Updated “Supply Current” tables.</p> <p>Added note on “Output pin transition times” table.</p> <p>Updated “Temperature Sensor Electrical Characteristics” table.</p> <p>Updated “16 MHz RC Oscillator Electrical Characteristics” table.</p> <p>Removed the note about the condition from “Flash read access timing” table.</p> <p>Removed the notes that assert the values need to be confirmed before validation.</p> |

**Table 42. Revision history (continued)**

| Revision | Date        | Substantive changes  |
|----------|-------------|--|
| Rev. 7   | 07-Apr-2011 | <p>Formatting and editorial changes throughout</p> <p>Removed all content referencing Junction Temperature Sensor</p> <p><a href="#">Section 1, "Introduction"</a>: changed title (was: Overview); reorganized contents</p> <p>MPC5604P device comparison:</p> <ul style="list-style-type: none"> <li>• ADC feature: changed "16 channels" to "15-channel"; added footnote to indicate that four channels are shared between the two ADCs</li> <li>• removed MPC5602P column</li> <li>• indicated that data flash memory is an optional feature</li> <li>• indicated that FlexRay is an optional feature</li> <li>• changed "dual channel" to "selectable single or dual channel support" in FlexRay footnote</li> <li>• updated "eTimer" feature</li> <li>• updated footnote relative to "Digital power supply" feature</li> </ul> <p>Updated MPC5604P block diagram</p> <p>Added MPC5604P series block summary</p> <p>Added <a href="#">Section 1.5, "Feature details"</a></p> <p><a href="#">Section 2.1, "Package pinouts"</a>: removed alternate functions from pinout diagrams</p> <p>Supply pins: updated descriptions of power supply pins (1.2 V)</p> <p>System pins: updated table</p> <p>Pin muxing: added rows "B[4]" and "B[5]"</p> <p><a href="#">Section 3.3, "Absolute maximum ratings"</a>: added voltage specifications to titles of <a href="#">Figure 4</a> and <a href="#">Figure 5</a>; in <a href="#">Table 7</a>, changed row "V<sub>SS_HV</sub> / Digital Ground" to "V<sub>SS</sub> / Device Ground"; updated symbols</p> <p><a href="#">Section 3.4, "Recommended operating conditions"</a>: added voltage specifications to titles of <a href="#">Figure 6</a> and <a href="#">Figure 7</a></p> <p>Recommended operating conditions (5.0 V), and Recommended operating conditions (3.3 V): changed row "V<sub>SS_HV</sub> / Digital Ground" to "V<sub>SS</sub> / Device Ground"; updated symbols</p> <p>Updated <a href="#">Section 3.5.1, "Package thermal characteristics"</a></p> <p>Updated <a href="#">Section 3.6, "Electromagnetic interference (EMI) characteristics"</a></p> <p><a href="#">Section 3.8.1, "Voltage regulator electrical characteristics"</a>: amended titles of <a href="#">Table 15</a> and <a href="#">Table 17</a></p> <p>Voltage regulator electrical characteristics (configuration without resistor on base) and Voltage regulator electrical characteristics (configuration with resistor on base): updated symbol and values for V<sub>DD_LV_REGCOR</sub></p> <p>Low voltage monitor electrical characteristics: Updated V<sub>MLVDDOK_H</sub> max value—was 1.15 V; is 1.145 V</p> <p><a href="#">Section 3.10, "DC electrical characteristics"</a>: reorganized contents</p> <p>Updated <a href="#">Section 3.10.1, "NVUSRO register"</a> (includes adding "NVUSRO[OSCILLATOR_MARGIN] field description" table</p> <p>Supply current (5.0 V, NVUSRO[PAD3V5V] = 0): updated symbols</p> |

**Table 42. Revision history (continued)**

| Revision           | Date        | Substantive changes   |
|--------------------|-------------|---|
| Rev. 7<br>(cont'd) | 07-Apr-2011 | <p>Corrected parameter descriptions in DC electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1):</p> <ul style="list-style-type: none"> <li>• <math>V_{OL\_F}</math>—was “Fast, high level output voltage”; is “Fast, low level output voltage”</li> <li>• <math>V_{OL\_SYM}</math>—was “Symmetric, high level output voltage”; is “Symmetric, low level output voltage”</li> </ul> <p>Supply current (3.3 V, NVUSRO[PAD3V5V] = 1): updated symbols</p> <p>Main oscillator output electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0): replaced instances of EXTAL with XTAL</p> <p>Main oscillator output electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1): replaced instances of EXTAL with XTAL</p> <p>FMPLL electrical characteristics: replaced “PLLMRFM” with “FMPLL” in table title; updated conditions; removed <math>f_{sys}</math> row; updated <math>f_{FMPLLOUT}</math> min value</p> <p>ADC conversion characteristics: updated symbols; added row <math>t_{ADC\_PU}</math></p> <p>Flash memory read access timing: added footnote to “Conditions” column</p> <p><a href="#">Section 3.16.1, “Pad AC specifications</a>: added Pad output delay diagram</p> <p>In the range of figures “DSPI Classic SPI Timing — Master, CPHA = 0” to “DSPI PCS Strobe (PCSS) Timing”: added note</p> <p>Removed Orderable Part Number Summary table</p> <p>Updated “Commercial product code structure” figure</p> <p><a href="#">Table A-1</a>: Added abbreviations “DUT”, “NPN”, and “RBW”</p> |

**Table 42. Revision history (continued)**

| Revision | Date        | Substantive changes   |
|----------|-------------|---|
| Rev. 8   | 23-May-2012 | <p>Section 1.5.4, “Flash memory: Changed “Data flash memory: 32-bit ECC” to “Data flash memory: 64-bit ECC”</p> <p>Figure 42 (Commercial product code structure), replaced "C = 60 MHz, 5 V" and "D = 60 MHz, 3.3 V" with respectively "C = 40 MHz, 5 V" and "D = 40 MHz, 3.3 V"</p> <p>Table 7 (Absolute maximum ratings), updated <math>TV_{DD}</math> parameter, the minimum value to 3.0 V/s and the maximum value to 0.5 V/<math>\mu</math>s</p> <p>Table 5 (Pin muxing), changed the description in the column "I/O direction" from "I/O" to "O" for the following port pins:</p> <ul style="list-style-type: none"> <li>A[10] with function B[0]</li> <li>A[11] with function A[0]</li> <li>A[11] with function A[2]</li> <li>A[12] with function A[2]</li> <li>A[12] with function B[2]</li> <li>A[13] with function B[2]</li> <li>C[7] with function A[1]</li> <li>C[10] with function A[3]</li> <li>C[15] with function A[1]</li> <li>D[0] with function B[1]</li> <li>D[10] with function A[0]</li> <li>D[11] with function B[0]</li> <li>D[13] with function A[1]</li> <li>D[14] with function B[1]</li> </ul> <p>Updated Section 3.8.1, “Voltage regulator electrical characteristics</p> <p>Added Table 25 (I/O consumption)</p> <p>Section 3.10, DC electrical characteristics:</p> <ul style="list-style-type: none"> <li>deleted references to “oscillator margin”</li> <li>deleted subsection “NVUSRO[OSCILLATOR_MARGIN] field description”</li> </ul> <p>Table 19 (DC electrical characteristics (5.0 V, NVUSRO[PAD3V5V] = 0)), added IPU row for RESET pin</p> <p>Table 21 (DC electrical characteristics (3.3 V, NVUSRO[PAD3V5V] = 1)), added IPU row for RESET pin</p> <p>Table 31 (ADC conversion characteristics), added <math>V_{INAN}</math> entry</p> <p>Removed “Order codes” table</p> |

**How to Reach Us:**

**Home Page:**

freescale.com

**Web Support:**

freescale.com/support

Information in this document is provided solely to enable system and software implementers to use Freescale products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits based on the information in this document.

Freescale reserves the right to make changes without further notice to any products herein. Freescale makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale data sheets and/or specifications can and do vary in different applications, and actual performance may vary over time. All operating parameters, including "typicals," must be validated for each customer application by customer's technical experts. Freescale does not convey any license under its patent rights nor the rights of others. Freescale sells products pursuant to standard terms and conditions of sale, which can be found at the following address: <http://www.reg.net/v2/webservices/Freescale/Docs/TermsandConditions.htm>

Freescale, the Freescale logo, Altivec, C-5, CodeTest, CodeWarrior, ColdFire, C-Ware, Energy Efficient Solutions logo, Kinetis, mobileGT, PowerQUICC, Processor Expert, QorIQ, Qorivva, StarCore, Symphony, and VortiQa are trademarks of Freescale Semiconductor, Inc., Reg. U.S. Pat. & Tm. Off. Airfast, BeeKit, BeeStack, ColdFire+, CoreNet, Flexis, MagniV, MXC, Platform in a Package, QorIQ Qonverge, QUICC Engine, Ready Play, SafeAssure, SMARTMOS, TurboLink, Vybrid, and Xtrinsic are trademarks of Freescale Semiconductor, Inc. All other product or service names are the property of their respective owners. The Power Architecture and Power.org word marks and the Power and Power.org logos and related marks are trademarks and service marks licensed by Power.org.

© 2008–2012 Freescale, Inc.

Document Number: MPC5604P

Rev. 8

07/2012







## Looking for pricing, stock, or lifecycle information?

Click below to explore more details on WIN SOURCE:

 [View SPC5604PGF1MLQ6 on WIN SOURCE](#)

 [NXP / Nexperia Information](#)

## Optimize Your Supply Chain with WIN SOURCE Solutions

-  Global Sourcing Solution
-  Obsolete Management
-  Cost Control Management
-  Shortage Management
-  Alternative Solution
-  Excess Inventory Management